RT600

Dual-core microcontroller with 32-bit Cortex®-M33 and Xtensa HiFi4 Audio DSP CPUs; Up to 4.5 MB SRAM; FlexSPI with cache and dynamic decryption; High-speed USB device/host + Phy; 12-bit 1 Msamples/s ADC; Analog Comparator; Audio subsystems supporting up to 8 DMIC channels; SDIO/eMMC; AES/SHA/Crypto M33 coprocessor; PUF key generation

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1. General description

The RT600 is a family of dual-core microcontrollers for embedded applications featuring an Arm Cortex-M33 CPU combined with a Cadence Xtensa HiFi4 advanced Audio Digital Signal Processor CPU. The Cortex-M33 includes two hardware coprocessors providing enhanced performance for an array of complex algorithms. The family offers a rich set of peripherals and very low power consumption.

The Arm Cortex-M33 is a next generation core based on the ARMv8-M architecture that offers system enhancements, such as ARM TrustZone® security, single-cycle digital signal processing, and a tightly-coupled coprocessor interface, combined with low power consumption, enhanced debug features, and a high level of support block integration. The ARM Cortex-M33 CPU employs a 3-stage instruction pipe and includes an internal prefetch unit that supports speculative branching. A hardware floating-point processor is integrated into the core. On the RT600, the Cortex-M33 is augmented with two hardware coprocessors providing accelerated support for additional DSP algorithms and cryptography.

The Cadence Xtensa HiFi 4 Audio DSP engine is a highly optimized audio processor designed especially for efficient execution of audio and voice codecs and pre- and post-processing modules. It supports four 32x32-bit MACs, some support for 72-bit accumulators, limited ability to support eight 32x16-bit MACs, and the ability to issue two 64-bit loads per cycle. There is a floating point unit providing up to four single-precision IEEE floating point MACs per cycle.

The RT600 provides up to 4.5 MB of on-chip SRAM (plus an additional 128 KB of tightly-coupled HiFi4 ram) and several high-bandwidth interfaces to access off-chip flash. The FlexSPI flash interface supports two channels and includes an 32 KB cache and an on-the-fly decryption engine. The RT600 is designed to allow the Cortex-M33 to operate at frequencies of up to 300 MHz and the HiFi4 DSP to operate at frequencies of up to 600 MHz.

1.1 Peripherals

The peripheral complement includes an FlexSPI flash interface with two channels, two SDIO/eMMC interfaces, a high-speed USB device/host with on-chip PHY, a 12-bit, 1 MSamples/sec ADC with temperature sensor, an analog comparator, AES256 and Hash engines with Physical Unclonable Function (PUF) key generation, a digital microphone

interface supporting up to eight channels and Voice Activation Detect, one I3C interface, one high-speed SPI interface and seven configurable serial interfaces that can be configured as a USART, SPI, I2C or I2S bus interface, each including a FIFO. When configured as USARTs the serial interfaces have the option to operate in deep-sleep mode using the 32 kHz oscillator or an external clock. There is a dedicated fractional baud rate generator for each of the serial interfaces.

Timing peripherals include one advanced, 32-bit SCTimer/PWM module, five general purpose 32-bit timer/counters with PWM capability, a 24-bit, multiple-channel multi-rate timer, two windowed watchdog timers, a system tick timer with capture capability, and a Real-time clock module with independent power and a dedicated oscillator. A common OS Event Timer is provided for synchronized event generation and timestamping between the two CPUs.

There are two general purpose DMA engines which can service most of the peripherals described in this section. The two DMA engines may be assigned to different CPUs and/or one may be used for secure operations, the other for non-secure.

Mailboxes and hardware semaphores are provided to facilitate inter-core communication. A variety of oscillators and PLLs are available as clock sources throughout the system.

1.2 Shared system SRAM

The entire system SRAM space of up to 4.5 MB is divided into up to 30 separate partitions, which are accessible to both CPUs, both DMA engines, and all other AHB bus masters. The HiFi4 CPU accesses the RAM via a dedicated 256-bit interface. Cache (with single-cycle access) is provided on this interface to improve performance. All other masters, including the Cortex-M33 processor and the DMA engines, access RAM via the main 32-bit AHB bus. These accesses are all single-cycle. Hardware interface modules arbitrate access to each RAM partition between the HiFi4 and the AHB bus.

Under software control, each of the 30 individual SRAM partitions can be used exclusively as code or as data, dedicated either CPU, or shared among the various masters. Each partition can be independently placed in a low-power retention mode or powered off entirely.

In addition to the shared SRAM, a total of 128 KB (64 KB code, 64 KB data) of local, Tightly-Coupled Memory (TCM) is provided for the exclusive use of the HiFi4 DSP processor. Access to this memory is single-cycle.

2. Features and benefits

- Control processor core
  - ◆ Arm Cortex-M33 processor, running at frequencies of up to 300 MHz.
  - ◆ Arm TrustZone.
  - ◆ Arm Cortex-M33 built-in Memory Protection Unit (MPU) supporting eight regions
  - ◆ Hardware Floating Point Unit (FPU).
  - ◆ Arm Cortex-M33 built-in Nested Vectored Interrupt Controller (NVIC).
  - ◆ Non-maskable Interrupt (NMI) input.

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◆ Two coprocessors for the Cortex-M33: a hardware accelerator for fixed and floating point DSP functions (PowerQuad) and a Crypto/FFT engine (Casper). The DSP coprocessor uses a bank of four dedicated 2 KB SRAMs. The Crypto/FFT engine uses a bank of two 2 KB SRAMs that are also AHB accessible by the CPU and the DMA engine.

◆ Serial Wire Debug with eight break points, four watch points, and a debug timestamp counter. It includes Serial Wire Output (SWO) trace and ETM trace.

◆ Cortex-M33 System tick timer.

■ DSP processor core:

◆ Cadence Xtensa HiFi4 Audio DSP processor, running at frequencies of up to 600 MHz.

◆ Hardware Floating Point Unit. Up to four single-precision IEEE floating point MACs per cycle.

◆ Serial Wire Debug (shared with Cortex-M33 Control Domain CPU).

◆ System tick timer.

■ Triple I/O power:

◆ Three independent supplies powering different clusters of pins to permit interfacing directly to off-chip peripherals operating at different supply levels.

■ On-chip Memory:

◆ Up to 4.5 MB of system SRAM accessible by both CPUs and all (dedicated and general purpose) DMA engines.

◆ 128 KB of local, Tightly-Coupled Memory dedicated to the DSP CPU.

◆ 96 KB (or more) of I & D cache for DSP accesses to shared system SRAM.

◆ Additional SRAMs for USB traffic (8 KB), Cortex-M33 coprocessors (4 x 2 KB), SDIO FIFOs (2 x 512 B dual-port), PUF secure key generation (2 KB), and FlexSPI cache (32 KB).

◆ 16 K bits of OTP fuses for factory and user configuration.

◆ Up to 256 KB ROM memory for factory-programmed drivers and APIs.

◆ System boot from SPI, I2C, UART, Octal/Quad SPI Flash, HS USB or eMMC via on-chip bootloader software included in ROM.

■ Digital peripherals:

◆ Two general purpose DMA engines, each with 32 channels and up to 25 programmable request/trigger sources.
- Can be configured such that one DMA is secure and the other non-secure and/or one can be designated for use by the M33 CPU and the other by the DSP.

◆ USB high-speed host/device controller with on-chip PHY and dedicated DMA controller.

◆ FlexSPI flash interface with 32 KB cache and dynamic decryption for execute-in-place and supports DMA. The FlexSPI includes 2 ports: high speed channel A and lower speed channel B. Both ports support quad or octal operation.

◆ An SD/eMMC memory card interface with dedicated DMA controller. Supports eMMC 5.0 with HS400/DDR operation (HS-400 is supported only on SD port 0).

◆ Eight configurable universal serial interface modules (Flexcomm Interfaces). Each module contains an integrated FIFO and DMA support. Flexcomms 0 through 7can be configured as:
- A USART with dedicated fractional baud rate generation and flow-control handshaking signals. The USART can optionally be clocked at 32 kHz and

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operated when the chip is in reduced power mode, using either the 32 kHz clock or an externally supplied clock.The USART also provides partial support for LIN2.2.
- An I^2C-bus interface with multiple address recognition, and a monitor mode. It supports 400 Kb/sec Fast-mode and 1 Mb/sec Fast-mode Plus. It also supports 3.4 Mb/sec high-speed when operating in slave mode.
- An SPI interface.
- An I^2S (Inter-IC Sound) interface for digital audio input or output. Each I^2S supports up to four channel-pairs.

◆ One high-speed SPI interface (Flexcomm Interface 14 only) supporting 50 MHz operation.

◆ One additional I2C interface available on some device configurations (see specific device data sheet for more information). This interface is intended primarily for communication with an external power management device (PMIC), but can be used for other purposes when the application does not use an external PMIC.

◆ One I3C bus interface.

◆ A digital microphone interface supporting up to 8 channels with associated decimators and Voice Activation Detect. One pair of channels can be streamed directly to I^2S. The DMIC supports DMA.

◆ One 32-bit SCTimer/PWM module (SCT). Multi-purpose timer with extensive event-generation, match/compare, and complex PWM and output control features.
- Supports DMA and can trigger external DMA events.
- Supports fractional match values for high resolution.
- State machine capability.
- 8 general-purpose inputs.
- 10 general-purpose/PWM outputs
- 16 matches or captures
- 16 events
- 32 states

◆ Five general purpose, 32-bit timer/counter modules with PWM capability.
- Each timer supports four match outputs and four capture inputs.
- Match register auto-reload from shadow registers.
- It supports DMA and can trigger external DMA events.

◆ 24-bit multi-rate timer module with four channels, each capable of generating repetitive interrupts at different programmable frequencies.

◆ Two Windowed Watchdog Timers (WDT) with dedicated watchdog oscillator.

◆ Frequency measurement module to determine the frequency of a selection of on-chip or off-chip clock sources.

◆ Real-Time Clock (RTC) with independent power supply and dedicated oscillator. Integrated wake-up timer can be used to wake the device up from low-power modes. The RTC includes eight 32-bit general purpose registers which can retain content when power is removed from the rest of the chip.

◆ Ultra-low power micro-tick timer running from the watchdog oscillator with capture capability for timestamping. Can be used to wake the device up from low-power modes.

◆ 64-bit OS Event Timer common to the Cortex-M33 and DSP processors with individual match/capture and interrupt generation logic.

◆ CRC engine block can calculate a CRC on supplied data using one of three standard polynomials. The CRC engine supports DMA.

◆ AES256 encryption module. The Random Number Generator can be used to create keys. Key storage is in OTP. The AES supports DMA.

◆ Physical Unclonable Function (PUF) key generation module.

◆ SHA1/SHA2 Secure Hash Algorithm module. Supports secure boot, uses a dedicated DMA controller.

◆ Cryptography hardware coprocessor attached to Cortex-M33 CPU.

■ Analog peripherals:

◆ One 12-bit ADC with sampling rates of 1 Msamples/sec and an enhanced ADC controller. It supports up to 12 single-ended channels or 6 differential channels. The ADC supports DMA.

◆ Temperature sensor.

◆ Analog comparator.

■ I/O peripherals:

◆ Up to 147 general purpose I/O (GPIO) pins with configurable pull-up/pull-down resistors. Ports can be written as words, half-words, bytes, or bits. The number of GPIOs depends on the device package.

◆ Individual GPIO pins can be used as edge and level sensitive interrupt sources, each with its own interrupt vector.

◆ All port0 and port1 GPIO pins can contribute to a one of two GPIO interrupts, with selection of polarity and edge vs level triggering.

◆ A group of up to 8 GPIO pins can be selected for boolean pattern matching, which can generate interrupts and/or drive a pattern-match output.

◆ Adjustable output drivers.

◆ JTAG boundary scan.

■ Clock generation unit:

◆ Crystal oscillator with an operating range of 4 MHz to 32 MHz.

◆ Internal 48 or 60 MHz IRC oscillator. Trimmed to ± 1% accuracy.

◆ Internal 16 MHz IRC oscillator. Trimmed to ± 3% accuracy.

◆ Internal 1 MHz low-power oscillator with 10% accuracy. Serves as the watchdog oscillator and clock for the OS Event Timer and the Systick. Also available as the system clock.

◆ 32 kHz real-time clock (RTC) oscillator that can optionally be used as a system clock.

◆ Selectable on-chip crystal load capacitors for RTC oscillator.

◆ Main System PLL:
- Allows CPU operation up to the maximum rate without the need for a high frequency crystal. May be run from the 16 MHz IRC, the 48/60 MHz IRC, or the crystal.
- Second PLL output using an independent fractional divider provides an alternate high-frequency clock source for the DSP CPU if the required frequency differs from the main system clock.
- Two additional PLL outputs, each using independent fractional dividers, providing alternative clock input sources to a number of peripherals.

◆ Audio PLL for the audio subsystem.

◆ 480 MHz USB PLL (internal to the USB PHY).

◆ Clock output function with divider that can reflect any of the internal clock sources.

■ Power control:

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◆ Main power supply is 1.8 V +/- 5%.

◆ Analog supply is 1.71 V - 3.6 V.

◆ Triple VDDIO supplies (can be shared or independent): 1.71 V - 3.6 V.

◆ USB Supply: 3.0 V - 3.6 V.

◆ Reduced power modes:

  - Sleep mode: Clock shut down for each CPU independently.
  - Deep-sleep mode: User selectable configuration via PDSLEEPCFG.
  - Deep power-down mode: Power removed from the entire chip except in the always-on domain.
  - Full deep power-down mode: same as deep power-down mode, but external power can be removed (except for VDD_AO18).
  - Each individual SRAM partition can be independently powered-off or put into a low-power retain mode. Individual SRAMs can also have their clocks stopped when not actually in use in order to save power.
  - Ability to operate the synchronous serial interfaces in sleep or deep-sleep mode as a slave or USART clocked by the 32 kHz RTC oscillator.
  - Wake-up from low-power modes via interrupts from various peripherals including the RTC and the OS/Event timer.

◆ RBB/FBB to provide additional control over power/performance trade-offs.

◆ Power-On Reset (POR).

■ Operating temperature range -20 °C to +85 °C

■ Available in VFBGA176, WLCSP114, and FOWLP249 packages.

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3. Applications

- ■ Consumer
- ■ Audio

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4. Ordering information

Table 1. Ordering information

Type number	Package			
	Name	**Description**		**Version**
MIMXRT685SFFOB	FOWLP249	Fan-Out Wafer-Level Packaging; 249 balls; 7 x 7 x 0.76 mm		SOT2003-1
MIMXRT685SFVKB	VFBGA176	thin fine-pitch ball grid array package; 176 balls; body 9 x 9 x 0.98 mm		SOT1850-1
MIMXRT685SFAWBR	WLCSP114	wafer level chip-size package; 114; 4.235 x 4.235 x 0.525 mm		SOT2019

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4.1 Ordering options

Table 2.   Ordering options 4

Type number	Package Name	M33	HiFi4 DSP	SRAM/MB	Security Features	FlexSPI A Interface	FlexSPI B Interface	RTC	USB ISP mode[1][4]	Flexcomm Interfaces (0 to 7)	High Speed SPI (Flexcomm 14)	PMIC I2C (Flexcomm 15) [3]	GPIO	SD/MMC
MIMXRT685SFFOB	FOWLP249	Yes	Yes	4.5	Yes	Yes	Yes	Yes	Yes	8	Yes	Yes	147	2
MIMXRT685SFVKB	VFBGA176	Yes	Yes	4.5	Yes	Yes	Yes	Yes	Yes	6	Yes	Yes	96	1
MIMXRT685SFAWBR	WLCSP114	Yes	Yes	4.5	Yes	Yes	No	No	No	7[2]	Yes	No	65	-

[1]   On WLCSP114 package, USB ISP mode is not supported. VBUS pin is not available on the WLCSP114 package. To detect VBUS connection, user can connect a GPIO pin to the USB connector's VBUS. When a rising edge occurs on the GPIO pin, software should set bit 10 (FORCE_VBUS) and bit 16 (DCON) in the DEVCMDSTAT register.

[2]   On WLCSP114 package, the Flexcomm interface 6 can only be used as a UART peripheral, I2C peripheral, or I2S peripheral (using I2S signal sharing feature).

[3]   This interface is intended primarily for communication with an external power management device (PMIC), but can be used for other purposes when the application does not use an external PMIC.

[4]   USB ISP can only boot with an external crystal oscillator of 24 MHz.

5. Marking

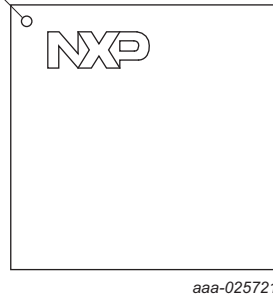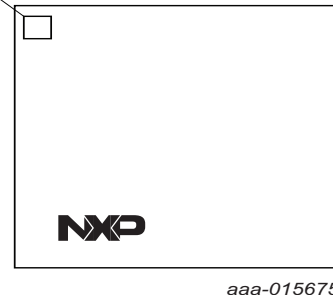**Fig 1. VFBGA 176 package marking**

Fig 2. WLCSP 114 package marking

The MIMXRT6xxSFAWBR WLCSP114 production samples has the following top-side package marking:

- First line: MRT6xxSF
- Second line: AW[R]R
- Third line: xxxxxx xx
- Fourth line: xxxxyyww
    - yyww: Date code with yy = year and ww = week
- Fifth line: xxx-yyy
- Sixth line: NXP

The MIMXRT6xxSFVKB VFBGA176 production samples has the following top-side package marking:

- First line: MRT6xxSFV
- Second line: K[R] xxxx
- Third line: xyyww
- Fourth line: xxxxx
    - yyww: Date code with yy = year and ww = week

The MIMXRT6xxSFFOB FOWLP249 production samples has the following top-side package marking:

- First line: MRT6xxSFFOB
- Second line: xxxxxx
- Third line: xxxxxx
- Fourth line: xxxxxyyww
    - yyww: Date code with yy = year and ww = week

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Table 3.   Device revision table

Revision identifier	Revision description [R]
B	Initial device revision

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6. Block diagram

Figure 3, Figure 4, and Figure 5 shows the RT600 block diagram. On Figure 4, shaded blocks support general purpose DMA or blocks include dedicated DMA control.
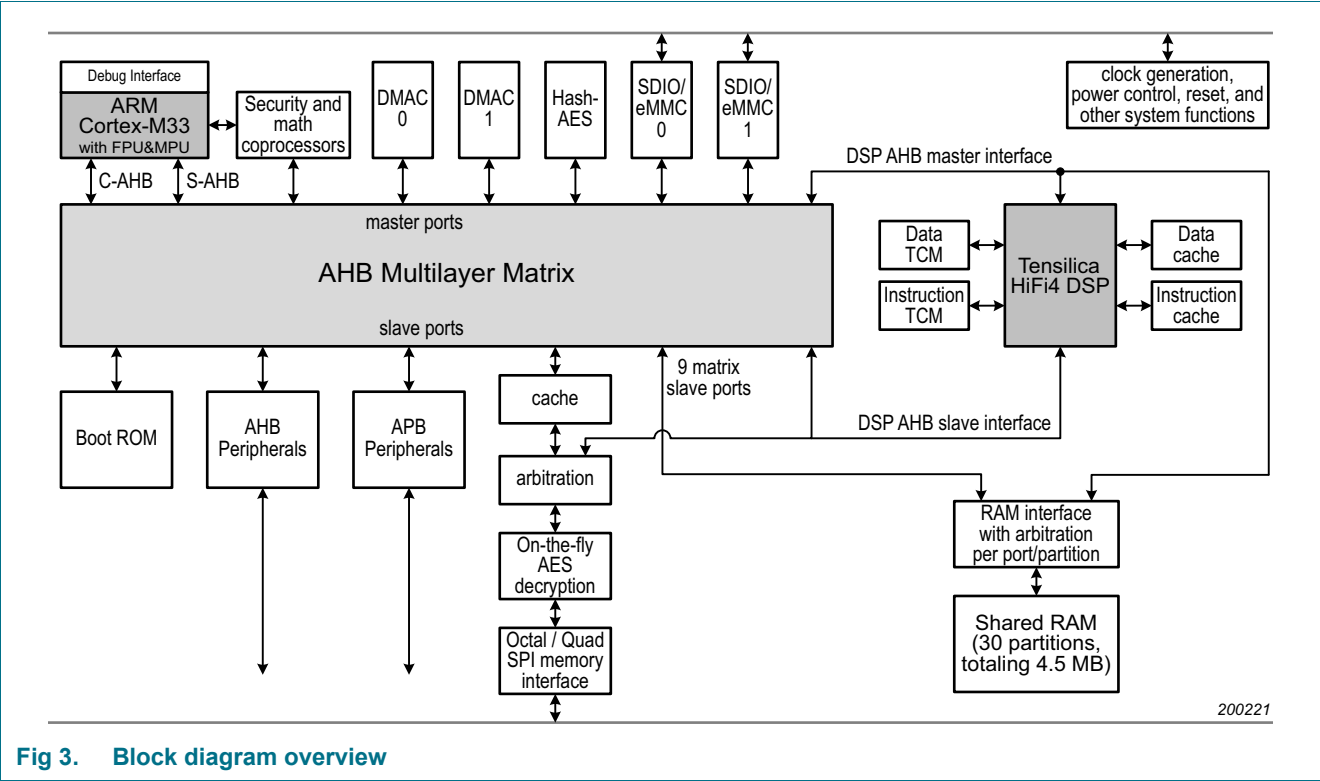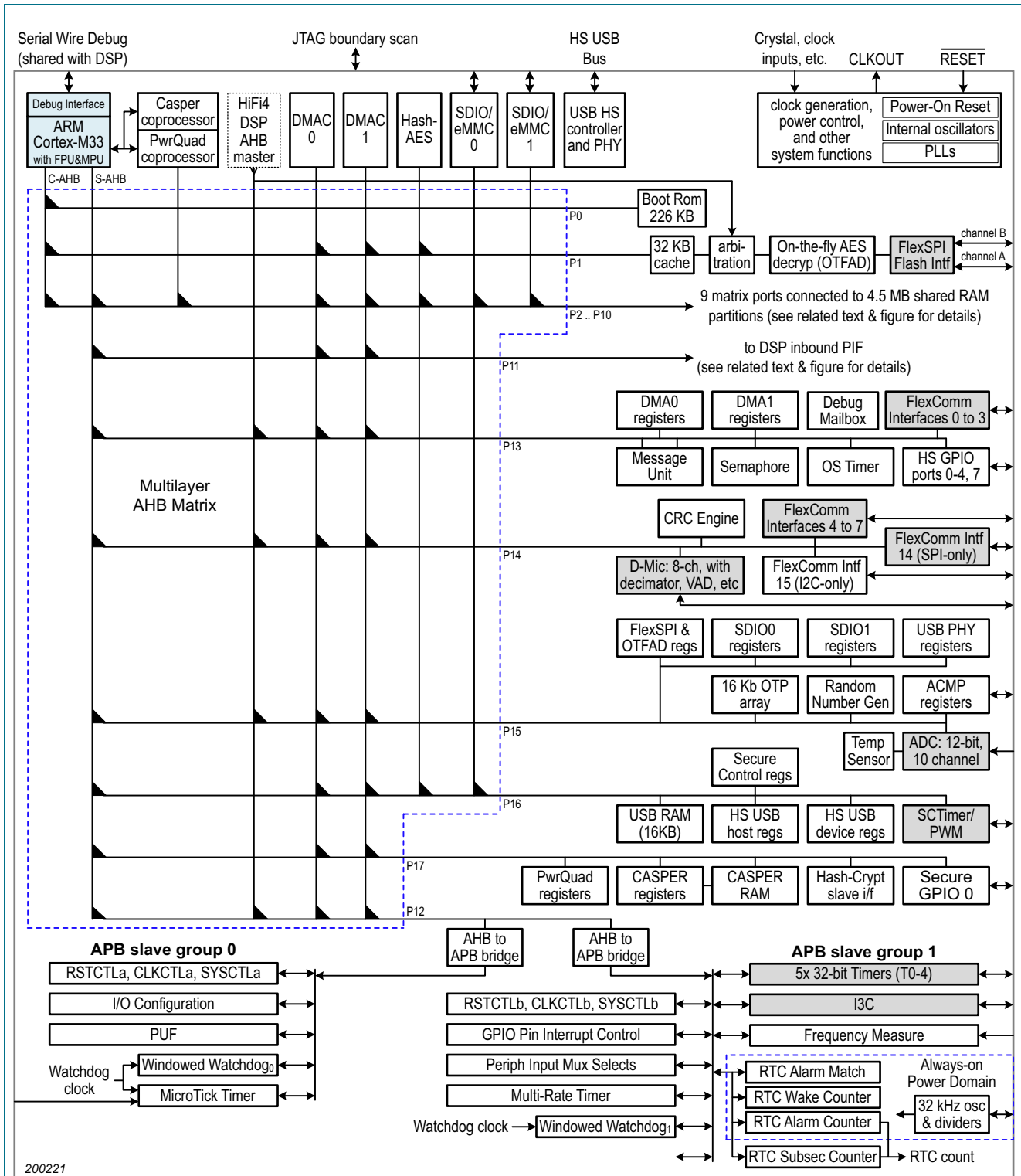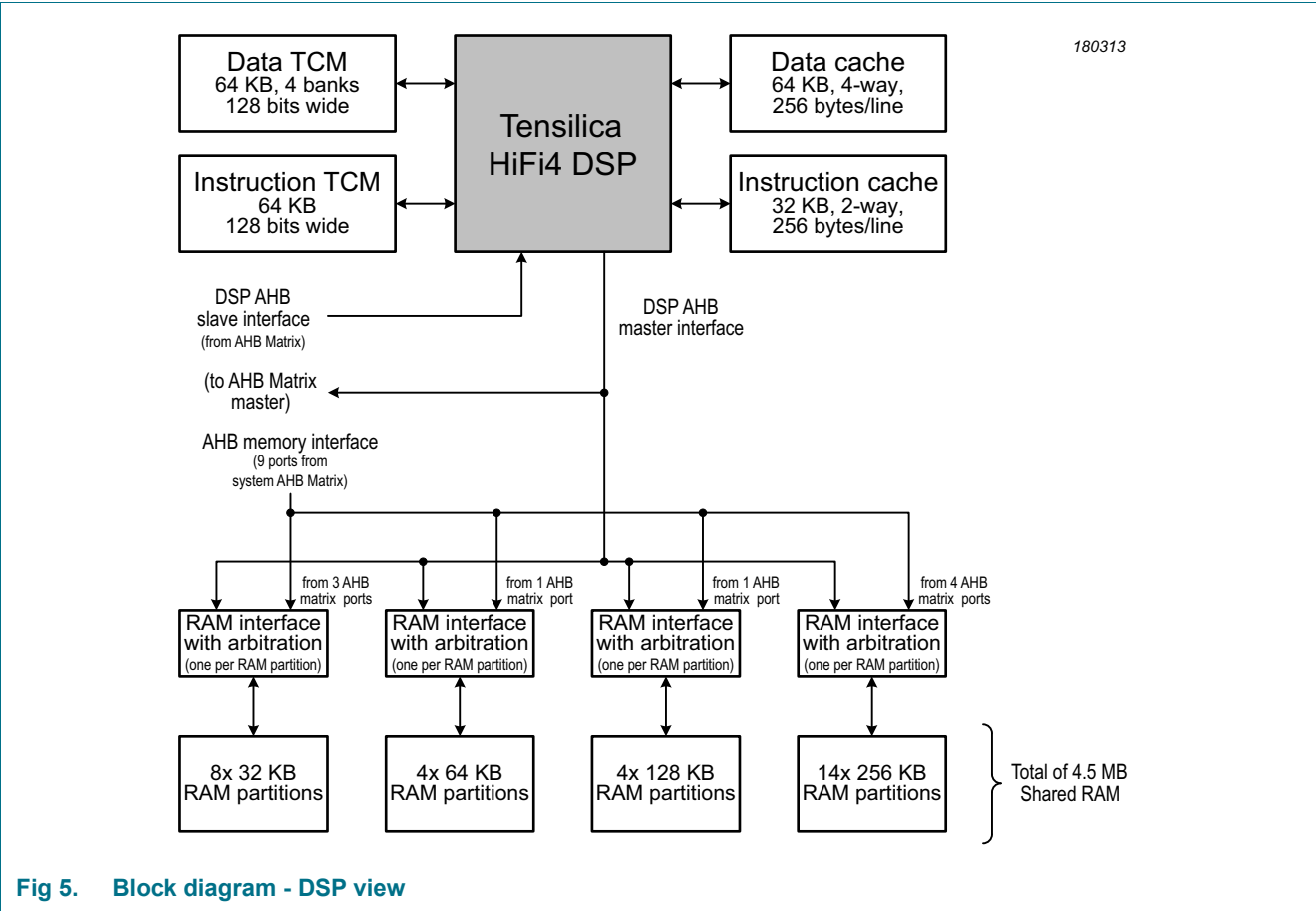

Fig 3. **Block diagram overview**

Fig 4. Block diagram - Cortex-M33 view (Not all features are available in all packages. Flexcomm Interfaces 0 through7 each include USART, SPI, I2C, and I2S functions. Grey-shaded blocks indicate peripherals that provide DMA requests or are otherwise able to trigger DMA transfers. Hash-AES and SDIO include a dedicated DMA function.)

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Fig 5.   Block diagram - DSP view

7. Pinning information

Table 4 shows the pin functions available on each pin, and for each package. These functions are selectable using IOCON control registers.

Some functions, such as ADC or comparator inputs, are available only on specific pins when digital functions are disabled on those pins. By default, the GPIO function is selected except on pins PIO2_25 and PIO2_26, which are the serial wire debug pins. This allows debug to operate through reset.

All GPIO pins have all pull-ups and pull-downs turned off at reset. This prevents power loss through pins prior to software configuration. All GPIO pins are fail safe up to 3.6 V when VDDIO supply = 0 V except following pins (PIO1_18 to PIO1_31, PIO2_0 to PIO2_8, PIO0_21, PIO0_22, and PIO0_23 pins). See GPIO pin diagrams for configuration options Figure 31 "Simplified fail-safe GPIO pins" and Figure 32 "Simplified high-speed GPIO pins".

The state of pins PIO1_15, PIO1_16, and PIO1_17 at Reset determine the boot source for the part or if the ISP handler is invoked.

The JTAG functions TRST, TCK, TMS, TDI, and TDO, are selected on pins PIO0_7 to PIO0_11 by hardware when the part is in boundary scan mode.

Table 4.   Pin description

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP		Reset state [1]	Type	Function #	Description
PIO0_0	H3	G1	H17		Z	I/O	0	**PIO0_0 —** General-purpose digital input/output pin.
						I/O	1	**FC0_SCK —** Flexcomm 0: USART, SPI, or I2S clock.
							2	**R —** Reserved.
							3	**R —** Reserved.
						O	4	**CTIMER0_MAT0 —** 32-bit CTimer0 match output 0.
						I	5	**I2S_BRIDGE_CLK_IN —** Allows I2S bypass by re-routing this function to a pin that includes the I2S_BRIDGE_CLK_OUT function.
						O	6	**GPIO_INT_BMAT —** Output of the pin interrupt pattern match engine.
							7	**R —** Reserved.
						I/O	8	**SEC_PIO0_0 —** Secure GPIO pin.

Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_1	H2	G2	H16	Z	I/O	0	**PIO0_1 —** General-purpose digital input/output pin.
					I/O	1	**FC0_TXD_SCL_MISO_WS —** Flexcomm 0: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
						2	**R —** Reserved.
						3	**R —** Reserved
					O	4	**CTIMER0_MAT1 —** 32-bit CTimer0 match output 1.
					I	5	**I2S_BRIDGE_WS_IN —** Allows I2S bypass by re-routing this function to a pin that includes the I2S_BRIDGE_WS_OUT function.
						6	**R —** Reserved.
						7	**R —** Reserved
					I/O	8	**SEC_PIO0_1 —** Secure GPIO pin.
PIO0_2	F5	G4	H15	Z	I/O	0	**PIO0_2 —** General-purpose digital input/output pin.
					I/O	1	**FC0_RXD_SDA_MOSI_DATA —** Flexcomm 0: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER0_MAT2 —** 32-bit CTimer0 match output 2.
					I	5	**I2S_BRIDGE_DATA_IN —** Allows I2S bypass by re-routing this function to a pin that includes the I2S_BRIDGE_DATA_OUT function.
						6	**R —** Reserved.
						7	**R —** Reserved
					I/O	8	**SEC_PIO0_2 —** Secure GPIO pin.
PIO0_3	F4	H2	H14	Z	I/O	0	**PIO0_3 —** General-purpose digital input/output pin.
					I/O	1	**FC0_CTS_SDA_SSEL0 —** Flexcomm 0: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER0_MAT3 —** 32-bit CTimer0 match output 3.
					I/O	5	**FC1_SSEL2 —** Flexcomm 1: SPI slave select 2.
						6	**R —** Reserved.
						7	**R —** Reserved
					I/O	8	**SEC_PIO0_3 —** Secure GPIO pin.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_4	G1	J1	K17	Z	I/O	0	**PIO0_4 —** General-purpose digital input/output pin.
					I/O	1	**FC0_RTS_SCL_SSEL1 —** Flexcomm 0: USART request-to-send, I2C clock, SPI slave select 1.
						2	**R —** Reserved.
						3	**R —** Reserved.
					I	4	**CTIMER_INP0 —** Capture input 0 to CTIMER input muxes.
					I/O	5	**FC1_SSEL3 —** Flexcomm 1: SPI slave select 3.
						6	**R —** Reserved.
					O	7	**CMP0_OUT —** Analog comparator 0 output.
					I/O	8	**SEC_PIO0_4 —** Secure GPIO pin.
PIO0_5/ CH0A	J3	F4	F16	Z	I/O; AI	0	**PIO0_5/CH0A —** General-purpose digital input/output pin. Analog input 0A. Can optionally be paired with CH0B for differential input on ADC channel 0.
					I/O	1	**FC0_SSEL2 —** Flexcomm 0: SPI slave select 2.
					I	2	**SCT0_GPI0 —** Pin input 0 to SCTimer/PWM.
					O	3	**SCT0_OUT0 —** SCTimer/PWM output 0.
					I	4	**CTIMER_INP1 —** Capture input 1 to CTIMER input muxes.
						5	**R —** Reserved.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_5 —** Secure GPIO pin.
PIO0_6/ CH0B	J1	E1	F17	Z	I/O; AI	0	**PIO0_6/CH0B —** General-purpose digital input/output pin. Analog input 0A. Can optionally be paired with CH0B for differential input on ADC channel 0.
					I/O	1	**FC0_SSEL3 —** Flexcomm 0: SPI slave select 3.
					I	2	**SCT0_GPI1 —** Pin input 1 to SCTimer/PWM.
					O	3	**SCT0_OUT1 —** SCTimer/PWM output 1.
					O	4	**CTIMER0_MAT0 —** 32-bit CTimer0 match output 0.
						5	**R —** Reserved.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_6 —** Secure GPIO pin.

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Table 4. **Pin description** …continued

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_7/ TRST	F3	J2	J15	Z	I/O	0	**PIO0_7 —** General-purpose digital input/output pin. In boundary scan mode: TRST (Test Reset).
					I/O	1	**FC1_SCK —** Flexcomm 1: USART, SPI, or I2S clock.
					I	2	**SCT0_GPI4 —** Pin input 4 to SCTimer/PWM.
					O	3	**SCT0_OUT4 —** SCTimer/PWM output 4.
					O	4	**CTIMER1_MAT0 —** 32-bit CTimer1 match output 0.
					O	5	**I2S_BRIDGE_CLK_OUT —** Allows I2S bypass by re-routing a pin that includes the I2S_BRIDGE_CLK_IN function to this pin.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_7 —** Secure GPIO pin.
PIO0_8/ TCK	E4	K4	K16	Z	I/O	0	**PIO0_8 —** General-purpose digital input/output pin. In boundary scan mode: TCK (Test Clock In).
					I/O	1	**FC1_TXD_SCL_MISO_WS —** Flexcomm 1: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
					I	2	**SCT0_GPI5 —** Pin input 5 to SCTimer/PWM.
					O	3	**SCT0_OUT5 —** SCTimer/PWM output 5.
					O	4	**CTIMER1_MAT1 —** 32-bit CTimer1 match output 1.
					O	5	**I2S_BRIDGE_WS_OUT —** Allows I2S bypass by re-routing a pin that includes the I2S_BRIDGE_WS_IN function to this pin.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_8 —** Secure GPIO pin.
PIO0_9/ TMS	E3	L3	K15	Z	I/O	0	**PIO0_9 —** General-purpose digital input/output pin. In boundary scan mode: TMS (Test Mode Select).
					I/O	1	**FC1_RXD_SDA_MOSI_DATA —** Flexcomm 1: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
					I	2	**SCT0_GPI6 —** Pin input 6 to SCTimer/PWM.
					O	3	**SCT0_OUT6 —** SCTimer/PWM output 6.
					O	4	**CTIMER1_MAT2 —** 32-bit CTimer1 match output 2.
					O	5	**I2S_BRIDGE_DATA_OUT —** Allows I2S bypass by re-routing a pin that includes the I2S_BRIDGE_DATA_IN function to this pin.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_9 —** Secure GPIO pin.

Table 4.   Pin description ...*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_10/ TDI	E2	J3	L16	Z	I/O	0	**PIO0_10 —** General-purpose digital input/output pin. In boundary scan mode: TDI (Test Data In).
					I/O	1	**FC1_CTS_SDA_SSEL0 —** Flexcomm 1: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
					I	2	**SCT0_GPI7 —** Pin input 7 to SCTimer/PWM.
					O	3	**SCT0_OUT7 —** SCTimer/PWM output 7.
					O	4	**CTIMER1_MAT3 —** 32-bit CTimer1 match output 3.
					I/O	5	**FC0_SSEL2 —** Flexcomm 0: SPI slave select 2.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_10 —** Secure GPIO pin.
PIO0_11/ TDO	E1	L1	K13	Z	I/O	0	**PIO0_11 —** General-purpose digital input/output pin. In boundary scan mode: TDO (Test Data Out).
					I/O	1	**FC1_RTS_SCL_SSEL1 —** Flexcomm 1: USART request-to-send, I2C clock, SPI slave select 1.
					I	2	**SCT0_GPI0 —** Pin input 0 to SCTimer/PWM.
					O	3	**SCT0_OUT8 —** SCTimer/PWM output 8.
					I	4	**CTIMER_INP2 —** Capture input 2 to CTIMER input muxes.
					I/O	5	**FC0_SSEL3 —** Flexcomm 0: SPI slave select 3.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_11 —** Secure GPIO pin.
PIO0_12/ CH1A	K1	E3	F15	Z	I/O; AI	0	**PIO0_12/CH1A —** General-purpose digital input/output pin. Analog input 1A. Can optionally be paired with CH1B for differential input on ADC channel 1.
					I/O	1	**FC1_SSEL2 —** Flexcomm 1: SPI slave select 2.
					I	2	**SCT0_GPI2 —** Pin input 2 to SCTimer/PWM.
					O	3	**SCT0_OUT2 —** SCTimer/PWM output 2.
					I	4	**CTIMER_INP3 —** Capture input 3 to CTIMER input muxes.
						5	**R —** Reserved.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_12 —** Secure GPIO pin.

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Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_13/ CH1B	G4	G3	G16	Z	I/O; AI	0	**PIO0_13/CH1B —** General-purpose digital input/output pin. Analog input 1B. Can optionally be paired with CH1A for differential input on ADC channel 1.
					I/O	1	**FC1_SSEL3 —** Flexcomm 1: SPI slave select 3.
					I	2	**SCT0_GPI3 —** Pin input 3 to SCTimer/PWM.
					O	3	**SCT0_OUT3 —** SCTimer/PWM output 3.
					O	4	**CTIMER0_MAT1 —** 32-bit CTimer0 match output 1.
						5	**R —** Reserved.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_13 —** Secure GPIO pin.
PIO0_14	K4	A3	B17	Z	I/O	0	**PIO0_14 —** General-purpose digital input/output pin.
					I/O	1	**FC2_SCK —** Flexcomm 1: USART, SPI, or I2S clock.
					I	2	**SCT0_GPI0 —** Pin input 0 to SCTimer/PWM.
					O	3	**SCT0_OUT0 —** SCTimer/PWM output 0.
					O	4	**CTIMER2_MAT0 —** 32-bit CTimer2 match output 0.
					I	5	**I2S_BRIDGE_CLK_IN —** Allows I2S bypass by re-routing this function to a pin that includes the I2S_BRIDGE_CLK_OUT function.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_14 —** Secure GPIO pin.
PIO0_15	J6	A5	A16	Z	I/O	0	**PIO0_15 —** General-purpose digital input/output pin.
					I/O	1	**FC2_TXD_SCL_MISO_WS —** Flexcomm 2: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
					I	2	**SCT0_GPI1 —** Pin input 1 to SCTimer/PWM.
					O	3	**SCT0_OUT1 —** SCTimer/PWM output 1.
					O	4	**CTIMER2_MAT1 —** 32-bit CTimer2 match output 1.
					I	5	**I2S_BRIDGE_WS_IN —** Allows I2S bypass by re-routing this function to a pin that includes the I2S_BRIDGE_WS_OUT function.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_15 —** Secure GPIO pin.

Table 4.   Pin description …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_16	K5	D6	B12	Z	I/O	0	**PIO0_16 —** General-purpose digital input/output pin.
					I/O	1	**FC2_RXD_SDA_MOSI_DATA —** Flexcomm 2: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
					I	2	**SCT0_GPI2 —** Pin input 2 to SCTimer/PWM.
					O	3	**SCT0_OUT2 —** SCTimer/PWM output 2.
					O	4	**CTIMER2_MAT2 —** 32-bit CTimer2 match output 2.
					I	5	**I2S_BRIDGE_DATA_IN —** Allows I2S bypass by re-routing this function to a pin that includes the I2S_BRIDGE_DATA_OUT function.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_16 —** Secure GPIO pin.
PIO0_17	-	D7	B14	Z	I/O	0	**PIO0_17 —** General-purpose digital input/output pin.
					I/O	1	**FC2_CTS_SDA_SSEL0 —** Flexcomm 2: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
					I	2	**SCT0_GPI3 —** Pin input 3 to SCTimer/PWM.
					O	3	**SCT0_OUT3 —** SCTimer/PWM output 3.
					O	4	**CTIMER2_MAT3 —** 32-bit CTimer2 match output 3.
					I/O	5	**FC5_SSEL2 —** Flexcomm 5: SPI slave select 2.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_17 —** Secure GPIO pin.
PIO0_18	-	B7	A14	Z	I/O	0	**PIO0_18 —** General-purpose digital input/output pin.
					I/O	1	**FC2_RTS_SCL_SSEL1 —** Flexcomm 2: USART request-to-send, I2C clock, SPI slave select 1.
					I	2	**SCT0_GPI6 —** Pin input 6 to SCTimer/PWM.
					O	3	**SCT0_OUT6 —** SCTimer/PWM output 6.
					I	4	**CTIMER_INP4 —** Capture input 4 to CTIMER input muxes.
					I/O	5	**FC5_SSEL3 —** Flexcomm 5: SPI slave select 3.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_18 —** Secure GPIO pin.

Table 4. **Pin description** ...*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_19/ CH2A	H6	A1	D12	Z	I/O; AI	0	**PIO0_19/CH2A —** General-purpose digital input/output pin. Analog input 2A. Can optionally be paired with CH2B for differential input on ADC channel 2.
					I/O	1	**FC2_SSEL2 —** Flexcomm 2: SPI slave select 2.
					I	2	**SCT0_GPI4 —** Pin input 4 to SCTimer/PWM.
					O	3	**SCT0_OUT4 —** SCTimer/PWM output 4.
					I	4	**CTIMER_INP5 —** Capture input 5 to CTIMER input muxes.
					I	5	**UTICK_CAP0 —** Micro-tick timer capture input 0.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_19 —** Secure GPIO pin.
PIO0_20/ CH2B	H5	B2	E13	Z	I/O; AI	0	**PIO0_20/CH2B —** General-purpose digital input/output pin. Analog input 2B. Can optionally be paired with CH2A for differential input on ADC channel 2.
					I/O	1	**FC2_SSEL3 —** Flexcomm 2: SPI slave select 3.
					I	2	**SCT0_GPI5 —** Pin input 5 to SCTimer/PWM.
					O	3	**SCT0_OUT5 —** SCTimer/PWM output 5.
					O	4	**CTIMER0_MAT2 —** 32-bit CTimer0 match output 2.
					I	5	**CTIMER_INP11 —** Capture input 11 to CTIMER input muxes.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_20 —** Secure GPIO pin.
PIO0_21	L5	C7	A12	Z	I/O	0	**PIO0_21 —** General-purpose digital input/output pin.
					I/O	1	**FC3_SCK —** Flexcomm 3: USART, SPI, or I2S clock.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT0 —** 32-bit CTimer3 match output 0.
						5	**R —** Reserved.
					O	6	**TRACECLK —** Trace clock.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_21 —** Secure GPIO pin.

Table 4. **Pin description** …continued

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_22	H7	D8	A10	Z	I/O	0	**PIO0_22 —** General-purpose digital input/output pin.
					I/O	1	**FC3_TXD_SCL_MISO_WS —** Flexcomm 3: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT1 —** 32-bit CTimer3 match output 1.
						5	**R —** Reserved.
					O	6	**TRACEDATA[0] —** Trace data bit 0.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_22 —** Secure GPIO pin.
PIO0_23	K7	C9	A8	Z	I/O	0	**PIO0_23/ —** General-purpose digital input/output pin.
					I/O	1	**FC3_RXD_SDA_MOSI_DATA —** Flexcomm 3: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT2 —** 32-bit CTimer3 match output 2.
						5	**R —** Reserved.
					O	6	**TRACEDATA[1] —** Trace data bit 1.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_23 —** Secure GPIO pin.
PIO0_24	H8	B9	B8	Z	I/O	0	**PIO0_24 —** General-purpose digital input/output pin.
					I/O	1	**FC3_CTS_SDA_SSEL0 —** Flexcomm 3: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT3 —** 32-bit CTimer3 match output 3.
					I/O	5	**FC2_SSEL2 —** Flexcomm 2: SPI slave select 2.
					O	6	**TRACEDATA[2] —** Trace data bit 2.
					O	7	**CLKOUT —** Output of the CLKOUT function.
					I/O	8	**SEC_PIO0_24 —** Secure GPIO pin.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_25	L6	A9	B7	Z	I/O	0	**PIO0_25 —** General-purpose digital input/output pin.
					I/O	1	**FC3_RTS_SCL_SSEL1 —** Flexcomm 3: USART request-to-send, I2C clock, SPI slave select 1.
						2	**R —** Reserved.
					I	3	**FREQME_GPIO_CLK —** Frequency Measure pin clock input.
					I	4	**CTIMER_INP6 —** Capture input 6 to CTIMER input muxes.
					I/O	5	**FC2_SSEL3 —** Flexcomm 2: SPI slave select 3.
					O	6	**TRACEDATA[3] —** Trace data bit 3.
					I	7	**CLKIN —** Clock input.
					I/O	8	**SEC_PIO0_25 —** Secure GPIO pin.
PIO0_26/ CH3A	L3	A2	B16	Z	I/O; AI	0	**PIO0_26/CH3A —** General-purpose digital input/output pin. Analog input 3A. Can optionally be paired with CH3B for differential input on ADC channel 3.
					I/O	1	**FC3_SSEL2 —** Flexcomm 3: SPI slave select 2.
					I	2	**SCT0_GPI6 —** Pin input 6 to SCTimer/PWM.
					O	3	**SCT0_OUT6 —** SCTimer/PWM output 6.
					I	4	**CTIMER_INP7 —** Capture input 7 to CTIMER input muxes.
						5	**R —** Reserved.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_26 —** Secure GPIO pin.
PIO0_27/ CH3B	J4	B3	D13	Z	I/O; AI	0	**PIO0_27/CH3B —** General-purpose digital input/output pin. Analog input 3B. Can optionally be paired with CH3A for differential input on ADC channel 3.
					I/O	1	**FC3_SSEL3 —** Flexcomm 3: SPI slave select 3.
					I	2	**SCT0_GPI7 —** Pin input 7 to SCTimer/PWM.
					O	3	**SCT0_OUT7 —** SCTimer/PWM output 7.
					O	4	**CTIMER0_MAT3 —** 32-bit CTimer0 match output 3.
						5	**R —** Reserved.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_27 —** Secure GPIO pin.

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Table 4.   **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_28	-	D11	A6	Z	I/O	0	**PIO0_28 —** General-purpose digital input/output pin.
					I/O	1	**FC4_SCK —** Flexcomm 4: USART, SPI, or I2S clock.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT0 —** 32-bit CTimer4 match output 0.
					O	5	**I2S_BRIDGE_CLK_OUT —** Allows I2S bypass by re-routing a pin that includes the I2S_BRIDGE_CLK_IN function to this pin.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_28 —** Secure GPIO pin.
PIO0_29	K8	B10	B6	Z	I/O	0	**PIO0_29 —** General-purpose digital input/output pin.
					I/O	1	**FC4_TXD_SCL_MISO_WS —** Flexcomm 4: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT1 —** 32-bit CTimer4 match output 1.
					O	5	**I2S_BRIDGE_WS_OUT —** Allows I2S bypass by re-routing a pin that includes the I2S_BRIDGE_WS_IN function to this pin.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_29 —** Secure GPIO pin.
PIO0_30	L8	C11	C6	Z	I/O	0	**PIO0_30 —** General-purpose digital input/output pin.
					I/O	1	**FC4_RXD_SDA_MOSI_DATA —** Flexcomm 4: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT2 —** 32-bit CTimer4 match output 2.
					O	5	**I2S_BRIDGE_DATA_OUT —** Allows I2S bypass by re-routing a pin that includes the I2S_BRIDGE_DATA_IN function to this pin.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_30 —** Secure GPIO pin.

Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO0_31	-	A11	B1	Z	I/O	0	**PIO0_31 —** General-purpose digital input/output pin.
					I/O	1	**FC4_CTS_SDA_SSEL0 —** Flexcomm 4: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
					I	2	**SCT0_GPI0 —** Pin input 0 to SCTimer/PWM.
					O	3	**SCT0_OUT6 —** SCTimer/PWM output 6.
					O	4	**CTIMER4_MAT3 —** 32-bit CTimer4 match output 3.
					I/O	5	**FC3_SSEL2 —** Flexcomm 3: SPI slave select 2.
						6	**R —** Reserved.
						7	**R —** Reserved.
					I/O	8	**SEC_PIO0_31 —** Secure GPIO pin.
PIO1_0	-	E17	H4	Z	I/O	0	**PIO1_0 —** General-purpose digital input/output pin.
					I/O	1	**FC4_RTS_SCL_SSEL1 —** Flexcomm 4: USART request-to-send, I2C clock, SPI slave select 1.
					I	2	**SCT0_GPI1 —** Pin input 1 to SCTimer/PWM.
					O	3	**SCT0_OUT7 —** SCTimer/PWM output 7.
					I	4	**CTIMER_INP8 —** Capture input 8 to CTIMER input muxes.
					I/O	5	**FC3_SSEL3 —** Flexcomm 3: SPI slave select 3.
PIO1_1	-	G15	H5	Z	I/O	0	**PIO1_1 —** General-purpose digital input/output pin.
					I/O	1	**FC4_SSEL2 —** Flexcomm 4: SPI slave select 2.
					I	2	**SCT0_GPI2 —** Pin input 2 to SCTimer/PWM.
					O	3	**SCT0_OUT8 —** SCTimer/PWM output 8.
					O	4	**CTIMER1_MAT0 —** 32-bit CTimer1 match output 0.
PIO1_2/ CMP0_C	K6	A7	B11	Z	I/O; AI	0	**PIO1_2/CMP0_C —** General-purpose digital input/output pin. Analog comparator input C if the DIGIMODE bit is set to 0 and ANAMODE is set to 1 in the IOCON register for this pin.
					I/O	1	**FC4_SSEL3 —** Flexcomm 4: SPI slave select 3.
					I	2	**SCT0_GPI3 —** Pin input 3 to SCTimer/PWM.
					O	3	**SCT0_OUT9 —** SCTimer/PWM output 9.
					O	4	**CTIMER1_MAT1 —** 32-bit CTimer1 match output 1.
PIO1_3	F10	G16	J4	Z	I/O	0	**PIO1_3 —** General-purpose digital input/output pin.
					I/O	1	**FC5_SCK —** Flexcomm 5: USART, SPI, or I2S clock.
PIO1_4	F9	G17	H3	Z	I/O	0	**PIO1_4 —** General-purpose digital input/output pin.
					I/O	1	**FC5_TXD_SCL_MISO_WS —** Flexcomm 5: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
PIO1_5	E11	J16	J3	Z	I/O	0	**PIO1_5 —** General-purpose digital input/output pin.
					I/O	1	**FC5_RXD_SDA_MOSI_DATA —** Flexcomm 5: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO1_6	-	J17	K3	Z	I/O	0	**PIO1_6 —** General-purpose digital input/output pin.
					I/O	1	**FC5_CTS_SDA_SSEL0 —** Flexcomm 5: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
					I	2	**SCT0_GPI4 —** Pin input 4 to SCTimer/PWM.
					O	3	**SCT0_OUT4 —** SCTimer/PWM output 4.
						4	**R —** Reserved.
					I/O	5	**FC4_SSEL2 —** Flexcomm 4: SPI slave select 2.
PIO1_7	-	J15	E3	Z	I/O	0	**PIO1_7 —** General-purpose digital input/output pin.
					I/O	1	**FC5_RTS_SCL_SSEL1 —** Flexcomm 5: USART request-to-send, I2C clock, SPI slave select 1.
					I	2	**SCT0_GPI5 —** Pin input 5 to SCTimer/PWM.
					O	3	**SCT0_OUT5 —** SCTimer/PWM output 5.
					I	4	**CTIMER_INP9 —** Capture input 9 to CTIMER input muxes.
					I/O	5	**FC4_SSEL3 —** Flexcomm 4: SPI slave select 3.
PIO1_8/ CH4A	J5	B5	B15	Z	I/O; AI	0	**PIO1_8/CH4A —** General-purpose digital input/output pin. Analog input 4A. Can optionally be paired with CH4B for differential input on ADC channel 4.
					I/O	1	**FC5_SSEL2 —** Flexcomm 5: SPI slave select 2.
					I	2	**SCT0_GPI6 —** Pin input 6 to SCTimer/PWM.
					I	3	**CTIMER_INP12 —** Capture input 12 to CTIMER input muxes.
					O	4	**CTIMER1_MAT2 —** 32-bit CTimer1 match output 2.
PIO1_9/ CH4B	K3	B1	E14	Z	I/O; AI	0	**PIO1_9/CH4B —** General-purpose digital input/output pin. Analog input 4B. Can optionally be paired with CH4A for differential input on ADC channel 4.
					I/O	1	**FC5_SSEL3 —** Flexcomm 5: SPI slave select 3.
					I	2	**SCT0_GPI7 —** Pin input 7 to SCTimer/PWM.
					I	3	**UTICK_CAP1 —** Micro-tick timer capture input 1.
					O	4	**CTIMER1_MAT3 —** 32-bit CTimer1 match output 3.
PIO1_10	E10	K16	F2	Z	I/O	0	**PIO1_10 —** General-purpose digital input/output pin.
					I/O	1	**MCLK —** MCLK input or output for I2S and/or digital microphone.
						2	**R —** Reserved.
					I	3	**FREQME_GPIO_CLK —** Frequency Measure pin clock input.
					I	4	**CTIMER_INP10 —** Capture input 10 to CTIMER input muxes.
						5	**R —** Reserved.
						6	**R —** Reserved.
					O	7	**CLKOUT —** Output of the CLKOUT function.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO1_11	E5	L2	K14	Z	I/O	0	**PIO1_11 —** General-purpose digital input/output pin.
					I/O	1	**HS_SPI_SCK —** Clock for high speed SPI.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT0 —** 32-bit CTimer2 match output 0.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA0 —** Data bit 0 for the FlexSPI B interface.
PIO1_12	D2	M2	M17	Z	I/O	0	**PIO1_12 —** General-purpose digital input/output pin.
					I/O	1	**HS_SPI_MISO —** Master-in/slave-out data for high speed SPI.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT1 —** 32-bit CTimer2 match output 1.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA1 —** Data bit 1 for the FlexSPI B interface.
PIO1_13	D3	N1	M16	Z	I/O	0	**PIO1_13 —** General-purpose digital input/output pin.
					I/O	1	**HS_SPI_MOSI —** Master-out/slave-in data for high speed SPI.
						2	**R —** Reserved
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT2 —** 32-bit CTimer2 match output 2.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA2 —** Data bit 2 for the FlexSPI B interface.
PIO1_14	D4	N2	M14	Z	I/O	0	**PIO1_14 —** General-purpose digital input/output pin.
					I/O	1	**HS_SPI_SSEL0 —** Slave Select 0 for high speed SPI.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT3 —** 32-bit CTimer2 match output 3.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA3 —** Data bit 3 for the FlexSPI B interface.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO1_15	C2	N3	M15	Z	I/O	0	**PIO1_15 —** General-purpose digital input/output pin.
							Remark: The state of this pin at Reset in conjunction with PIO1_16 and PIO1_17 will determine the boot source for the part or if ISP handler is invoked. See the Boot Process chapter in the relevant User Manual for more details.
					I/O	1	**HS_SPI_SSEL1 —** Slave Select 1 for high speed SPI.
						2	**R —** Reserved
						3	**R —** Reserved
					O	4	**CTIMER3_MAT0 —** 32-bit CTimer3 match output 0.
PIO1_16	C3	M4	P17	Z	I/O	0	**PIO1_16 —** General-purpose digital input/output pin.
							Remark: The state of this pin at Reset in conjunction with PIO1_15 and PIO1_17 will determine the boot source for the part or if ISP handler is invoked. See the Boot Process chapter in the relevant User Manual for more details.
					I/O	1	**HS_SPI_SSEL2 —** Slave Select 2 for high speed SPI.
					O	2	**SCT0_OUT8 —** SCTimer/PWM output 8.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT1 —** 32-bit CTimer3 match output 1.
PIO1_17	B2	N4	M13	Z	I/O	0	**PIO1_17 —** General-purpose digital input/output pin.
							Remark: The state of this pin at Reset in conjunction with PIO1_15 and PIO1_16 will determine the boot source for the part or if ISP handler is invoked. See the Boot Process chapter in the relevant User Manual for more details.
					I/O	1	**HS_SPI_SSEL3 —** Slave Select 3 for high speed SPI.
					O	2	**SCT0_OUT9 —** SCTimer/PWM output 9.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT2 —** 32-bit CTimer3 match output 2.
PIO1_18	B7	T9	U4	Z	I/O	0	**PIO1_18 —** General-purpose digital input/output pin.
					O	1	**FLEXSPI0A_SCLK —** Clock output for the FlexSPI A interface.
					I	2	**SCT0_GPI0 —** Pin input 0 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT3 —** 32-bit CTimer3 match output 3.
PIO1_19	B4	T4	U16	Z	I/O	0	**PIO1_19 —** General-purpose digital input/output pin.
					O	1	**FLEXSPI0A_SS0_N —** Active low slave select 0 for the FlexSPI A interface.
					O	2	**SCT0_OUT0 —** SCTimer/PWM output 0.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT0 —** 32-bit CTimer4 match output 0.

Table 4.   **Pin description** …continued

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO1_20	C6	T5	T12	Z	I/O	0	**PIO1_20 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA0 —** Data bit 0 for the FlexSPI A interface.
					I	2	**SCT0_GPI1 —** Pin input 1 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT1 —** 32-bit CTimer4 match output 1.
PIO1_21	C7	U5	U12	Z	I/O	0	**PIO1_21 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA1 —** Data bit 1 for the FlexSPI A interface.
					O	2	**SCT0_OUT1 —** SCTimer/PWM output 1.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT2 —** 32-bit CTimer4 match output 2.
PIO1_22	B5	P6	T11	Z	I/O	0	**PIO1_22 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA2 —** Data bit 2 for the FlexSPI A interface.
					I	2	**SCT0_GPI2 —** Pin input 2 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT3 —** 32-bit CTimer4 match output 3.
PIO1_23	A5	P7	T10	Z	I/O	0	**PIO1_23 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA3 —** Data bit 3 for the FlexSPI A interface.
					O	2	**SCT0_OUT2 —** SCTimer/PWM output 2.
						3	**R —** Reserved.
					I	4	**CTIMER_INP8 —** Capture input 8 to CTIMER input muxes.
PIO1_24	-	T7	U10	Z	I/O	0	**PIO1_24 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA4 —** Data bit 4 for the FlexSPI A interface.
					I	2	**SCT0_GPI3 —** Pin input 3 to SCTimer/PWM.
						3	**R —** Reserved.
PIO1_25	-	U7	U8	Z	I/O	0	**PIO1_25 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA5 —** Data bit 5 for the FlexSPI A interface.
					O	2	**SCT0_OUT3 —** SCTimer/PWM output 3.
						3	**R —** Reserved.
PIO1_26	-	R7	U6	Z	I/O	0	**PIO1_26 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA6 —** Data bit 6 for the FlexSPI A interface.
					I	2	**SCT0_GPI4 —** Pin input 4 to SCTimer/PWM.
						3	**R —** Reserved.
PIO1_27	-	T8	T7	Z	I/O	0	**PIO1_27 —** General-purpose digital input/output pin.
					I/O	1	**FLEXSPI0A_DATA7 —** Data bit 7 for the FlexSPI A interface.
					O	2	**SCT0_OUT4 —** SCTimer/PWM output 4.
						3	**R —** Reserved.

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Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO1_28	-	U9	T6	Z	I/O	0	**PIO1_28 —** General-purpose digital input/output pin.
					O	1	**FLEXSPI0A_DQS —** Data strobe output for the FlexSPI A interface.
					I	2	**SCT0_GPI5 —** Pin input 5 to SCTimer/PWM.
						3	**R —** Reserved.
						4	**R —** Reserved.
PIO1_29	-	U3	U14	Z	I/O	0	**PIO1_29 —** General-purpose digital input/output pin.
					O	1	**FLEXSPI0A_SS1_N —** Active low slave select 1 for the FlexSPI A interface.
					I/O	2	**SCT0_OUT5 —** SCTimer/PWM output 5.
					I	3	**UTICK_CAP2 —** Micro-tick timer capture input 2.
					I	4	**CTIMER_INP13 —** Capture input 13 to CTIMER input muxes.
					O	5	**FLEXSPI0A_SCLK_N or FLEXSPI0B_SCLK —** Inverted clock output for the FlexSPI A interface or Clock output for the FlexSPI B interface.
PIO1_30	-	P10	P5	Z	I/O	0	**PIO1_30 —** General-purpose digital input/output pin.
					O	1	**SD0_CLK —** SD/MMC0 clock.
					I	2	**SCT0_GPI0 —** Pin input 0 to SCTimer/PWM.
PIO1_31	-	R9	N8	Z	I/O	0	**PIO1_31 —** General-purpose digital input/output pin.
					I/O	1	**SD0_CMD —** SD/MMC0 card command I/O.
					I	2	**SCT0_GPI1 —** Pin input 1 to SCTimer/PWM.
PIO2_0	-	R11	N6	Z	I/O	0	**PIO2_0 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[0] —** SD/MMC0 interface data 0.
					I	2	**SCT0_GPI2 —** Pin input 2 to SCTimer/PWM.
PIO2_1	-	T11	K6	Z	I/O	0	**PIO2_1 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[1] —** SD/MMC0 interface data 1.
					I	2	**SCT0_GPI3 —** Pin input 3 to SCTimer/PWM.
PIO2_2	-	U11	P6	Z	I/O	0	**PIO2_2 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[2] —** SD/MMC0 interface data 2.
					O	2	**SCT0_OUT0 —** SCTimer/PWM output 0.
PIO2_3	-	T12	M5	Z	I/O	0	**PIO2_3 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[3] —** SD/MMC0 interface data 3.
					O	2	**SCT0_OUT1 —** SCTimer/PWM output 1.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO2_4	-	T13	N5	Z	I/O	0	**PIO2_4 —** General-purpose digital input/output pin.
					I	1	**SD0_WR_PRT —** SD/MMC 0 write protect.
					O	2	**SCT0_OUT2 —** SCTimer/PWM output 2.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I	5	**SD0_DS —** Read data strobe from SD/MMC0 device.
PIO2_5	-	U13	M4	Z	I/O	0	**PIO2_5 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[4] —** SD/MMC0 interface data 4.
					O	2	**SCT0_OUT3 —** SCTimer/PWM output 3.
						3	**R —** Reserved.
PIO2_6	-	U15	P4	Z	I/O	0	**PIO2_6 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[5] —** SD/MMC0 interface data 5.
					I	2	**SCT0_GPI4 —** Pin input 4 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER1_MAT0 —** 32-bit CTimer1 match output 0.
PIO2_7	-	U16	N4	Z	I/O	0	**PIO2_7 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[6] —** SD/MMC0 interface data 6.
					I	2	**SCT0_GPI5 —** Pin input 5 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER1_MAT1 —** 32-bit CTimer1 match output 1.
PIO2_8	-	U17	M1	Z	I/O	0	**PIO2_8 —** General-purpose digital input/output pin.
					I/O	1	**SD0_D[7] —** SD/MMC0 interface data 7.
					O	2	**SCT0_OUT4 —** SCTimer/PWM output 4.
						3	**R —** Reserved.
					O	4	**CTIMER1_MAT2 —** 32-bit CTimer1 match output 2.
PIO2_9	-	R13	M2	Z	I/O	0	**PIO2_9 —** General-purpose digital input/output pin.
					I	1	**SD0_CARD_DET_N —** SD/MMC 0 card detect (active low).
					O	2	**SCT0_OUT5 —** SCTimer/PWM output 5.
						3	**R —** Reserved.
					O	4	**CTIMER1_MAT3 —** 32-bit CTimer1 match output 3.
PIO2_10	-	T15	M3	Z	I/O	0	**PIO2_10 —** General-purpose digital input/output pin.
					O	1	**SD0_RESET_N —** SD/MMC0 card hardware reset, active low.
					I	2	**SCT0_GPI6 —** Pin input 6 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT0 —** 32-bit CTimer2 match output 0.

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Table 4.   **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO2_11	-	T16	N3	Z	I/O	0	**PIO2_11 —** General-purpose digital input/output pin.
					O	1	**SD0_VOLT —** SD/MMC0 card regulator voltage control.
					I	2	**SCT0_GPI7 —** Pin input 7 to SCTimer/PWM.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT1 —** 32-bit CTimer2 match output 1.
PIO2_12	-	T3	T14	Z	I/O	0	**PIO2_12 —** General-purpose digital input/output pin.
						1	**R —** Reserved.
					O	2	**SCT0_OUT6 —** SCTimer/PWM output 6.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT2 —** 32-bit CTimer2 match output 2.
PIO2_13	-	T1	N15	Z	I/O	0	**PIO2_13 —** General-purpose digital input/output pin.
						1	**R —** Reserved.
					O	2	**SCT0_OUT7 —** SCTimer/PWM output 7.
						3	**R —** Reserved.
					O	4	**CTIMER2_MAT3 —** 32-bit CTimer2 match output 3.
						5	**R —** Reserved.
						6	**R —** Reserved.
					O	7	**CMP0_OUT —** Analog comparator 0 output.
PIO2_14/ CMP0_A	G5	C1	F14	Z	I/O; AI	0	**PIO2_14/CMP0_A —** General-purpose digital input/output pin. Analog comparator input A if the DIGIMODE bit is set to 0 and ANAMODE is set to 1 in the IOCON register for this pin.
						1	**R —** Reserved.
					O	2	**SCT0_OUT8 —** SCTimer/PWM output 8.
						3	**R —** Reserved.
					I	4	**CTIMER_INP1 —** Capture input 1 to CTIMER input muxes.
PIO2_15/ CMP0_D	H4	E2	F13	Z	I/O; AI	0	**PIO2_15/CMP0_D —** General-purpose digital input/output pin. Analog comparator input D if the DIGIMODE bit is set to 0 and ANAMODE is set to 1 in the IOCON register for this pin.
						1	**R —** Reserved.
					O	2	**SCT0_OUT9 —** SCTimer/PWM output 9.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
						6	**R —** Reserved.
					I	7	**CLKIN —** Clock input.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO2_16	B3	R1	P16	Z	I/O	0	**PIO2_16 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK01 —** PDM clock output for DMIC channels 0 and 1.
						2	**R —** Reserved.
						3	**R —** Reserved.
PIO2_17	C4	U1	R16	Z	I/O	0	**PIO2_17 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK23 —** PDM clock output for DMIC channels 2 and 3.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA4 —** Data bit 4 for the FlexSPI B interface.
PIO2_18	B1	R2	P15	Z	I/O	0	**PIO2_18 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK45 —** PDM clock output for DMIC channels 4 and 5.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA5 —** Data bit 5 for the FlexSPI B interface.
PIO2_19	A2	T2	N14	Z	I/O	0	**PIO2_19 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK67 —** PDM clock output for DMIC channels 6 and 7.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					O	6	**FLEXSPI0B_SS0_N —** Active low slave select 0 for the FlexSPI B interface.
PIO2_20	C5	U2	N13	Z	I/O	0	**PIO2_20 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA01 —** PDM data input for DMIC channels 0 and 1.
						2	**R —** Reserved.
						3	**R —** Reserved.

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Table 4.   Pin description *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO2_21	A3	R3	P13	Z	I/O	0	**PIO2_21 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA23 —** PDM data input for DMIC channels 2 and 3.
						2	**R —** Reserved.
						3	**R —** Reserved.
					I	4	**CTIMER_INP14 —** Capture input 14 to CTIMER input muxes.
						5	**R —** Reserved.
					O	6	**FLEXSPI0B_SS1_N —** Active low slave select 1 for the FlexSPI B interface.
PIO2_22	-	P3	P14	Z	I/O	0	**PIO2_22 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA45 —** PDM data input for DMIC channels 4 and 5.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA6 —** Data bit 6 for the FlexSPI B interface.
PIO2_23	-	P5	R14	Z	I/O	0	**PIO2_23 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA67 —** PDM data input for DMIC channels 6 and 7.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					I/O	6	**FLEXSPI0B_DATA7 —** Data bit 7 for the FlexSPI B interface.
PIO2_24	-	L16	G2	Z	I/O	0	**PIO2_24 —** General-purpose digital input/output pin.
					O	1	**SWO —** Serial Wire Debug trace output.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					O	6	**GPIO_INT_BMAT —** Output of the pin interrupt pattern match engine.
PIO2_25	D8	L17	F1	Z	I/O	0	**PIO2_25 —** General-purpose digital input/output pin.
					O	1	**SWCLK —** Serial Wire Debug clock. This is the default function after booting. Since the internal pull-ups are disabled by default, connect external pull-up or pull-down resistor (~10 Kohm) on SWCLK pin to comply with the ARM SWD interface spec.

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Table 4.   **Pin description** …continued

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO2_26	D10	L15	H2	Z	I/O	0	**PIO2_26 —** General-purpose digital input/output pin.
					I/O	1	**SWDIO —** Serial Wire Debug I/O. This is the default function after booting. Since the internal pull-ups are disabled by default, connect external pull-up resistor (~10 Kohm) on SWDIO pin to comply with the ARM SWD interface spec.
PIO2_27	D9	M14	H1	Z	I/O	0	**PIO2_27 —** General-purpose digital input/output pin.
					I	1	**USB1_OVERCURRENTN —** USB1 bus overcurrent indicator (active low). USB host only function. Port power fault signal indicating over-current condition. This signal monitors over-current on the USB bus (external circuitry required to detect over-current condition, active LOW)
PIO2_28	C8	N15	K2	Z	I/O	0	**PIO2_28 —** General-purpose digital input/output pin.
					O	1	**USB1_PORTPWRN —** USB1 VBUS drive enable (Indicates VBUS must supplied in host mode).
PIO2_29	C11	N17	L2	Z	I/O	0	**PIO2_29 —** General-purpose digital input/output pin.
					I/O	1	**I3C0_SCL —** Clock for I3C master or slave.
					O	2	**SCT0_OUT0 —** SCTimer/PWM output 0.
						3	**R —** Reserved.
						4	**R —** Reserved.
					O	5	**CLKOUT —** Output of the CLKOUT function.
PIO2_30	C9	P16	K1	Z	I/O	0	**PIO2_30 —** General-purpose digital input/output pin.
					I/O	1	**I3C0_SDA —** Data for I3C master or slave.
					O	2	**SCT0_OUT3 —** SCTimer/PWM output 3.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I	5	**CLKIN —** Clock input.
						6	**R —** Reserved.
					O	7	**CMP0_OUT —** Analog comparator 0 output.

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Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO2_31/ CMP0_B	J7	B6	C12	Z	I/O; AI	0	**PIO2_31/CMP0_B —** General-purpose digital input/output pin. Analog comparator input B if the DIGIMODE bit is set to 0 and ANAMODE is set to 1 in the IOCON register for this pin.
					O	1	**I3C0_PUR —** Pullup resistor control for I3C master. The I3C0_PUR function controls the SDA pull-up. It is intended to be connected to one end of an external low-value pull-up resistor (e.g. 1KOhm), with the other end connected to the SDA line. If there is no external high weak bus keeper on SDA, then add an additional external weak (e.g. 100KR or even 500KR) always-on pull-up on this line.
					O	2	**SCT0_OUT7 —** SCTimer/PWM output 7.
					I	3	**UTICK_CAP3 —** Micro-tick timer capture input 3.
					I	4	**CTIMER_INP15 —** Capture input 15 to CTIMER input muxes.
					O	5	**SWO —** Serial Wire Debug trace output.
PIO3_0	-	-	D14	Z	I/O	0	**PIO3_0 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK01 —** PDM clock output for DMIC channels 0 and 1.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**FC0_SCK —** Flexcomm 0: USART, SPI, or I2S clock.
PIO3_1	-	-	D15	Z	I/O	0	**PIO3_1 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK23 —** PDM clock output for DMIC channels 2 and 3.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC0_TXD_SCL_MISO_WS —** Flexcomm 0: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
PIO3_2	-	-	D16	Z	I/O	0	**PIO3_2 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK45 —** PDM clock output for DMIC channels 4 and 5.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC0_RXD_SDA_MOSI_DATA —** Flexcomm 0: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O

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Table 4.   Pin description …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO3_3	-	-	D17	Z	I/O	0	**PIO3_3 —** General-purpose digital input/output pin.
					O	1	**PDM_CLK67 —** PDM clock output for DMIC channels 6 and 7.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC0_CTS_SDA_SSEL0 —** Flexcomm 0: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
						6	**R —** Reserved.
					O	7	**CMP0_OUT —** Analog comparator 0 output.
PIO3_4	-	-	C16	Z	I/O	0	**PIO3_4 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA01 —** PDM data input for DMIC channels 0 and 1.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC0_RTS_SCL_SSEL1 —** Flexcomm 0: USART request-to-send, I2C clock, SPI slave select 1.
PIO3_5	-	-	C14	Z	I/O	0	**PIO3_5 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA23 —** PDM data input for DMIC channels 2 and 3.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC0_SSEL2 —** Flexcomm 0: SPI slave select 2.
PIO3_6	-	-	C13	Z	I/O	0	**PIO3_6 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA45 —** PDM data input for DMIC channels 4 and 5.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC0_SSEL3 —** Flexcomm 0: SPI slave select 3.
PIO3_7	-	-	E10	Z	I/O	0	**PIO3_7 —** General-purpose digital input/output pin.
					I	1	**PDM_DATA67 —** PDM data input for DMIC channels 6 and 7.

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Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO3_8	-	-	C10	Z	I/O	0	**PIO3_8 —** General-purpose digital input/output pin.
					O	1	**SD1_CLK —** SD/MMC1 clock.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER0_MAT0 —** 32-bit CTimer0 match output 0.
PIO3_9	-	-	B10	Z	I/O	0	**PIO3_9 —** General-purpose digital input/output pin.
					I/O	1	**SD1_CMD —** SD/MMC1 card command I/O.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER0_MAT1 —** 32-bit CTimer0 match output 1.
PIO3_10	-	-	C9	Z	I/O	0	**PIO3_10 —** General-purpose digital input/output pin.
					I/O	1	**SD1_D[0] —** SD/MMC1 interface data 0.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER0_MAT2 —** 32-bit CTimer0 match output 2.
PIO3_11	-	-	D9	Z	I/O	0	**PIO3_11 —** General-purpose digital input/output pin.
					I/O	1	**SD1_D[1] —** SD/MMC1 interface data 1.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER0_MAT3 —** 32-bit CTimer0 match output 3.
PIO3_12	-	-	C8	Z	I/O	0	**PIO3_12 —** General-purpose digital input/output pin.
					I/O	1	**SD1_D[2] —** SD/MMC1 interface data 2.
						2	**R —** Reserved.
						3	**R —** Reserved.
					I	4	**CTIMER_INP0 —** Capture input 0 to CTIMER input muxes.
PIO3_13	-	-	D5	Z	I/O	0	**PIO3_13 —** General-purpose digital input/output pin.
					I/O	1	**SD1_D[3] —** SD/MMC1 interface data 3.
						2	**R —** Reserved.
						3	**R —** Reserved.
					I	4	**CTIMER_INP1 —** Capture input 1 to CTIMER input muxes.
PIO3_14	-	-	D10	Z	I/O	0	**PIO3_14 —** General-purpose digital input/output pin.
					I	1	**SD1_WR_PRT —** SD/MMC 1 write protect.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER3_MAT0 —** 32-bit CTimer3 match output 0.

Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP		Reset state [1]	Type	Function #	Description
PIO3_15	-	-	E9		Z	I/O	0	**PIO3_15 —** General-purpose digital input/output pin.
						I/O	1	**SD1_D[4] —** SD/MMC1 interface data 4.
							2	**R —** Reserved.
							3	**R —** Reserved.
						O	4	**CTIMER3_MAT1 —** 32-bit CTimer3 match output 1.
						I/O	5	**FC5_SCK —** Flexcomm 5: USART, SPI, or I2S clock.
PIO3_16	-	-	E6		Z	I/O	0	**PIO3_16 —** General-purpose digital input/output pin.
						I/O	1	**SD1_D[5] —** SD/MMC1 interface data 5.
							2	**R —** Reserved.
							3	**R —** Reserved.
						O	4	**CTIMER3_MAT2 —** 32-bit CTimer3 match output 2.
						I/O	5	**FC5_TXD_SCL_MISO_WS —** Flexcomm 5: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
PIO3_17	-	-	E5		Z	I/O	0	**PIO3_17 —** General-purpose digital input/output pin.
						I/O	1	**SD1_D[6] —** SD/MMC1 interface data 6.
							2	**R —** Reserved.
							3	**R —** Reserved.
						O	4	**CTIMER3_MAT3 —** 32-bit CTimer3 match output 3.
						I/O	5	**FC5_RXD_SDA_MOSI_DATA —** Flexcomm 5: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O
PIO3_18	-	-	D1		Z	I/O	0	**PIO3_18 —** General-purpose digital input/output pin.
						I/O	1	**SD1_D[7] —** SD/MMC1 interface data 7.
							2	**R —** Reserved.
							3	**R —** Reserved.
						O	4	**CTIMER4_MAT0 —** 32-bit CTimer4 match output 0.
						I/O	5	**FC5_CTS_SDA_SSEL0 —** Flexcomm 5: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
PIO3_19	-	-	D2		Z	I/O	0	**PIO3_19 —** General-purpose digital input/output pin.
						I	1	**SD1_CARD_DET_N —** SD/MMC 1 card detect (active low).
							2	**R —** Reserved.
							3	**R —** Reserved.
						O	4	**CTIMER4_MAT1 —** 32-bit CTimer4 match output 1.
						I/O	5	**MCLK —** MCLK input or output for I2S and/or digital microphone.

Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO3_20	-	-	C2	Z	I/O	0	**PIO3_20 —** General-purpose digital input/output pin.
					O	1	**SD1_RESET_N —** SD/MMC1 card hardware reset, active low.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT2 —** 32-bit CTimer4 match output 2.
PIO3_21	-	-	D8	Z	I/O	0	**PIO3_21 —** General-purpose digital input/output pin.
					O	1	**SD1_VOLT —** SD/MMC1 card regulator voltage control.
						2	**R —** Reserved.
						3	**R —** Reserved.
					O	4	**CTIMER4_MAT3 —** 32-bit CTimer4 match output 3.
						5	**R —** Reserved.
					O	6	**GPIO_INT_BMAT —** Output of the pin interrupt pattern match engine.
PIO3_22	-	-	D6	Z	I/O	0	**PIO3_22 —** General-purpose digital input/output pin.
						1	**R —** Reserved.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC5_RTS_SCL_SSEL1 —** Flexcomm 5: USART request-to-send, I2C clock, SPI slave select 1.
PIO3_23/ CH5A	-	-	H12	Z	I/O	0	**PIO3_23/CH5A —** General-purpose digital input/output pin. Analog input 5A. Can optionally be paired with CH5B for differential input on ADC channel 5.
						1	**R —** Reserved.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC5_SSEL2 —** Flexcomm 5: SPI slave select 2.
PIO3_24/ CH5B	-	-	E15	Z	I/O	0	**PIO3_24/CH5B —** General-purpose digital input/output pin. Analog input 5B. Can optionally be paired with CH5A for differential input on ADC channel 5.
						1	**R —** Reserved.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC5_SSEL3 —** Flexcomm 5: SPI slave select 3.
PIO3_25	-	-	R9	Z	I/O	0	**PIO3_25 —** General-purpose digital input/output pin.
					I/O	1	**FC6_SCK —** Flexcomm 6: USART, SPI, or I2S clock.

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Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP		Reset state [1]	Type	Function #	Description
PIO3_26	A8	-	P9		Z	I/O	0	**PIO3_26 —** General-purpose digital input/output pin.
						I/O	1	**FC6_TXD_SCL_MISO_WS —** Flexcomm 6: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
PIO3_27	A7	-	T8		Z	I/O	0	**PIO3_27 —** General-purpose digital input/output pin.
						I/O	1	**FC6_RXD_SDA_MOSI_DATA —** Flexcomm 6: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O
PIO3_28	-	-	R8		Z	I/O	0	**PIO3_28 —** General-purpose digital input/output pin.
						I/O	1	**FC6_CTS_SDA_SSEL0 —** Flexcomm 6: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
PIO3_29	-	-	P8		Z	I/O	0	**PIO3_29 —** General-purpose digital input/output pin.
						I/O	1	**FC6_RTS_SCL_SSEL1 —** Flexcomm 6: USART request-to-send, I2C clock, SPI slave select 1.
PIO3_30	-	-	N9		Z	I/O	0	**PIO3_30 —** General-purpose digital input/output pin.
						I/O	1	**FC6_SSEL2 —** Flexcomm 6: SPI slave select 2.
PIO3_31	-	-	P7		Z	I/O	0	**PIO3_31 —** General-purpose digital input/output pin.
						I/O	1	**FC6_SSEL3 —** Flexcomm 6: SPI slave select 3.
PIO4_0	-	-	R13		Z	I/O	0	**PIO4_0 —** General-purpose digital input/output pin.
						I/O	1	**FC7_SCK —** Flexcomm 7: USART, SPI, or I2S clock.
							2	**R —** Reserved.
							3	**R —** Reserved.
						I	4	**FREQME_GPIO_CLK —** Frequency Measure pin clock input.
							5	**R —** Reserved.
							6	**R —** Reserved.
						O	7	**CLKOUT —** Output of the CLKOUT function.
PIO4_1	-	-	T17		Z	I/O	0	**PIO4_1 —** General-purpose digital input/output pin.
						I/O	1	**FC7_TXD_SCL_MISO_WS —** Flexcomm 7: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
							2	**R —** Reserved.
							3	**R —** Reserved.
							4	**R —** Reserved.
							5	**R —** Reserved.
							6	**R —** Reserved.
						I	7	**CLKIN —** Clock input.

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Table 4. **Pin description** …continued

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO4_2	-	-	T16	Z	I/O	0	**PIO4_2 —** General-purpose digital input/output pin.
					I/O	1	**FC7_RXD_SDA_MOSI_DATA —** Flexcomm 7: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
PIO4_3	-	-	T3	Z	I/O	0	**PIO4_3 —** General-purpose digital input/output pin.
					I/O	1	**FC7_CTS_SDA_SSEL0 —** Flexcomm 7: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
PIO4_4	-	-	R2	Z	I/O	0	**PIO4_4 —** General-purpose digital input/output pin.
					I/O	1	**FC7_RTS_SCL_SSEL1 —** Flexcomm 7: USART request-to-send, I2C clock, SPI slave select 1.
PIO4_5	-	-	P1	Z	I/O	0	**PIO4_5 —** General-purpose digital input/output pin.
					I/O	1	**FC7_SSEL2 —** Flexcomm 7: SPI slave select 2.
PIO4_6	-	-	P2	Z	I/O	0	**PIO4_6 —** General-purpose digital input/output pin.
					I/O	1	**FC7_SSEL3 —** Flexcomm 7: SPI slave select 3.
PIO4_7	-	-	P3	Z	I/O	0	**PIO4_7 —** General-purpose digital input/output pin.
					I/O	1	**MCLK —** MCLK input or output for I2S and/or digital microphone.
PIO4_8	-	-	R4	Z	I/O	0	**PIO4_8 —** General-purpose digital input/output pin.
						1	**R —** Reserved.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC2_CTS_SDA_SSEL0 —** Flexcomm 2: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
						6	**R —** Reserved.
					O	7	**CMP0_OUT —** Analog comparator 0 output.
PIO4_9	-	-	R5	Z	I/O	0	**PIO4_9 —** General-purpose digital input/output pin.
						1	**R —** Reserved.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
						5	**R —** Reserved.
					O	6	**GPIO_INT_BMAT —** Output of the pin interrupt pattern match engine.
PIO4_10	-	-	R6	Z	I/O	0	**PIO4_10 —** General-purpose digital input/output pin.

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Table 4.   **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO7_24	-	-	T15	Z	I/O	0	**PIO7_24 —** General-purpose digital input/output pin.
						1	**R —** Reserved.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC2_SCK —** Flexcomm 2: USART, SPI, or I2S clock.
						6	**R —** Reserved.
PIO7_25	-	-	P12	Z	I/O	0	**PIO7_25 —** General-purpose digital input/output pin.
					I/O	1	**FC1_SCK —** Flexcomm 1: USART, SPI, or I2S clock.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**R —** Reserved.
						6	**R —** Reserved.
PIO7_26	-	-	N12	Z	I/O	0	**PIO7_26 —** General-purpose digital input/output pin.
					I/O	1	**FC1_TXD_SCL_MISO_WS —** Flexcomm 1: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**R —** Reserved.
						6	**R —** Reserved.
PIO7_27	-	-	R12	Z	I/O	0	**PIO7_27 —** General-purpose digital input/output pin.
					I/O	1	**FC1_RXD_SDA_MOSI_DATA —** Flexcomm 1: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**R —** Reserved.
						6	**R —** Reserved.

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Table 4.   **Pin description** …continued

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PIO7_28	-	-	N10	Z	I/O	0	**PIO7_28 —** General-purpose digital input/output pin.
					I/O	1	**FC1_CTS_SDA_SSEL0 —** Flexcomm 1: USART clear-to-send, I2C data I/O, SPI Slave Select 0.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**R —** Reserved.
						6	**R —** Reserved.
PIO7_29	-	-	R10	Z	I/O	0	**PIO7_29 —** General-purpose digital input/output pin.
					I/O	1	**FC1_RTS_SCL_SSEL1 —** Flexcomm 1: USART request-to-send, I2C clock, SPI slave select 1.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**R —** Reserved.
						6	**R —** Reserved.
PIO7_30	-	-	P10	Z	I/O	0	**PIO7_30 —** General-purpose digital input/output pin.
					I/O	1	**FC1_SSEL2 —** Flexcomm 1: SPI slave select 2.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC2_TXD_SCL_MISO_WS —** Flexcomm 2: USART transmitter, I2C clock, SPI master-in/slave-out data I/O, I2S word select/frame.
						6	**R —** Reserved.
PIO7_31	-	-	T4	Z	I/O	0	**PIO7_31 —** General-purpose digital input/output pin.
					I/O	1	**FC1_SSEL3 —** Flexcomm 1: SPI slave select 3.
						2	**R —** Reserved.
						3	**R —** Reserved.
						4	**R —** Reserved.
					I/O	5	**FC2_RXD_SDA_MOSI_DATA —** Flexcomm 2: USART receiver, I2C data I/O, SPI master-out/slave-in data, I2S data I/O.
						6	**R —** Reserved.
PMIC_I2C_SCL	-	E16	F4	[2]	Z	O	-	I2C clock. Used for communication with an off-chip PMIC, if present. It is not an open drain pin.
PMIC_I2C_SDA	-	F16	F3	[2]	Z	I/O	-	I2C data. Used for communication with an off-chip PMIC, if present. It is not an open drain pin.

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Table 4. **Pin description** …*continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
PMIC_IRQ_N	-	A15	F5	[2]	Z	I	-	Interrupt input, active low logic. Used with an off-chip PMIC, if present.
PMIC_MODE0	-	C15	D3	[2]	O	O	-	Power mode control output to an off-chip PMIC, if present. Value is controlled by the PDRUNCFG and PDSLEEPCFG registers. Reset state is 0.
PMIC_MODE1	-	B16	E4	[2]	O	O	-	Power mode control output to an off-chip PMIC, if present. Value is controlled by the PDRUNCFG and PDSLEEPCFG registers. Reset state is 0.
RESETN	K10	B15	C4		-	I	-	External reset input: A LOW on this pin resets the device, causing I/O ports and peripherals to take on their default states, and the boot code to execute. Wakes up the part from deep power-down mode. Minimum reset pulse width is 4ns.
RTCXIN	-	B17	A2		-	-	-	RTC oscillator input. Selectable on-chip crystal load capacitors are available for RTC oscillator. Please refer to UM for further details.
RTCXOUT	-	A17	B3		-	-	-	RTC oscillator input. Selectable on-chip crystal load capacitors are available for RTC oscillator. Please refer to UM for further details.
USB1_DM	B9	T17	T1		-	I/O	-	USB1 bidirectional D- line.
USB1_DP	B10	R17	U2		-	I/O	-	USB1 bidirectional D+ line.
USB1_VBUS	[4]	R16	T2		-	I	-	VBUS pin (power on USB cable). 5 V tolerant pin when supplies are present or when not present.
USB1_VDD3V3	C10	N16	K5	[3]	-	-	-	USB1 analog 3.3 V supply.
LDO_ENABLE	H9	A16	C5		-	-	-	When 1, enables the on-chip regulator to power core logic through the VDDCORE pins. Tie low if an off-chip power management IC (PMIC) is used to supply power to core logic. This pin can not be left floating. 100K external pull-up or 10K external pull-down is recommended. LDO_Enable is a fail-safe pin. It must be driven high before VDD_AO1V8 supply comes up or at the same time.
VDD_AO1V8	L11	C13; D13	B2; D4	[3]	-	-	-	Supply 1.8 V supply for "always on" features. This includes the RTC, RESETN, LDO_ENABLE, PMIC_IRQ_N, PMIC_MODE0, and PMIC_MODE1. See Table 5
VDDIO_0	B8; D7; E7; F2; G3; J2	F5; H5; K5; M5; N6; N8; N10	J12; J13; K12; M10; M12; M9	[3]	-	-	-	Single 1.8 V to 3.3 V power supply for GPIOs defined as belonging to the VDDIO_0 group. VDDIO_0, VDDIO_1, and VDDIO_2 may be supplied at different voltage levels as needed by the application. VDDIO_0 supplies the following port pins: PIO0_0 to PIO0_13; PIO1_11 to PIO1_29; and PIO2_12 to PIO2_23. See Table 5

Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
VDDIO_1	E9; J8; L2	E6; E8; E10; H13; H14; K13; L14	F10; F11; F6; F7; F9; J5; J6	[3]	-	-	-	Single 1.8 V to 3.3 V power supply for GPIOs defined as belonging to the VDDIO_1 group. VDDIO_0, VDDIO_1, and VDDIO_2 may be supplied at different voltage levels as needed by the application. VDDIO_1 supplies the following port pins: PIO0_14 to PIO0_31; PIO1_0 to PIO1_10; PIO2_24 to PIO2_31; PMIC_I2C_SCL and PMIC_I2C_SDA. See Table 5
VDDIO_2	-	N12; P11; P12	M7; M8	[3]	-	-	-	Single 1.8 V to 3.3 V power supply for GPIOs defined as belonging to the VDDIO_2 group. VDDIO_0, VDDIO_1, and VDDIO_2 may be supplied at different voltage levels as needed by the application. VDDIO_2 supplies the following port pins: PIO1_30 to PIO1_31 and PIO2_0 to PIO2_11. See Table 5
VDD1V8	A9; K2; L10; D5; G8; H10; H11; J10	B11; C16; C17; E15; F13; G14; L4; R15	E8; J14; H6; G6; H7; J7; M6	[3]	-	-	-	1.8 V supply voltage for on-chip analog functions other than the ADC and comparator.
VDDA_ADC1V8	[5]	E4	H13	[3]	-	-	-	1.8 V analog supply voltage for ADC and comparator.
VDDA_BIAS	[5]	C4	E12	[3]	-	-	-	Bias for ADC and comparator. VDD_BIAS must be equal to max ADC input voltage or max comparator input voltage.
VDDCORE	A10; C1; E8; F1; F6; F7; G2; G7; G10; G11	C5; D9; F14; J4; J14; P9; R5; R14	G9; H10; H8; H9; J10; J11; J8; J9; K10; K8; K9; L9	[3]	-	-	-	Power supply for core logic. May be supplied from the internal LDO or externally by an off-chip power management IC (PMIC). An external filter capacitor is always required on these pins, see Section 13.2 "Power Sequencing"
VREFN	[5]	C2	G12		-	-	-	ADC negative reference voltage.
VREFP	[5]	D2	F12	[3]	-	-	-	ADC positive reference voltage.
VDD1V8_1	G9	A13	F8	[3]	-	-	-	1.8 V supply voltage for OTP during active mode. In deep-sleep mode, this pin can be powered off to conserve additional current (~ 65 uA). VDD1V8_1 must be stable before performing any OTP related functions.

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Table 4. **Pin description** *…continued*

Symbol	114-pin, WLCSP	176-pin, VFBGA	249-pin, FOWLP	Reset state [1]	Type	Function #	Description
VSS	A1; A6; A11; B6; D6; E6; F8; F11; G6; J9; J11; L1; L7	D5; D15; E12; E14; F7; F11; G6; G12; H8; H9; H10; J8; J10; K8; K9; K10; L6; L12; M7; M11; M13; N14; P13	A1; A17; C11; C15; C3; C7; E11; E7; G10; G11; G13; G14; G15; G3; G4; G5; G7; G8; H11; K11; K4; K7; L10; L11; L12; L13; L14; L15; L3; L4; L5; L6; L7; L8; M11; N11; N7; P11; R11; R15; R3; R7; U1; U17	-	-	-	Ground.
VSSA	[5]	C3, D12	D7; D11	-	-	-	Analog ground.
XTALIN	K9	B14	B4	-	-	-	Main oscillator input. USB ISP can only boot with external crystal oscillator of 24 MHz.
XTALOUT	L9	B13	A4	-	-	-	Main oscillator output. USB ISP can only boot with external crystal oscillator of 24 MHz.

[1] Z = high impedance; pull-up or pull-down disabled. AI = analog input. I = input. O = output. I/O = input/output. Reset state reflects the pin state at reset without boot code operation. For pin states in the different power modes.

[2] These pins are intended for connection to an off-chip power management IC (PMIC) if such a device is used to supply power to core logic to this device. These pins may be used for other purposes if the on-chip regulator is used to supply power to core logic.

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[3]   See Section 13.1 "General operating conditions" for specification of actual allowable voltage ranges.

[4]   On WLCSP114 package, USB ISP mode is not supported. VBUS pin is not available on the WLCSP114 package. To detect VBUS connection, user can connect a GPIO pin to the USB connector's VBUS. When a rising edge occurs on the GPIO pin, software should set bit 10 (FORCE_VBUS) and bit 16 (DCON) in the DEVCMDSTAT register.

[5]   On the WLCSP package, VDDA_ADC1V8 is internally connected to VDD1V8 pin; VDDA_BIAS is internally connected to VDDIO_0; VREFP is internally connected to VDD1V8; VREFN is internally connected to VSS; VSSA is internally connected to VSS.

8. Power Supply for pins

Table 5 shows the GPIOs belonging to the specific VDDIO groups and VDD_AO1V8 domain. Each VDDIO supply pin may be supplied at different voltage levels as needed by the application and can be powered between 1.71 V to 3.6 V.

Table 5.   Power Supply for pins

Pin	GPIO pins
VDDIO_0	PIO0_0 to PIO0_13(Fail Safe Pads)
	PIO1_11 to PIO1_17(Fail Safe Pads)
	PIO1_18 to PIO1_29(High Speed Pads)
	PIO2_12 to PIO2_23(Fail Safe Pads) PIO3_25 to PIO3_31(Fail Safe Pads) PIO4_0 to PIO4_10(Fail Safe Pads) PIO7_24 to PIO7_31(Fail Safe Pads)
VDDIO_1	PIO0_14 to PIO0_31 (Fail Safe Pads)
	PIO1_0 to PIO1_10 (Fail Safe Pads)
	PIO2_24 to PIO2_31 (Fail Safe Pads) PIO3_0 to PIO3_24 (Fail Safe Pads) PMIC_I2C_SCL (Fail Safe Pads) PMIC_I2C_SDA (Fail Safe Pads)
VDDIO_2	PIO1_30 to PIO1_31(High Speed Pads)
	PIO2_0 to PIO2_8(High Speed Pads)
	PIO2_9 to PIO2_11(Fail Safe Pads)
VDD_AO1V8	RESETN (Fail Safe Pad)
	LDO_ENABLE (Fail Safe Pad)
	PMIC_IRQ_N (Fail Safe Pad)
	PMIC_MODE0 and PMIC_MODE1 (Fail Safe Pads)

Note: Please refer to Hardware Development Guide for the RT600 Processor on nxp.com. This guide provides information about board layout recommendations and design checklists to ensure first-pass success and to avoid problems with board bring-up.

9. Termination of unused pins

Table 6 shows how to terminate pins that are **not** used in the application. In many cases, unused pins can be left unconnected since pins are default high Z state.

The internal pull-down can be enabled on the unconnected pins (input buffer disabled by default, internal pull-down enabled) or unconnected can be configured by software (GPIO output low) to minimize the overall power consumption of the part.

Table 6.   Termination of unused pins

Pin	Default state[1]	Recommended termination of unused pins
All PIOn pins	Z	Leave unconnected.
PMIC_I2C_SCL/SDA	Z	Leave unconnected.
PMIC_IRQ_N	I; Z	10 kΩ resistor to VDD_AO1V8.
PMIC_MODEn	O	Leave unconnected.
RESETN	I	100 kΩ resistor to VDD_AO1V8.
RTCXIN	I	Connect to ground.
RTCXOUT	-	Leave unconnected.
USB1_DM/DP	-	Leave unconnected.
USB1_VBUS	-	Leave unconnected.
USB1_VDD3V3	-	Leave unconnected.
VDD_AO1V8	-	Connect to 1.8V power.
VDD_1V8	-	Connect to 1.8V power.
VDD_1V8_1	-	Connect to 1.8V power during active. Can be powered off during deep sleep mode to reduce current consumption by approximately 65 uA.
VDDA_ADC1V8	-	Connect to 1.8V power.
VDDA_BIAS	-	Connect to 1.8 V power.
VREFN	-	Connect to ground.
VREFP	-	Connect to VDDA_ADC1V8
VSSA	-	Connect to ground.
XTALIN	I	Connect to ground.
XTALOUT	-	Leave unconnected.

[1]   Z = Input, pull-up, and pull-down disabled; I = Input; O = Output

9.0.1   Pin states in different power modes

Table 7.   Pin states in different power modes

Pin	Active	Sleep	Deep-sleep	Deep power-down
All PIOn pins	As configured in IOCON[1]. Default is Z (input, pull-up, and pull-down disable)			
PMIC_MODE0/1	00	00		

[1]   Default and programmed pin states are retained in sleep and deep-sleep.

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10. Functional description

10.1 Architectural overview

The ARM Cortex-M33 includes two AHB-Lite buses, the system bus and the C-code bus. The use of two core buses allows for simultaneous operations if concurrent operations target different devices.

A multi-layer AHB matrix connects the CPU buses and other bus masters to peripherals in a flexible manner that optimizes performance by allowing peripherals on different slaves ports of the matrix to be accessed simultaneously by different bus masters. More information on the multilayer matrix can be found in Section 10.12.1. Connections in the multilayer matrix are shown in Figure 3. Note that while the AHB bus itself supports word, halfword, and byte accesses, not all AHB peripherals need or provide that support.

10.2 Arm Cortex-M33 processor

The Cortex-M33 is a general purpose 32-bit microprocessor, which offers high performance and very low power consumption. The Cortex-M33 offers an instruction set based on Thumb®-2, low interrupt latency, interruptible/continuable multiple load and store instructions, automatic state save and restore for interrupts, tightly integrated interrupt controller, multiple core buses capable of simultaneous accesses, and a floating point unit.

The RT600 includes the Armv8-M Security Extension that adds security through code and data protection features.

Information about Cortex-M33 configuration options can be found in the user manual.

10.3 Arm Cortex-M33 integrated Floating Point Unit (FPU)

The FPU fully supports single-precision add, subtract, multiply, divide, multiply and accumulate, and square root operations. It also provides conversions between fixed-point and floating-point data formats, and floating-point constant instructions.

The FPU provides floating-point computation functionality that is compliant with the ANSI/IEEE Std 754-2008, IEEE Standard for Binary Floating-Point Arithmetic, referred to as the IEEE 754 standard.

10.4 Xtensa HiFi 4 advanced Audio Digital Signal Processor

The HiFi 4 Audio Engine is present on selected RT600 devices. The HiFi 4 is a highly optimized audio processor geared for efficient execution of audio and voice codecs and pre- and post-processing modules. It includes support for four 32x32-bit MACs, some support for 72-bit accumulators, limited ability to support eight 32x16-bit MACs, and the ability to issue two 64-bit loads per cycle. There is an floating point unit included, providing up to four single-precision IEEE floating point MACs per cycle. The HiFi 4 Audio Engine is a configuration option of the Xtensa LX6 processor. All HiFi 4 Audio Engine operations can be used as intrinsics in standard C/C++ applications.

Information about HiFi 4 DSP configuration options can be found in the user manual.

10.5 Memory Protection Unit (MPU)

The Cortex-M33 processor has a memory protection unit (MPU) that provides fine grain memory control, enabling applications to implement security privilege levels, separating code, data and stack on a task-by-task basis. Such requirements are critical in many embedded applications.

The MPU allows separating processing tasks by disallowing access to each other's data, disabling access to memory regions, allowing memory regions to be defined as read-only and detecting unexpected memory accesses that could potentially break the system.

The MPU separates the memory into distinct regions and implements protection by preventing disallowed accesses. The MPU supports up to eight regions each of which can be divided into eight subregions. Accesses to memory locations that are not defined in the MPU regions, or not permitted by the region setting, will cause the Memory Management Fault exception to take place.

10.6 Nested Vectored Interrupt Controller (NVIC) for Cortex-M33

The NVIC is an integral part of the Cortex-M33. The tight coupling to the CPU allows for low interrupt latency and efficient processing of late arriving interrupts.

10.6.1 Features

- Controls system exceptions and peripheral interrupts.
- Supports up to 58 vectored interrupts.
- Eight programmable interrupt priority levels, with hardware priority level masking.
- Relocatable vector table.
- Non-Maskable Interrupt (NMI).
- Software interrupt generation.

10.6.2 Interrupt sources

Each peripheral device has one interrupt line connected to the NVIC but may have several interrupt flags.

10.7 System Tick timer (SysTick)

The Arm Cortex-M33 includes a system tick timer (SysTick) that is intended to generate a dedicated SYSTICK exception. The clock source for the SysTick can be the FRO or the Cortex-M33 core clock.

10.8 PowerQuad Hardware Accelerator

The RT600 has a PowerQuad hardware accelerator for CMSIS DSP functions (fixed and floating point unit) with support of SDK software API faster execution of ARM CMSIS instruction set.The PowerQuad is a hardware accelerator targeting common calculations in DSP applications. With the assistance of the PowerQuad, the Cortex-M33 can be freed to perform other tasks. While the PowerQuad is executing the assigned computation task, the CM33 can prepare the next PowerQuad task, resulting in a pipeline of PowerQuad tasks.

10.9 On-chip static RAM

The RT600 supports 5 MB SRAM with separate bus master access for higher throughput and individual power control for low-power operation.

10.10 On-chip ROM

The 128 kB on-chip ROM contains the boot loader and the following Application Programming Interfaces (API):

- In-Application Programming (IAP) and In-System Programming (ISP).
- ROM-based USB drivers (HID, CDC, MSC, and DFU). Supports flash updates via USB. USB ISP mode is not supported in WLCSP114 package.
- Supports booting from valid USART, SPI, I2C, Octal/Quad SPI, HS USB, SD/eMMC.
- Legacy, Single, and Dual image boot.
- OTP API for programming OTP memory.
- Random Number Generator (RNG) API.

10.11 OTP

The RT600 contains up to 16 kB byte of on-time-programmable memory used for part configuration, key storage (as an alternative to PUF) and various other uses. The OTP contains pre-programmed factory configuration data such as on-chip oscillator calibration values, among other things. It may also be used by customer applications to configure some details of device operation, code signature values, aspects of device security, debug options, and boot options

10.12 Memory mapping

The RT600 incorporates several distinct memory regions. The APB peripheral area is 512 kB in size and is divided to allow for up to 64 peripherals.Each peripheral is allocated 4 kB of space simplifying the address decoding. The registers incorporated into the CPU, such as NVIC, SysTick, and sleep mode control, are located on the private peripheral bus.

The Arm Cortex-M33 processor has a single 4 GB address space.

10.12.1 AHB multilayer matrix

The RT600 uses a multi-layer AHB matrix to connect the CPU buses and other bus masters to peripherals in a flexible manner that optimizes performance by allowing peripherals that are on different slave ports of the matrix to be accessed simultaneously by different bus masters. Figure 4 shows details of the available matrix connections.

Remark: Attempted accesses by the CM33 to unused spaces between assigned memory and peripheral spaces generally cause an exception. For the HiFi4 this is not the case.

10.12.2 Memory Protection Unit (MPU)

The Cortex-M33 processor has a memory protection unit (MPU) that provides fine grain memory control, enabling applications to implement security privilege levels, separating code, data and stack on a task-by-task basis. Such requirements are critical in many embedded applications.

The MPU register interface is located on the private peripheral bus and is described in detail in Cortex-M33 DGUG — ARM Cortex-M33 Devices Generic User Guide

10.12.3 TrustZone and Cortex-M33 busing on this device

The implementation of ARM TrustZone on this device involves using address bit 28 to divide the address space into potential secure and non-secure regions. Address bit 28 is not decoded in memory access hardware, so each physical location appears in two places on whatever bus they are located on. Other hardware determines which kinds of accesses (including non-secure callable) are actually allowed for any particular address.

In addition, the shared RAM is generally expected to be used for both code and data, in different balance for different applications. Some applications may require a great deal of code and little data, others may require most of the shared RAM to be used for data. For this reason, the entire shared RAM appears on both the code bus and the data bus of the Cortex-M33. Code can be located at addresses that are on the code bus, data can be located at addresses that are on the data bus. As long as code and data are contained in shared RAM that is connected on different AHB matrix slave ports, each can be accessed simultaneously on the appropriate bus.

Table 8 shows the overall mapping of the code and data buses for secure and non-secure accesses to various device resources. The block diagrams in Figure 3 "Block diagram overview" may also be useful in understanding the memory map.

In addition to the fixed mapping of secure and non-secure spaces, "checker" hardware present on all AHB matrix ports confirms the types of access allowed for each peripheral or memory range (with a granularity of 32 memory ranges for each port). This is described in more detail in RT6xx User Manual (please see RT6xx Trusted execution environment chapter)

Remark: In the peripheral description chapters of this manual, only the native (non-secure) base address is noted, secure base addresses can be found in this chapter or created algorithmically where needed.

Table 8. TrustZone and Cortex-M33 general mapping

Start address	End address	TrustZone	CM-33 bus	CM-33 usage
0x0000 0000	0x0FFF FFFF	Non-secure	Code	Shared RAM, Boot ROM, OSPI memory mapped region.
0x1000 0000	0x1FFF FFFF	Secure	Code	Same as above
0x2000 0000	0x2FFF FFFF	Non-secure	Data	Shared RAM, CM33 access to HiFi 4 TCMs via inbound PIF. Non-cacheable FlexSPI memory mapped region for DSP only.
0x3000 0000	0x3FFF FFFF	Secure	Data	Same as above
0x4000 0000	0x4FFF FFFF	Non-secure	Data	AHB and APB peripherals.
0x5000 0000	0x5FFF FFFF	Secure	Data	Same as above

[1] The HiFi 4 accesses shared RAM via a separate connection, not using the AHB matrix.

[2] The size shown for peripherals spaces indicates the space allocated in the memory map, not the actual space used by the peripheral.

[3] Some AHB and APB peripherals are not accessible to the HiFi 4.

[4] Selected areas of secure regions may be marked as non-secure callable.

10.12.4 Links to specific memory map descriptions and tables:

- Section 10.12.5 "Device overview"

- [Section 10.12.6 "Cortex-M33 Memory overview"](#)
- [Section 10.12.7 "Shared RAM detail"](#)
- [Section 10.12.8 "APB peripherals"](#)
- [Section 10.12.9 "AHB peripherals"](#)
- [Section 10.12.10 "HiFi 4 memory map"](#)

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10.12.5 Device overview

The RT600 incorporates several distinct memory regions. Table 9 gives a simplified view of the overall map of the entire address space from the user program viewpoint following reset. The figure indicates the main address regions and how (or whether) they related to both the Cortex-M33 and the HiFi 4.

Table 9.   Device overview memory map

Start addr	End addr	Size	Cortex-M33 function	HiFi 4 function
0x0000 0000	0x0047 FFFF	4.5 MB	Shared RAM via the CM33 code bus (non-secure access). See Section 10.12.7.	Shared RAM - cacheable access. See Section 10.12.10. [1]
0x0300 0000	0x0303 FFFF	256 KB	Boot ROM (non-secure access). See Section 10.12.6	-
0x0800 0000	0x0FFF FFFF	128 MB	FlexSPI memory mapped space with cache and on-the-fly AES decryption (non-secure access). See Section 10.12.6. [2]	FlexSPI memory mapped space, cacheable. See Section 10.12.10. [2]
0x1000 0000	0x1047 FFFF	4.5 MB	Shared RAM via the CM33 code bus (secure access). See Section 10.12.7. [3]	-
0x1300 0000	0x1303 FFFF	256 KB	Boot ROM (secure access). See Section 10.12.6	-
0x1800 0000	0x1FFF FFFF	128 MB	FlexSPI memory mapped space with cache and on-the-fly AES decryption (secure access). See Section 10.12.6.	-
0x2000 0000	0x2047 FFFF	4.5 MB	Shared RAM via the CM33 data bus (non-secure access). See Section 10.12.7.	Shared RAM - non-cacheable access. See Section 10.12.10. [1]
0x2400 0000	0x2400 FFFF	64 KB	Cortex-M33 access to HiFi 4 data TCM via inbound PIF (non-secure access). See Section 10.12.6.	HiFi 4 data TCM - 4 interleaved banks. See Section 10.12.10.
0x2402 0000	0x2402 FFFF	64 KB	Cortex-M33 access to HiFi 4 instruction TCM via inbound PIF (non-secure access). See Section 10.12.6.	HiFi 4 instruction TCM. See Section 10.12.10.
0x2800 0000	0x2FFF FFFF	128 MB	-	FlexSPI memory mapped space, non-cacheable. See Section 10.12.10. [2]
0x3000 0000	0x3047 FFFF	4.5 MB	Shared RAM via the CM33 data bus (secure access). See Section 10.12.7. [3]	-
0x3400 0000	0x3400 FFFF	64 KB	Cortex-M33 access to HiFi 4 data TCM via inbound PIF (secure access). See Section 10.12.6.	-
0x3402 0000	0x3402 FFFF	64 KB	Cortex-M33 access to HiFi 4 instruction TCM via inbound PIF (secure access). See Section 10.12.6.	HiFi 4 instruction TCM. See Section 10.12.10.
0x4000 0000	0x4003 FFFF	256 KB [4]	APB peripherals (non-secure access). See Section 10.12.8.	APB peripherals. See Section 10.12.10. [5]
0x4010 0000	0x4015 FFFF	400 KB [4]	AHB peripherals (non-secure access). See Section 10.12.9.	AHB peripherals. See Section 10.12.10. [5]
0x5000 0000	0x5003 FFFF	256 KB [4]	APB peripherals (secure access). See Section 10.12.8.	-
0x5010 0000	0x5015 FFFF	400 KB [4]	AHB peripherals (secure access). See Section 10.12.9.	-

[1]   The HiFi 4 accesses shared RAM via a separate connection, not using the AHB matrix.

[2]   Access to the FlexSPI memory space can be enabled or disabled for the CM33 and the HiFi 4.

[3]   Selected areas of secure regions may be marked as non-secure callable.

[4]   The size shown for peripheral spaces indicates the space allocated in the memory map, not the actual space used by the peripheral.

[5]   Some AHB and APB peripherals are not accessible to the HiFi 4.

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10.12.6 Cortex-M33 Memory overview

Table 10 gives a more detailed memory map as seen by the Cortex-M33. The purpose of the four address spaces for the shared RAMs is outlined at the beginning of this chapter. The details of which shared RAM regions are on which AHB matrix slave ports can be seen here. Further details given in Section 10.12.6.

Table 10.   Cortex-M33 overview memory map

AHB port	Non-secure start address	Non-secure end address	Secure start address	Secure end address	Function [1]
2	0x0000 0000	0x0000 FFFF	0x1000 0000	0x1000 FFFF	Shared RAM on CM33 code bus, partitions 0 to 1.
3	0x0001 0000	0x0001 FFFF	0x1001 0000	0x1001 FFFF	Shared RAM on CM33 code bus, partitions 2 to 3.
4	0x0002 0000	0x0003 FFFF	0x1002 0000	0x1003 FFFF	Shared RAM on CM33 code bus, partitions 4 to 7.
5	0x0004 0000	0x0007 FFFF	0x1004 0000	0x1007 FFFF	Shared RAM on CM33 code bus, partitions 8 to 11.
6	0x0008 0000	0x000F FFFF	0x1008 0000	0x100F FFFF	Shared RAM on CM33 code bus, partitions 12 to 15.
7	0x0010 0000	0x001F FFFF	0x1010 0000	0x101F FFFF	Shared RAM on CM33 code bus, partitions 16 to 19.
8	0x0020 0000	0x002F FFFF	0x1020 0000	0x102F FFFF	Shared RAM on CM33 code bus, partitions 20 to 23.
9	0x0030 0000	0x003F FFFF	0x1030 0000	0x103F FFFF	Shared RAM on CM33 code bus, partitions 24 to 27.
10	0x0040 0000	0x0047 FFFF	0x1040 0000	0x1047 FFFF	Shared RAM on CM33 code bus, partitions 28 to 29.
0	0x0300 0000	0x0303 FFFF	0x1300 0000	0x1303 FFFF	Boot ROM
1	0x0800 0000	0x0FFF FFFF	0x1800 0000	0x1FFF FFFF	FlexSPI memory mapped space with cache and on-the-fly AES decryption.
2	0x2000 0000	0x2000 FFFF	0x3000 0000	0x3000 FFFF	Shared RAM on CM33 data bus, partitions 0 to 1.
3	0x2001 0000	0x2001 FFFF	0x3001 0000	0x3001 FFFF	Shared RAM on CM33 data bus, partitions 2 to 3.
4	0x2002 0000	0x2003 FFFF	0x3002 0000	0x3003 FFFF	Shared RAM on CM33 data bus, partitions 4 to 7.
5	0x2004 0000	0x2007 FFFF	0x3004 0000	0x3007 FFFF	Shared RAM on CM33 data bus, partitions 8 to 11.
6	0x2008 0000	0x200F FFFF	0x3008 0000	0x300F FFFF	Shared RAM on CM33 data bus, partitions 12 to 15.
7	0x2010 0000	0x201F FFFF	0x3010 0000	0x301F FFFF	Shared RAM on CM33 data bus, partitions 16 to 19.
8	0x2020 0000	0x202F FFFF	0x3020 0000	0x302F FFFF	Shared RAM on CM33 data bus, partitions 20 to 23.
9	0x2030 0000	0x203F FFFF	0x3030 0000	0x303F FFFF	Shared RAM on CM33 data bus, partitions 24 to 27.
10	0x2040 0000	0x2047 FFFF	0x3040 0000	0x3047 FFFF	Shared RAM on CM33 data bus, partitions 28 to 29.
11	0x2400 0000	0x240F FFFF	0x3400 0000	0x340F FFFF	HiFi 4 inbound PIF. Allows AHB access to HiFi 4 Instruction and Data TCMs.
12	0x4000 0000	0x4001 FFFF	0x5000 0000	0x5001 FFFF	AHB to APB bridge 0 [2]
	0x4002 0000	0x4003 FFFF	0x5002 0000	0x5003 FFFF	AHB to APB bridge 1 [2]
13	0x4010 0000	0x4011 FFFF	0x5010 0000	0x5011 FFFF	AHB peripherals [3]
14	0x4012 0000	0x4012 FFFF	0x5012 0000	0x5012 FFFF	AHB peripherals [3]
15	0x4013 0000	0x4013 FFFF	0x5013 0000	0x5013 FFFF	AHB peripherals [3]
16	0x4014 0000	0x4014 FFFF	0x5014 0000	0x5014 FFFF	AHB peripherals [3]
17	0x4015 0000	0x4015 FFFF	0x5015 0000	0x5015 FFFF	AHB peripherals [3]

[1]   Gaps between AHB matrix slave ports are not shown.

[2]   Details of this space may be found in Section 10.12.8 "APB peripherals".

[3]   Details of this space may be found in Section 10.12.9 "AHB peripherals".

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10.12.7 Shared RAM detail

Table 11 reflects both the Cortex-M33 and DSP views of the RAM partitions and address. The AHB matrix port is only relevant to the Cortex-M33 because the DSP accesses these RAMs via a separate bus.

The partitions shown in Table 11 are mirrored in all four shared RAM address regions for the Cortex-M33. The purpose of those regions is outlined in Section 10.12.3, while Table 12 gives the base addresses for the four regions.

A variety of shared RAM partition sizes are provided to allow more flexibility in assigning the uses of those spaces. For each application, shard RAM usage should be planned to minimize collision of accesses by the two buses of the Cortex-M33, as well as other bus masters, including DMA controllers and the HiFi 4.

A best case would be if each shared RAM partition is accessed by only one master at any particular time, "ownership" being passed to another master (for instance) when a buffer is filled from a peripheral, a block of data is processed by an algorithm, etc.

To summarize, access collisions can occur under the following conditions.

- On the AHB matrix: when two AHB masters access a resource on the same slave port at the same time. AHB masters include the HiFi 4 when it is using the AHB matrix, not when it is accessing shared RAM.
- HiFi 4 accessing shared RAM: when the HiFi 4 and an AHB master access the same shared RAM partition at the same time. Note that in this case, the access collision happens at the partition, not at the slave port. Since there are multiple partitions for each slave port, this allows even more opportunity to avoid collisions.

Table 11.   Shared RAM memory map: offsets for all types of shared memory accesses

AHB port	Partition	Start offset	End offset	Size
2	0	0x00 0000	0x00 7FFF	32 KB
	1	0x00 8000	0x00 FFFF	32 KB
3	2	0x01 0000	0x01 7FFF	32 KB
	3	0x01 8000	0x01 FFFF	32 KB
4	4	0x02 0000	0x02 7FFF	32 KB
	5	0x02 8000	0x02 FFFF	32 KB
	6	0x03 0000	0x03 7FFF	32 KB
	7	0x03 8000	0x03 FFFF	32 KB
5	8	0x04 0000	0x04 FFFF	64 KB
	9	0x05 0000	0x05 FFFF	64 KB
	10	0x06 0000	0x06 FFFF	64 KB
	11	0x07 0000	0x07 FFFF	64 KB
6	12	0x08 0000	0x09 FFFF	128 KB
	13	0x0A 0000	0x0B FFFF	128 KB
	14	0x0C 0000	0x0D FFFF	128 KB
	15	0x0E 0000	0x0F FFFF	128 KB

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Table 11. Shared RAM memory map: offsets for all types of shared memory accesses

AHB port	Partition	Start offset	End offset	Size
7	16	0x10 0000	0x13 FFFF	256 KB
	17	0x14 0000	0x17 FFFF	256 KB
	18	0x18 0000	0x1B FFFF	256 KB
	19	0x1C 0000	0x1F FFFF	256 KB
8	20	0x20 0000	0x23 FFFF	256 KB
	21	0x24 0000	0x27 FFFF	256 KB
	22	0x28 0000	0x2B FFFF	256 KB
	23	0x2C 0000	0x2F FFFF	256 KB
9	24	0x30 0000	0x33 FFFF	256 KB
	25	0x34 0000	0x37 FFFF	256 KB
	26	0x38 0000	0x3B FFFF	256 KB
	27	0x3C 0000	0x3F FFFF	256 KB
10	28	0x40 0000	0x43 FFFF	256 KB
	29	0x44 0000	0x47 FFFF	256 KB

Table 12. Base addresses for different types of shared memory accesses

Base address	Cortex-M33	HiFi 4
0x0000 0000	Code bus - non-secure	Cacheable (see Section 10.12.10.1)
0x1000 0000	Code bus - secure	-
0x2000 0000	Data bus - non-secure	Non-cacheable (see Section 10.12.10.1)
0x3000 0000	Data bus - secure	-

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10.12.8 APB peripherals

Table 13 provides details of the addresses for APB peripherals. APB peripherals have both secure and non-secure access possibilities, and are accessible by the HiFi 4 unless secured.

Table 13. APB peripherals memory map

AHB port	APB bridge	Non-secure base address	Secure base address	Peripheral
12	0	0x4000 0000	0x5000 0000	RSTCTL0. Reset control group 0. [1]
		0x4000 1000	0x5000 1000	CLKCTL0. Clock control group 0. [1]
		0x4000 2000	0x5000 2000	SYSCTL0. System control group 0. [1]
		0x4000 4000	0x5000 4000	IOCON. Pin function selection and pin control setup.
		0x4000 6000	0x5000 6000	PUF. Physical unclonable function cryptographic key generation.
		0x4000 E000	0x5000 E000	WWDT0 (Windowed watchdog timer 0).
		0x4000 F000	0x5000 F000	Utick (Micro-tick timer).
	1	0x4002 0000	0x5002 0000	RSTCTL1. Reset control group 1. [1]
		0x4002 1000	0x5002 1000	CLKCTL1. Clock control group 1. [1]
		0x4002 2000	0x5002 2000	SYSCTL1. System control group 1. [1]
		0x4002 5000	0x5002 5000	GPIO pin interrupts (PINT).
		0x4002 6000	0x5002 6000	Input multiplexing controls.
		0x4002 8000	0x5002 8000	CT32B0 (standard counter/timer 0).
		0x4002 9000	0x5002 9000	CT32B1 (standard counter/timer 1).
		0x4002 A000	0x5002 A000	CT32B2 (standard counter/timer 2).
		0x4002 B000	0x5002 B000	CT32B3 (standard counter/timer 3).
		0x4002 C000	0x5002 C000	CT32B4 (standard counter/timer 4).
		0x4002 D000	0x5002 D000	MRT (Multi-Rate Timer).
		0x4002 E000	0x5002 E000	WWDT1 (Windowed watchdog timer 1).
		0x4002 F000	0x5002 F000	Frequency measure unit.
		0x4003 0000	0x5003 0000	RTC & Wake-up timer.
		0x4003 6000	0x5003 6000	I3C interface.
		0x4003 7000	0x5003 7000	Reserved.

[1] Reset, clock, and system control functions are separated into 2 groups to allow the possibility of securing group 0 while leaving group 1 unsecured.

10.12.9 AHB peripherals

Table 14 provides details of the addresses for AHB peripherals. AHB peripherals have both secure and non-secure access possibilities. Some AHB matrix ports are accessible by the HiFi 4 (for peripherals that are not secure), some are accessible only by the Cortex-M33.

Table 14. AHB peripheral memory map

AHB port	Non-secure base address	Secure base address	Accessible by HiFi 4?	Peripheral
13	0x4010 0000	0x5010 0000	Yes	High Speed GPIO (general purpose I/O for port pins that are not selected for some other function by IOCON).
	0x4010 4000	0x5010 4000		DMA0 registers.
	0x4010 5000	0x5010 5000		DMA1 registers.
	0x4010 6000	0x5010 6000		Flexcomm Interface 0.
	0x4010 7000	0x5010 7000		Flexcomm Interface 1.
	0x4010 8000	0x5010 8000		Flexcomm Interface 2.
	0x4010 9000	0x5010 9000		Flexcomm Interface 3.
	0x4010 F000	0x5010 F000		Debug mailbox.
	0x4011 0000	0x5011 0000		Message Unit A (Cortex-M33 port).
	0x4011 1000	0x5011 1000		Message Unit B (HiFi 4 port).
	0x4011 2000	0x5011 2000		Semaphore.
	0x4011 3000	0x5011 3000		OS Event Timer 0 (for access by Cortex-M33).
	0x4011 4000	0x5011 4000		OS Event Timer 1 (for access by HiFi 4).
14	0x4012 0000	0x5012 0000	Yes	CRC Engine.
	0x4012 1000	0x5012 1000		D-MIC (8 channel PDM digital microphone interface)
	0x4012 2000	0x5012 2000		Flexcomm Interface 4.
	0x4012 3000	0x5012 3000		Flexcomm Interface 5.
	0x4012 4000	0x5012 4000		Flexcomm Interface 6.
	0x4012 6000	0x5012 6000		Flexcomm Interface 14 (High Speed SPI).
	0x4012 7000	0x5012 7000		Flexcomm Interface 15 (PMIC I2C).
15	0x4013 0000	0x5013 0000	Yes	OTP Controller (One Time Programmable factory and user settings).
	0x4013 4000	0x5013 4000		FlexSPI and OTFAD registers.
	0x4013 5000	0x5013 5000		PMC (PMU control).
	0x4013 6000	0x5013 6000		SDIO0 registers.
	0x4013 8000	0x5013 8000		Random Number Generator.
	0x4013 9000	0x5013 9000		ACMP0 (comparator).
	0x4013 A000	0x5013 A000		ADC0.
	0x4013 B000	0x5013 B000		HS USB PHY registers.
16	0x4014 0000	0x5014 0000	No	HS USB RAM interface.
	0x4014 4000	0x5014 4000		HS USB device registers.
	0x4014 5000	0x5014 5000		HS USB host registers.
	0x4014 6000	0x5014 6000		SCTimer/PWM.
	0x4014 8000	0x5014 8000		Security Control registers (AHB_SECURE_CTRL).

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Table 14. **AHB peripheral memory map** *…continued*

AHB port	Non-secure base address	Secure base address	Accessible by HiFi 4?	Peripheral
17	0x4015 0000	0x5015 0000	No	PowerQuad coprocessor.
	0x4015 1000	0x5015 1000		Casper coprocessor.
	0x4015 2000	0x5015 2000		Casper RAM interface.
	0x4015 4000	0x5015 4000		Secure HS GPIO (alternate 32-bit GPIO facility that can be secured separately from the main GPIO).
	0x4015 8000	0x5015 8000		Hash-AES registers.

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10.12.10 HiFi 4 memory map

Table 15 provides a detailed memory map from the viewpoint of the HiFi 4.

Table 15. HiFi 4 overview memory map

Cacheable start address [1]	Cacheable end address [1]	Non-cacheable start address [1]	Non-cacheable end address [1]	Function	Size	AHB port
0x0000 0000	0x0000 7FFF	0x2000 0000	0x2000 7FFF	Shared RAM partition 0.	32 KB	2 [2]
0x0000 8000	0x0000 FFFF	0x2000 8000	0x2000 FFFF	Shared RAM partition 1.	32 KB	
0x0001 0000	0x0001 7FFF	0x2001 0000	0x2001 7FFF	Shared RAM partition 2.	32 KB	3 [2]
0x0001 8000	0x0001 FFFF	0x2001 8000	0x2001 FFFF	Shared RAM partition 3.	32 KB	
0x0002 0000	0x0002 7FFF	0x2002 0000	0x2002 7FFF	Shared RAM partition 4.	32 KB	4 [2]
0x0002 8000	0x0002 FFFF	0x2002 8000	0x2002 FFFF	Shared RAM partition 5.	32 KB	
0x0003 0000	0x0003 7FFF	0x2003 0000	0x2003 7FFF	Shared RAM partition 6.	32 KB	
0x0003 8000	0x0003 FFFF	0x2003 8000	0x2003 FFFF	Shared RAM partition 7.	32 KB	
0x0004 0000	0x0004 FFFF	0x2004 0000	0x2004 FFFF	Shared RAM partition 8.	64 KB	5 [2]
0x0005 0000	0x0005 FFFF	0x2005 0000	0x2005 FFFF	Shared RAM partition 9.	64 KB	
0x0006 0000	0x0006 FFFF	0x2006 0000	0x2006 FFFF	Shared RAM partition 10.	64 KB	
0x0007 0000	0x0007 FFFF	0x2007 0000	0x2007 FFFF	Shared RAM partition 11.	64 KB	
0x0008 0000	0x0009 FFFF	0x2008 0000	0x2009 FFFF	Shared RAM partition 12.	128 KB	6 [2]
0x000A 0000	0x000B FFFF	0x200A 0000	0x200B FFFF	Shared RAM partition 13.	128 KB	
0x000C 0000	0x000D FFFF	0x200C 0000	0x200D FFFF	Shared RAM partition 14.	128 KB	
0x000E 0000	0x000F FFFF	0x200E 0000	0x200F FFFF	Shared RAM partition 15.	128 KB	
0x0010 0000	0x0013 FFFF	0x2010 0000	0x2013 FFFF	Shared RAM partition 16.	256 KB	7 [2]
0x0014 0000	0x0017 FFFF	0x2014 0000	0x2017 FFFF	Shared RAM partition 17.	256 KB	
0x0018 0000	0x001B FFFF	0x2018 0000	0x201B FFFF	Shared RAM partition 18.	256 KB	
0x001C 0000	0x001F FFFF	0x201C 0000	0x201F FFFF	Shared RAM partition 19.	256 KB	
0x0020 0000	0x0023 FFFF	0x2020 0000	0x2023 FFFF	Shared RAM partition 20.	256 KB	8 [2]
0x0024 0000	0x0027 FFFF	0x2024 0000	0x2027 FFFF	Shared RAM partition 21.	256 KB	
0x0028 0000	0x002B FFFF	0x2028 0000	0x202B FFFF	Shared RAM partition 22.	256 KB	
0x002C 0000	0x002F FFFF	0x202C 0000	0x202F FFFF	Shared RAM partition 23.	256 KB	
0x0030 0000	0x0033 FFFF	0x2030 0000	0x2033 FFFF	Shared RAM partition 24.	256 KB	9 [2]
0x0034 0000	0x0037 FFFF	0x2034 0000	0x2037 FFFF	Shared RAM partition 25.	256 KB	
0x0038 0000	0x003B FFFF	0x2038 0000	0x203B FFFF	Shared RAM partition 26.	256 KB	
0x003C 0000	0x003F FFFF	0x203C 0000	0x203F FFFF	Shared RAM partition 27.	256 KB	
0x0040 0000	0x0043 FFFF	0x2040 0000	0x2043 FFFF	Shared RAM partition 28.	256 KB	10 [2]
0x0044 0000	0x0047 FFFF	0x2044 0000	0x2047 FFFF	Shared RAM partition 29.	256 KB	
0x2400 0000	0x2400 FFFF	-	-	Data TCM - in 4 interleaved banks.	64 KB	11 [2]
0x2402 0000	0x2402 FFFF	-	-	Instruction TCM (includes the default vector table)	64 KB	
-	-	0x4000 0000	0x4001 FFFF	AHB to APB bridge 0	128 KB	12
-	-	0x4002 0000	0x4003 FFFF	AHB to APB bridge 1	128 KB	
-	-	0x4010 0000	0x4011 FFFF	AHB peripherals [3]	128 KB	13
-	-	0x4012 0000	0x4012 FFFF	AHB peripherals [3]	64 KB	14
-	-	0x4013 0000	0x4013 FFFF	AHB peripherals	64 KB	15

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[1] This is a suggested configuration of cacheable and non-cacheable regions, See Section 10.12.10.1 below.

[2] The HiFi 4 does not use AHB to access this space.

[3] AHB peripherals on other AHB matrix ports are not accessible to the HiFi 4. See Section 10.12.9 "AHB peripherals".

10.12.10.1 Using cacheable and non-cacheable memory regions

The cacheable and non-cacheable regions indicated in the table above and elsewhere in this chapter are recommended (not forced by hardware) in order to insure that the TCMs are not in cacheable space. If this is not done, TCM accesses will use additional power while providing no performance improvement. Cacheable and non-cacheable regions may be user configured via software tools (e.g. the linker used to create HiFi 4 code), and at run time via API calls.

The recommended configuration allows the user to control cache usage for the large shared memory via the two logical address ranges that access the same physical memories. By selecting the address for specific memory usage (as shown in Table 15), the cache will, or will not, be used for that access.

For example, HiFi4 code may always be placed at cacheable addresses. Data that is accessed as a long sequential stream (and therefore not useful to cache) may be placed in non-cacheable addresses. Avoiding the cache when it is not needed will save power and leave more cache space for operations that can take advantage of it.

In addition, cacheing certain areas, such as data that is altered through a different path such as DMA, or peripheral registers, can cause improper operation.

10.13 System control

10.13.1 Clock sources

The RT600 supports three external and three internal clock sources:

- 12 MHz Free Running Oscillator
- 48/60 MHz Free Running Oscillator (FRO).
- 1 MHz Low-Power Internal Oscillator.
- Crystal oscillator.
- 32 kHz Crystal Oscillator
- External Clock Input pin (50 MHz maximum)

10.13.1.1 12 MHz Free Running Oscillator (FRO)

The FRO 12 MHz oscillator provides the default clock at reset and provides a clean system clock shortly after the supply pins reach operating voltage. This FRO oscillator, factory trimmed for accuracy, that can optionally be used as a system clock as well as other purposes

10.13.1.2 48/60 MHz Free Running Oscillator (FRO)

Selectable 48 MHz or 60 MHz FRO oscillator, factory trimmed for accuracy, that can optionally be used as a system clock as well as other purposes.

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10.13.1.3 1 MHz Low-Power oscillator

The 1 MHz oscillator provides an ultra low-power, low-frequency clock source that can be used to clock a variety of functions including the Watchdog Timer (WWDT) and the OSTimer. It can also be used as the main system clock for low-power operation.
The 1 MHz Low Power oscillator is accurate to +/-10% over temperature.

10.13.1.4 Crystal oscillator

The main crystal oscillator on the RT600 can be used with crystal frequencies from 4 MHz to 32 MHz. The crystal oscillator may be used to drive a PLL to achieve higher clock rates. However, the practical range of crystal frequencies for PLL usage is 5 MHz to 26 MHz.

One aspect of the oscillator high gain mode is that a larger voltage swing is used at the crystal pin. This gives a higher noise immunity within the oscillator and less edge to edge jitter of the internal clock. When high gain mode is not required, power used by the crystal oscillator can be reduced by using low power mode.

Remark: High gain mode requires a 1 megohm resistor to be inserted in parallel with the crystal. See Section 16.5. For this reason, high gain mode and low power mode cannot both be used in the same application. The board design must reflect the mode that will be used.

10.13.1.5 32 kHz oscillator

The 32KHz oscillator resides in the "always-on" domain and is used to drive the Real Time Clock. It is also available for use for a variety of other purposes including low-power UART operation or as the main system clock for very low frequency operation.

10.13.2 System PLL (PLL0)

The system PLL accepts an input clock frequency in the range of 32.768 kHz to 25 MHz. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO). PLL lock time is approximately 150 us.

The PLL can be enabled or disabled by software.

10.13.3 Audio PLL (PLL2)

The audio PLL accepts an input clock frequency in the range of 1 MHz to 25 MHz. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO).

The PLL can be enabled or disabled by software.

10.13.4 Clock Generation
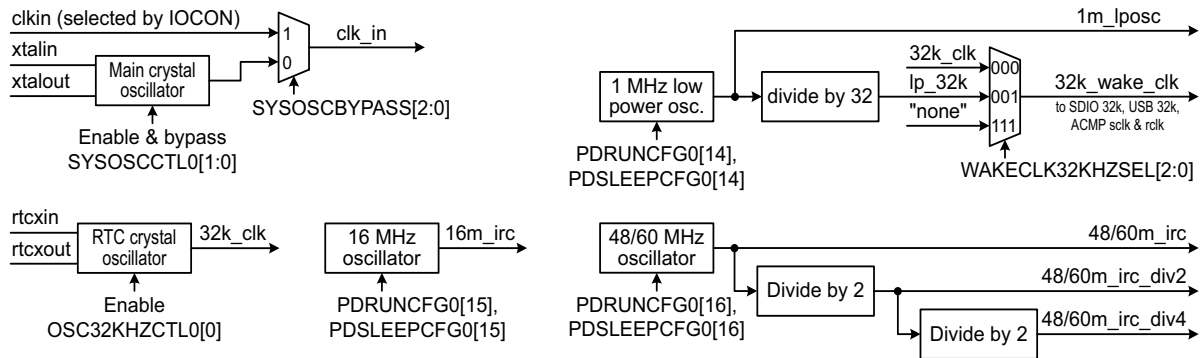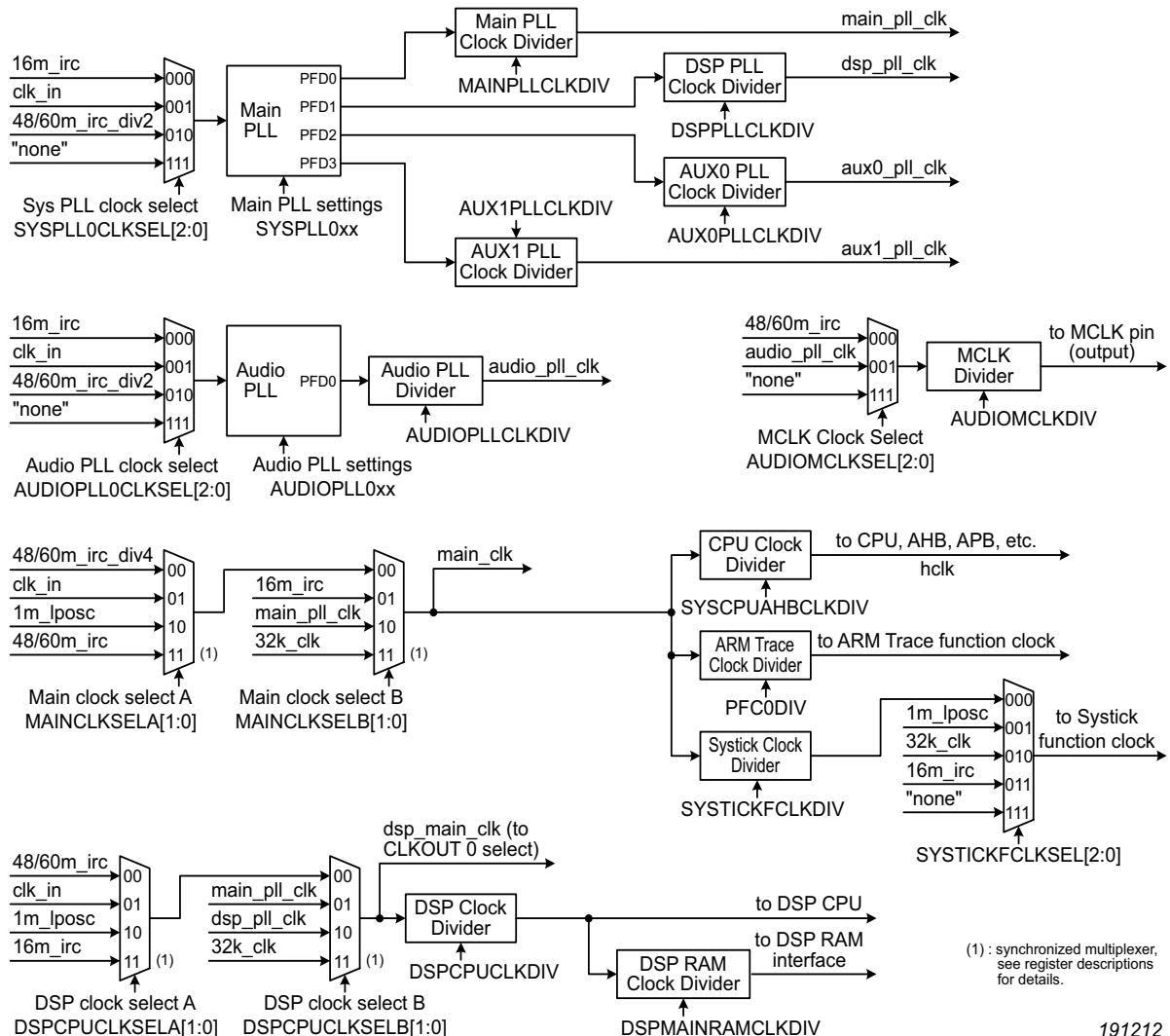
Fig 6. RT600 clock generation

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Fig 7.   RT600 clock generation (continued)

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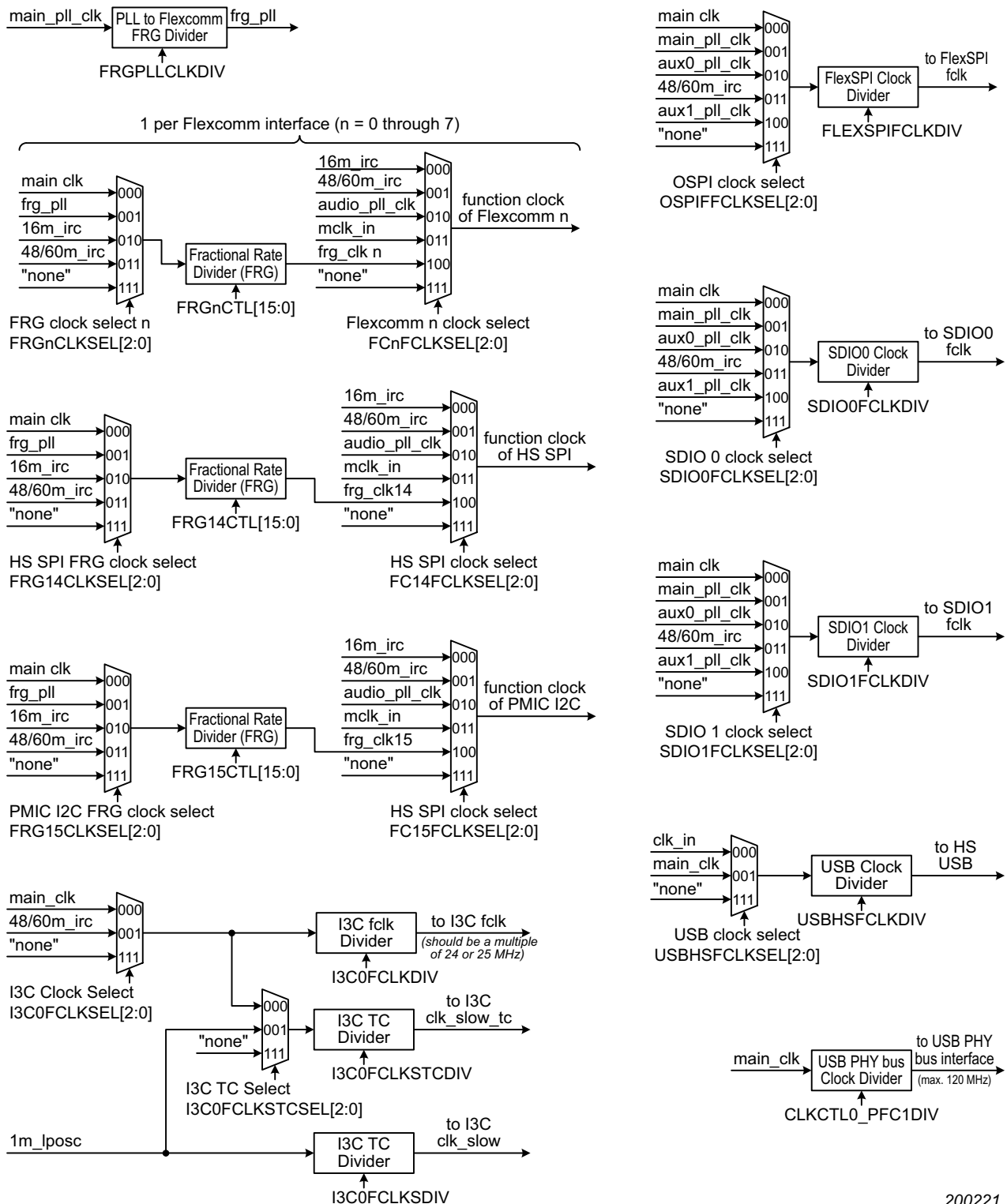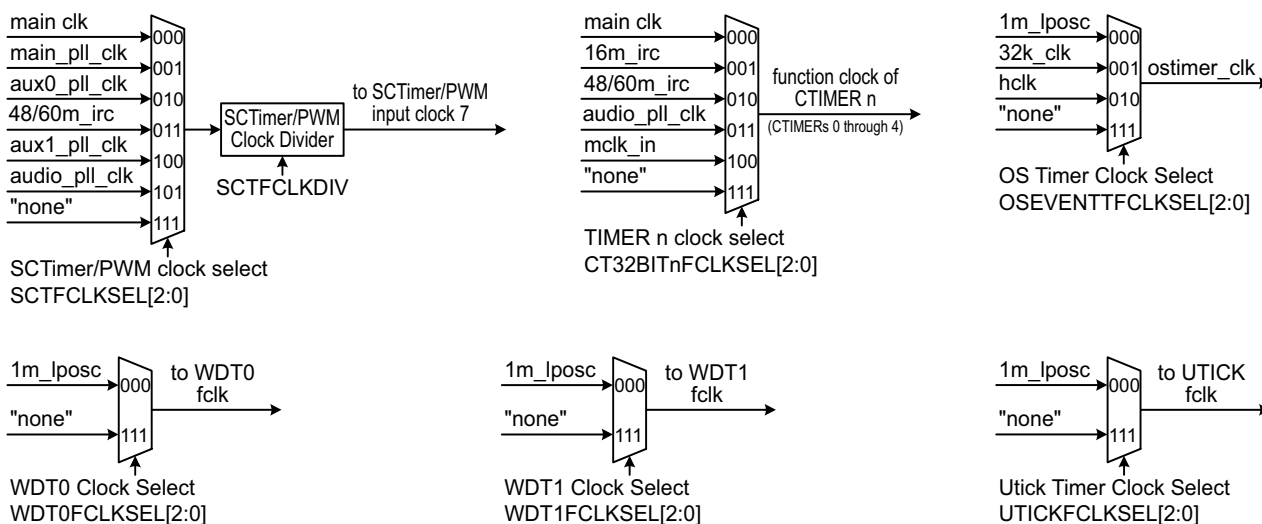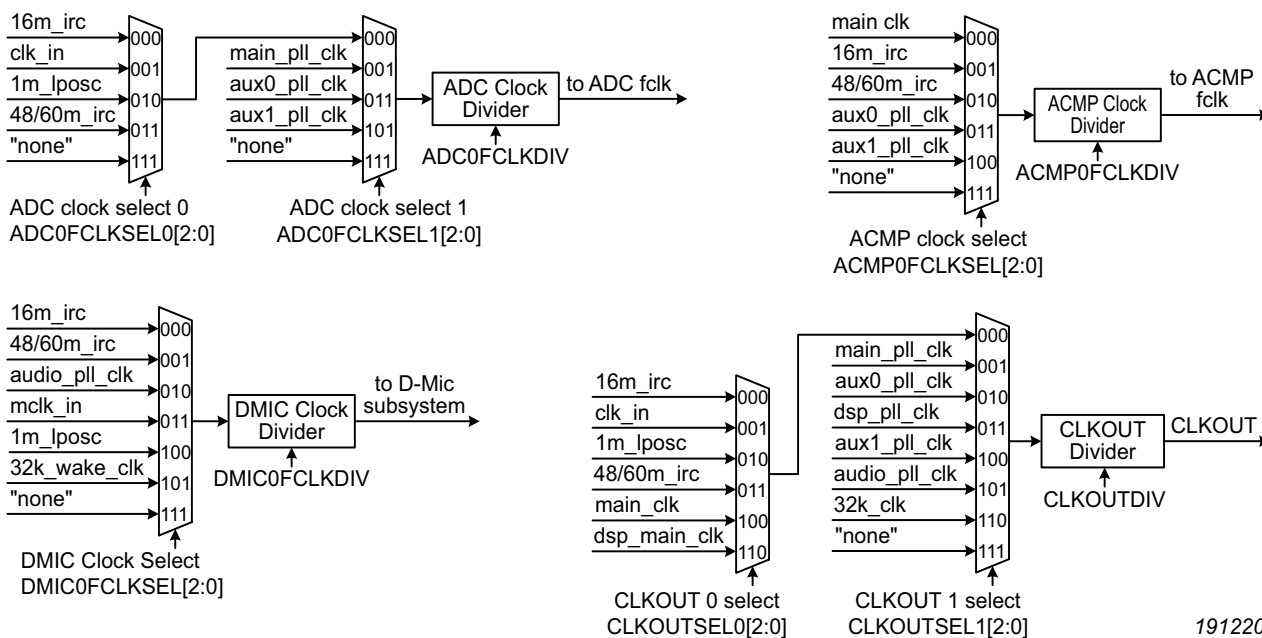
Fig 8. RT600 clock generation (continued)

10.13.5 Safety

The RT600 includes a Windowed WatchDog Timer (WWDT), which can be enabled by software after reset. Once enabled, the WWDT remains locked and cannot be modified in any way until a reset occurs.

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10.14 Power control

The RT600 supports a variety of power control features. In Active mode, when the chip is running, power and clocks to selected peripherals can be adjusted for power consumption. In addition, there are individual power-down controls for many (particularly analog) peripherals. Finally, any set of individual shared Ram partitions may be placed in retain/standby mode or powered-off entirely. This selection can be made on a partition-by-partition basis.

In addition, there are three special modes of processor power reduction with different peripherals running: sleep mode, deep-sleep mode, and deep power-down mode that can be activated using the power API library from the SDK software package

Only FBB must be used for active mode and only RBB must be used for deep sleep mode.

10.14.1 Sleep mode

There are independent sleep modes for each of the two CPUs. In sleep mode, the system clock to that CPU is stopped and execution of instructions is suspended until either a reset or an interrupt occurs. Peripheral functions, if selected to be clocked can continue operation during Sleep mode and may generate interrupts to cause the processor to resume execution. Sleep mode eliminates dynamic power used by the processor itself, memory systems and related controllers, internal buses, and unused peripherals. The processor state and registers, peripheral registers, and internal SRAM values are maintained, and the logic levels of the pins remain static.

10.14.2 Deep-sleep mode

In deep-sleep mode, the system clock to the processor is disabled as in sleep mode. Analog blocks are powered down by default but can be selected to keep running through the POWER_EnterDeepSleep API if needed as wake-up sources. The main clock and all peripheral clocks are disabled. Primary clock sources are disabled by default.

Deep-sleep mode eliminates all power used by analog peripherals and all dynamic power used by the processor itself, memory systems and related controllers, and internal buses (other than those specifically designated to remain functional). The processor state and registers, peripheral registers, and internal SRAM values are maintained, and the logic levels of the pins remain static.

GPIO Pin Interrupts, and selected peripherals such as USB, DMIC, SPI, I2C, USART, WWDT, RTC, and Micro-tick Timer can be left running in deep-sleep mode. Except for the Main PLL, Audio PLL, and main clock, the following clock sources (CLKIN pin, crystal oscillator, 1m_lposc, 16m_irc, 32k_clk, 32k_wake_clk, 48/60m_irc, RTC oscillator, watchdog oscillator, and mclk_in) may be left running.

See related chapters for details of a specific interface. In some cases, DMA can operate in deep-sleep mode.

10.14.3 Deep power-down mode and Full Deep power-down mode

In deep power-down mode, power is shut off to the entire chip except for the RTC power domain, the $\overline{\text{RESET}}$ pin, and the PMIC_IRQ_N pin. The RT600 can wake up from deep power-down mode via the $\overline{\text{RESET}}$ pin, the RTC alarm, and the PMIC_IRQ_N pin. The

ALARM1HZ flag in RTC control register generates an RTC wake-up interrupt request, which can wake up the part. During deep power-down mode, the contents of the SRAM and registers are not retained. All functional pins are tri-stated in deep power-down mode.

In deep power-down mode, all rails can remained powered and supply to the VDDCORE supply can be powered down. In full deep power-down mode, all rails can be powered off and the VDD_AO18 supply can remain powered.

10.14.4 Peripheral configuration in reduced power modes

Table 16 shows the peripheral configuration in reduced power modes.

Table 16.   Peripheral configuration in reduced power modes

Peripheral/Clock	Reduced power mode		
	Sleep	**Deep-sleep**	**Deep power-down**[2]
1m_lposc	Software configured	Software configured	Off
16m_irc	Software configured	Software configured	Off
48/60m_irc	Software configured	Software configured	Off
Crystal oscillator	Software configured	Software configured	Off
RTC and RTC oscillator	Software configured	Software configured	Software configured
System PLL	Software configured	Software configured	Off
Audio PLL	Software configured	Software configured	Off
SRAM memory arrays	Software configured	Software configured	Off
SRAM periphery	Software configured	Software configured	Off
Boot ROM	On	Off'	Off
Other digital peripherals	Software configured	Software configured	Off
A to D converter	Software configured	Software configured	Off
Analog Comparator	Software configured	Software configured [1]	Off

[1]   The comparator may be on in deep-sleep mode, but cannot generate a wake-up interrupt.

[2]   Applies to both deep power-down and full deep power-down modes.

Table 17 shows typical wake-up sources for reduced power modes.

Table 17.   Wake-up sources for reduced power modes

Power mode	Wake-up source	Comment
Sleep	Any peripheral that can cause an interrupt in sleep mode	[1][2]
	HWWAKE	Flexcomm Interfaces and DMIC subsystem activity. [4]
Deep-sleep	Pin interrupts	[1][2][3]
	Watchdog interrupt	Only WDT0 can generate a wake-up from deep-sleep mode. [1][2][3]
	Watchdog reset	Only WDT0 can generate a chip reset. [1]
	Reset pin	No configuration needed.
	RTC 1 Hz alarm timer	[1][2][3]
	RTC_ALARM, RTC_WAKE	[1][2][3]
	Micro-tick timer	Note: the Micro-tick timer is specifically targeted for ultra-low power wake-up from deep-sleep mode [1][2][3]
	OS Event Timer	[1][2][3]
	Flexcomm USART	Interrupt from USART in slave or 32 kHz mode. [1][2][3]
	Flexcomm SPI	Interrupt from SPI in slave mode. [1][2][3]
	Flexcomm I2C	Interrupt from I2C in slave mode. [1][2][3]
	Flexcomm I2S	Interrupt from I2S in slave mode. [1][2][3]
	I3C	Interrupt from I3C in slave mode. [1][2][3]
	USB need clock	Interrupt from USB when activity is detected that requires a clock. [1][2][3][4]
	DMA	See DMA controller chapter in UM for details of DMA-related interrupts. [1][2][3]
	DMA controllers	[1][2][3]
	DMIC	[1][2][3]
	HWWAKE	Certain Flexcomm Interface and DMIC subsystem activity. [4]
	Quad/octal SPI	[1][2][3]
	SDIO	[1][2][3]
	HASH-AES	[1][2][3]
	CASPER	[1][2][3]
	PowerQuad	[1][2][3]
	A to D converter	[1][2][3]
	HiFi4 DSP	[2][3][5]
Deep power-down	RTC_ALARM, RTC_WAKE	[1][2][3]
	Reset pin	No configuration needed.
Full deep power-down	Same as deep power-down except that external power must be restored prior to wake-up.	

[1]   See specific peripheral chapter for basic configuration.

[2]   The related interrupt must be enabled in the NVIC.

[3]   Enable related function in the and STARTEN0 or STARTEN1 register.

[4]   See Hardware Wake-up control register in UM

[5]   Typically via the Message Unit interrupt. See Inter-CPU communications in UM chapter.

10.15 General Purpose I/O (GPIO)

The RT600 provides GPIO ports with a total of up to 147 GPIO pins.

Device pins that are not connected to a specific peripheral function are controlled by the GPIO registers. Pins may be dynamically configured as inputs or outputs. Separate registers allow setting or clearing any number of outputs simultaneously. The current level of a port pin can be read back no matter what peripheral is selected for that pin.

10.15.1 Features

- Accelerated GPIO functions:
  - GPIO registers are located on the AHB so that the fastest possible I/O timing can be achieved.
  - Mask registers allow treating sets of port bits as a group, leaving other bits unchanged.
  - All GPIO registers are byte and half-word addressable.
  - Entire port value can be written in one instruction.
- Bit-level set and clear registers allow a single instruction set or clear of any number of bits in one port.
- Direction control of individual bits.
- All GPIO default to high impedance after reset.
- All GPIO pins can be selected to create an edge or level-sensitive GPIO interrupt request.
- One GPIO group interrupt can be triggered by a combination of any pin or pins.

10.16 Pin interrupt/pattern engine

The pin interrupt block configures up to eight pins from all digital pins for providing eight external interrupts connected to the NVIC. The pattern match engine can be used in conjunction with software to create complex state machines based on pin inputs. Any digital pin, independent of the function selected through the switch matrix can be configured through the SYSCON block as an input to the pin interrupt or pattern match engine. The registers that control the pin interrupt or pattern match engine are located on the I/O+ bus for fast single-cycle access.

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10.16.1 Features

- Pin interrupts:

  - Up to eight pins can be selected from all GPIO pins on ports 0 and 1 as edge-sensitive or level-sensitive interrupt requests. Each request creates a separate interrupt in the NVIC.

  - Edge-sensitive interrupt pins can interrupt on rising or falling edges or both.

  - Level-sensitive interrupt pins can be HIGH-active or LOW-active.

  - Level-sensitive interrupt pins can be HIGH-active or LOW-active.

  - Pin interrupts can wake up the device from sleep mode and deep-sleep mode.

- Pattern match engine:

  - Up to eight pins can be selected from all digital pins on ports 0 and 1 to contribute to a boolean expression. The boolean expression consists of specified levels and/or transitions on various combinations of these pins.

  - Each bit slice minterm (product term) comprising of the specified boolean expression can generate its own, dedicated interrupt request.

  - Any occurrence of a pattern match can also be programmed to generate an RXEV notification to the CPU. The RXEV signal can be connected to a pin.

  - Pattern match can be used in conjunction with software to create complex state machines based on pin inputs.

  - Pattern match engine facilities wake-up only from active and sleep modes.

10.17 Communications peripherals

10.17.1 High-speed USB Host/Device interface (USB1)

The Universal Serial Bus (USB) is a 4-wire bus that supports communication between a host and one or more (up to 127) peripherals. The host controller allocates the USB bandwidth to attached devices through a token-based protocol. The bus supports hot plugging and dynamic configuration of the devices. All transactions are initiated by the host controller.

10.17.1.1 USB1 device controller

The device controller enables 480 Mbit/s data exchange with a USB host controller. It consists of a register interface, serial interface engine, endpoint buffer memory. The serial interface engine decodes the USB data stream and writes data to the appropriate endpoint buffer. The status of a completed USB transfer or error condition is indicated via status registers. An interrupt is also generated if enabled.

Features

- Fully compliant with *USB 2.0 Specification* (high speed).

- Supports 12 physical (6 logical) endpoints with up to 8 kB endpoint buffer RAM.

- Supports Control, Bulk, Interrupt and Isochronous endpoints.

- Scalable realization of endpoints at run time.

- Endpoint Maximum packet size selection (up to USB maximum specification) by software at run time.

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- While USB is in the Suspend mode, the RT600 can enter one of the reduced power modes and wake up on USB activity.
- Double buffer implementation for Bulk and Isochronous endpoints.

10.17.1.2 USB1 host controller

The host controller enables high speed data exchange with USB devices attached to the bus. It consists of register interface and serial interface engine. The register interface complies with the Enhanced Host Controller Interface (EHCI) specification.

Features

- EHCI compliant.
- Two downstream ports.
- Supports per-port power switching.

10.17.2 FlexSPI Flash Inerface

The Flexible Serial Peripheral Interface (FlexSPI) host controller supports up to two SPI channels and up to 4 external devices. Each channel supports Single/Dual/Quad/Octal mode data transfer (1/2/4/8 bidirectional data lines).

FlexSPI flash interface with 32 KB cache and dynamic decryption for execute-in-place and supports DMA.

10.17.2.1 Features

- FlexSPI is compliant to JEDEC's JESD151 v1.0 for xSPI standard specification
- Flexible sequence engine (LUT table) to support various vendor devices.
  - Serial NOR Flash: XccelaFLash, HyperFlash, EcoXiP Flash, Octa Flash, and all QSPI flash devices
  - Serial NAND Flash
  - Serial pSRAM: HyperRAM, Xccela RAM (IoTRAM)
  - FPGA device
- Flash access mode
  - Single/Dual/Quad/Octal mode
  - SDR/DDR mode
  - Individual/Parallel mode
- Support sampling clock mode:
  - Internal dummy read strobe looped back internally
  - Internal dummy read strobe looped back from pad
  - Flash provided read strobe
- Automatic Data Learning to select correct sample clock phase
- Memory mapped read/write access by AHB Bus
  - AHB RX Buffer implemented to reduce read latency. Total AHB RX Buffer size: 256 * 64 Bits
  - 16 AHB masters supported with priority for read access

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- 8 flexible and configurable buffers in AHB RX Buffer

- AHB TX Buffer implemented to buffer all write data from one AHB burst. AHB TX Buffer size: 8 * 64 Bits

- All AHB masters share this AHB TX Buffer. No AHB master number limitation for Write Access.

- Software triggered Flash read/write access by IP Bus

  - IP RX FIFO implemented to buffer all read data from External device. FIFO size: 64 * 64 Bits

  - IP TX FIFO implemented to buffer all Write data to External device. FIFO size: 128 * 64 Bits

  - DMA support to fill IP TX FIFO

  - DMA support to read IP RX FIFO

  - SCLK stopped when reading flash data and IP RX FIFO is full

  - SCLK stopped when writing flash data and IP TX FIFO is empty

10.17.3 SD/eMMC Interfaces

SD/eMMC memory card interface is available with dedicated DMA controller. Supports the eMMC 5.0 standard including HS400 DDR mode. HS-400 is supported on SD port 0 only.

10.17.4 Flexcomm Interface serial communication

10.17.4.1 Features

- USART with asynchronous operation or synchronous master or slave operation.

- SPI master or slave, with up to 4 slave selects.

- I^2C, including separate master, slave, and monitor functions.

- Two I2S functions using Flexcomm Interface 6 and Flexcomm Interface 7.

- Data for USART, SPI, and I2S traffic uses the Flexcomm Interface FIFO. The I^2C function does not use the FIFO.

10.17.4.2 SPI serial I/O controller (Flexcomm Interfaces 0 - 7)

Features

- Excluding delays introduced by external device and PCB, The maximum supported bit rate for SPI master mode (transmit/receive) is 25 Mbit/s and the maximum supported bit rate for SPI slave mode (transmit/receive) is 25 Mbit/s.

- Data frames of 1 to 16 bits supported directly. Larger frames supported by software or DMA set-up.

- Master and slave operation.

- Data can be transmitted to a slave without the need to read incoming data. This can be useful while setting up an SPI memory.

- Control information can optionally be written along with data. This allows very versatile operation, including "any length" frames.

- Four Slave Select input/outputs with selectable polarity and flexible usage.

- Activity on the SPI in slave mode allows wake-up from deep-sleep mode on any enabled interrupt.

Remark: Texas Instruments SSI and National Microwire modes are not supported.

10.17.4.3 I^{2}C-bus interface

The I^{2}C-bus is bidirectional for inter-IC control using only two wires: a serial clock line (SCL) and a serial data line (SDA). Each device is recognized by a unique address and can operate as either a receiver-only device (for example, an LCD driver) or a transmitter with the capability to both receive and send information (such as memory). Transmitters and/or receivers can operate in either master or slave mode, depending on whether the chip has to initiate a data transfer or is only addressed. The I^{2}C is a multi-master bus and can be controlled by more than one bus master connected to it.

Features

- All I2Cs support standard, Fast-mode, and Fast-mode Plus with data rates of up to 1 Mbit/s.
- All I2Cs support high-speed slave mode with data rates of up to 3.4 Mbit/s.
- Independent Master, Slave, and Monitor functions.
- Supports both Multi-master and Multi-master with Slave functions.
- Multiple I^{2}C slave addresses supported in hardware.
- One slave address can be selectively qualified with a bit mask or an address range in order to respond to multiple I^{2}C-bus addresses.
- 10-bit addressing supported with software assist.
- Supports SMBus.
- Activity on the I2C in slave mode allows wake-up from deep-sleep mode on any enabled interrupt.

10.17.4.4 USART

Features

- Excluding delays introduced by external device and PCB, the maximum bit rates of 6.25 Mbit/s in asynchronous mode.
- Excluding delays introduced by external device and PCB, the maximum supported bit rate for USART master synchronous mode is 20 Mbit/s, and the maximum supported bit rate for USART slave synchronous mode is 20.0 Mbit/s.
- 7, 8, or 9 data bits and 1 or 2 stop bits.
- Synchronous mode with master or slave operation. Includes data phase selection and continuous clock option.
- Multiprocessor/multidrop (9-bit) mode with software address compare.
- RS-485 transceiver output enable.
- Autobaud mode for automatic baud rate detection
- Parity generation and checking: odd, even, or none.
- Software selectable oversampling from 5 to 16 clocks in asynchronous mode.
- One transmit and one receive data buffer.

- RTS/CTS for hardware signaling for automatic flow control. Software flow control can be performed using Delta CTS detect, Transmit Disable control, and any GPIO as an RTS output.

- Received data and status can optionally be read from a single register

- Break generation and detection.

- Receive data is 2 of 3 sample "voting". Status flag set when one sample differs.

- Built-in Baud Rate Generator with auto-baud function.

- A fractional rate divider is shared among all USARTs.

- Interrupts available for Receiver Ready, Transmitter Ready, Receiver Idle, change in receiver break detect, Framing error, Parity error, Overrun, Underrun, Delta CTS detect, and receiver sample noise detected.

- Loopback mode for testing of data and flow control.

- In synchronous slave mode, wakes up the part from deep-sleep mode.

- Special operating mode allows operation at up to 9600 baud using the 32.768 kHz RTC oscillator as the UART clock. This mode can be used while the device is in deep-sleep mode and can wake-up the device when a character is received.

- USART transmit and receive functions work with the system DMA controller.

10.17.4.5 I^{2}S-bus interface

The I^{2}S bus provides a standard communication interface for streaming data transfer applications such as digital audio or data collection. The I^{2}S bus specification defines a 3-wire serial bus, having one data, one clock, and one word select/frame trigger signal, providing single or dual (mono or stereo) audio data transfer as well as other configurations. In the RT600, the I^{2}S function is included in Flexcomm Interface 6 and Flexcomm Interface 7. Each of the Flexcomm Interface implements four I^{2}S channel pairs.

The I^{2}S interface within one Flexcomm Interface provides at least one channel pair that can be configured as a master or a slave. Other channel pairs, if present, always operate as slaves. All of the channel pairs within one Flexcomm Interface share one set of I^{2}S signals, and are configured together for either transmit or receive operation, using the same mode, same data configuration and frame configuration. All such channel pairs can participate in a time division multiplexing (TDM) arrangement. For cases requiring an MCLK input and/or output, this is handled outside of the I^{2}S block in the system level clocking scheme.

Features

- A Flexcomm Interface may implement one or more I^{2}S channel pairs, the first of which could be a master or a slave, and the rest of which would be slaves. All channel pairs are configured together for either transmit or receive and other shared attributes. The number of channel pairs is defined for each Flexcomm Interface, and may be from 0 to 4.

- Configurable data size for all channels within one Flexcomm Interface, from 4 bits to 32 bits. Each channel pair can also be configured independently to act as a single channel (mono as opposed to stereo operation).

- All channel pairs within one Flexcomm Interface share a single bit clock (SCK) and word select/frame trigger (WS), and data line (SDA).

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- Data for all I^{2}S traffic within one Flexcomm Interface uses the Flexcomm Interface FIFO. The FIFO depth is 8 entries.

- Left justified and right justified data modes.

- DMA support using FIFO level triggering.

- TDM (Time Division Multiplexing) with a several stereo slots and/or mono slots is supported. Each channel pair can act as any data slot. Multiple channel pairs can participate as different slots on one TDM data line.

- The bit clock and WS can be selectively inverted.

- Sampling frequencies supported depends on the specific device configuration and applications constraints (for example, system clock frequency and PLL availability.) but generally supports standard audio data rates. See the data rates section in I^{2}S chapter in the RT6xx user manual to calculate clock and sample rates.

10.17.5 High-Speed SPI interface (Flexcomm Interface 14)

An additional, stand-alone SPI module is provided. This will be a high-speed SPI able to provide 50 MHz transfer rates. Functionally, it is identical to the SPI Flexcomm interfaces 0 to 7. Excluding delays introduced by external device and PCB, the maximum supported bit rate for SPI master mode (transmit/receive) is 50 Mbit/s. The maximum supported bit rate for SPI slave mode (receive) is 50Mbit/s and for SPI slave mode (transmit) is 35 Mbit/s.

10.17.6 I3C interface

The MIPI Alliance Improved Inter-Integrated Circuit (MIPI I3C) brings major improvements in use and power over I2C, and provides an alternative to SPI for mid-speed applications.The I3C bus is designed to support future sensor interface architectures, widely expected in Internet-of-Things applications.

The I3C bus is intended to be used by microcontrollers (MCU) and application processors

(AP) to connect to sensors, actuators, and other MCUs (as slaves). Connecting an MCU to other MCUs and connecting an AP to an MCU are considered to be the major use cases.

10.17.6.1 Features

- In-band interrupts: interrupts can go from Slave to Master without extra wires, such that the Master knows which Slave sent the interrupt.

- In-band command codes (Common Command Codes (CCC))

- Dynamic addressing

- Multi-master / multi-drop

- Hot-Join

- I2C compatibility. Note that I2C compatibility has limitations. Please refer to user manual for further details.

10.18 Counter/timer peripherals

10.18.1 General-purpose 32-bit timers/external event counter

The RT600 includes five general-purpose 32-bit timer/counters.

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The timer/counter is designed to count cycles of the system derived clock or an externally-supplied clock. It can optionally generate interrupts, generate timed DMA requests, or perform other actions at specified timer values, based on four match registers. Each timer/counter also includes two capture inputs to trap the timer value when an input signal transitions, optionally generating an interrupt.

10.18.1.1 Features

- A 32-bit timer/counter with a programmable 32-bit prescaler.
- Counter or timer operation.
- Up to four 32-bit captures can take a snapshot of the timer value when an input signal transitions. A capture event may also optionally generate an interrupt. The number of capture inputs for each timer that are actually available on device pins may vary by device.
- Four 32-bit match registers that allow:
  - Continuous operation with optional interrupt generation on match.
  - Stop timer on match with optional interrupt generation.
  - Reset timer on match with optional interrupt generation.
  - Shadow registers are added for glitch-free PWM output.
- For each timer, up to four external outputs corresponding to match registers with the following capabilities (the number of match outputs for each timer that are actually available on device pins may vary by device):
  - Set LOW on match.
  - Set HIGH on match.
  - Toggle on match.
  - Do nothing on match.
- Up to two match registers can be used to generate timed DMA requests.
- The timer and prescaler may be configured to be cleared on a designated capture event. This feature permits easy pulse width measurement by clearing the timer on the leading edge of an input pulse and capturing the timer value on the trailing edge.
- Up to four match registers can be configured for PWM operation, allowing up to three single edged controlled PWM outputs. (The number of match outputs for each timer that are actually available on device pins may vary by device.)

10.18.2 SCTimer/PWM

The SCTimer/PWM allows a wide variety of timing, counting, output modulation, and input capture operations. The inputs and outputs of the SCTimer/PWM are shared with the capture and match inputs/outputs of the 32-bit general-purpose counter/timers.

The SCTimer/PWM can be configured as two 16-bit counters or a unified 32-bit counter. In the two-counter case, in addition to the counter value the following operational elements are independent for each half:

- State variable.
- Limit, halt, stop, and start conditions.
- Values of Match/Capture registers, plus reload or capture control values.

In the two-counter case, the following operational elements are global to the SCTimer/PWM, but the last three can use match conditions from either counter:

- Clock selection
- Inputs
- Events
- Outputs
- Interrupts

10.18.2.1 Features

- Two 16-bit counters or one 32-bit counter.
- Counter(s) clocked by bus clock or selected input.
- Up counter(s) or up-down counter(s).
- State variable allows sequencing across multiple counter cycles.
- Event combines input or output condition and/or counter match in a specified state.
- Events control outputs, interrupts, and the SCTimer/PWM states.
  - Match register 0 can be used as an automatic limit.
  - In bi-directional mode, events can be enabled based on the count direction.
  - Match events can be held until another qualifying event occurs.
- Selected event(s) can limit, halt, start, or stop a counter.
- Supports:
  - 8 inputs
  - 10 outputs
  - 16 match/capture registers
  - 16 events
  - 32 states
- PWM capabilities including dead time and emergency abort functions

10.18.3 Windowed WatchDog Timer (WWDT)

The purpose of the watchdog is to reset the controller if software fails to periodically service it within a programmable time window.

A separate Watchdog Timer is provided for each of the two CPUs.

10.18.3.1 Features

- Internally resets chip if not periodically reloaded during the programmable time-out period.
- Optional windowed operation requires reload to occur between a minimum and maximum time period, both programmable.
- Optional warning interrupt can be generated at a programmable time prior to watchdog time-out.
- Enabled by software but requires a hardware reset or a watchdog reset/interrupt to be disabled.

- Incorrect feed sequence causes reset or interrupt if enabled.
- Flag to indicate watchdog reset.
- Programmable 24-bit timer with internal prescaler.
- Selectable time period from ($T_{cy(WDCLK)} \times 256 \times 4$) to ($T_{cy(WDCLK)} \times 2^{24} \times 4$) in multiples of $T_{cy(WDCLK)} \times 4$.
- The Watchdog Clock (WDCLK) uses the WDOSC as the clock source.

10.18.4 Real Time Clock (RTC) timer

The RTC timer is a 32-bit timer which counts down from a preset value to zero. At zero, the preset value is reloaded and the counter continues. The RTC timer uses the 32.768 kHz clock input to create a 1 Hz or 1 kHz clock. Selectable on-chip crystal load capacitors are available for the RTC Oscillator.

10.18.5 Multi-Rate Timer (MRT)

The Multi-Rate Timer (MRT) provides a repetitive interrupt timer with four channels. Each channel can be programmed with an independent time interval, and each channel operates independently from the other channels.

10.18.5.1 Features

- 24-bit interrupt timer.
- Four channels independently counting down from individually set values.
- Repeat and one-shot interrupt modes.

10.18.6 OS/Event Timer

An OS/EVENT Timer module will provide a common time-base between the two CPUs for event synchronization and time-stamping.

The OS/EVENT Timer is comprised of a shared, free-running counter readable by each CPU and individual match and capture registers for each CPU.

The shared and local counters in this module will be implemented using Gray code. This will enable them to be read asynchronously by the processing domains.

The main counter in the OS/EVENT Timer module begins counting immediately following power-up and continues counting through any subsequent system resets (except those caused by a new POR).

10.18.6.1 Features

- 64-bit Gray code counter. Using Gray code means that the timer can run at a a frequency unrelated to either CPU clock and can still be read by either CPU without a synchronization delay. Gray code is a reflected binary code that changes in a single bit position for each increment.
- Separate functions for each CPU:
- A capture register can copy the main counter value when triggered by a CPU request.
- A match register can be compared to the main counter and can optionally generate an interrupt or wake-up event

10.18.7 Micro-Tick Timer

A 32-bit MicroTick timer that runs from the 1 MHz low-power oscillator. This timer can wake up the device from reduced power modes up to deep-sleep, with extremely low power consumption. The MicroTick timer has an added timestamp feature in the form of 4 capture registers.

10.18.7.1 Features

- Ultra simple, ultra-low power timer that can run and wake up the device in reduced power modes other than deep power-down.
- Write once to start.
- Interrupt or software polling.
- Four capture registers that can be triggered by external pin transitions.

10.19 Other digital peripherals

10.19.1 DMA controller

The DMA controller allows peripheral-to memory, memory-to-peripheral, and memory-to-memory transactions. Each DMA stream provides unidirectional DMA transfers for a single source and destination.

Two identical DMA controllers are provided on the RT600. The user may elect to dedicate one of these to the Cortex M-33 CPU and the other for use by the DSP CPU and/or one may be used as a secure DMA the other non-secure.

10.19.1.1 Features

- One channel per on-chip peripheral direction: typically one for input and one for output for most peripherals.
- DMA operations can optionally be triggered by on- or off-chip events.
- Priority is user selectable for each channel.
- Continuous priority arbitration.
- Address cache.
- Efficient use of data bus.
- Supports single transfers up to 1,024 words.
- Address increment options allow packing and/or unpacking data.

10.19.2 DMIC subsystem

10.19.2.1 Features

- Pulse-Density Modulation (PDM) data input for left and/or right channels on 1 or 2 buses.
- Flexible decimation.
- 16 entry FIFO for each channel.
- DC blocking or unaltered DC bias can be selected.

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- Data can be transferred using DMA from deep-sleep mode without waking up the CPU, then automatically returning to deep-sleep mode.
- Data can be streamed directly to I^{2}S on Flexcomm Interface 7.

10.19.3 CRC engine

The Cyclic Redundancy Check (CRC) generator with programmable polynomial settings supports several CRC standards commonly used. To save system power and bus bandwidth, the CRC engine supports DMA transfers.

10.19.3.1 Features

- Supports three common polynomials CRC-CCITT, CRC-16, and CRC-32.
  - CRC-CCITT: $x^{16} + x^{12} + x^5 + 1$
  - CRC-16: $x^{16} + x^{15} + x^2 + 1$
  - CRC-32: $x^{32} + x^{26} + x^{23} + x^{22} + x^{16} + x^{12} + x^{11} + x^{10} + x^8 + x^7 + x^5 + x^4 + x^2 + x + 1$
- Bit order reverse and 1's complement programmable setting for input data and CRC sum.
- Programmable seed number setting.
- Supports CPU PIO or DMA back-to-back transfer.
- Accept any size of data width per write: 8, 16 or 32-bit.
  - 8-bit write: 1-cycle operation.
  - 16-bit write: 2-cycle operation (8-bit x 2-cycle).
  - 32-bit write: 4-cycle operation (8-bit x 4-cycle).

10.20 Analog peripherals

10.20.1 12-bit Analog-to-Digital Converter (ADC)

The ADC supports a resolution of 12-bit and fast conversion rates of up to 1Msamples/s. Sequences of analog-to-digital conversions can be triggered by multiple sources. Possible trigger sources are the SCTimer/PWM, external pins, and the Arm TXEV interrupt.

The ADC supports a variable clocking scheme with clocking synchronous to the system clock or independent, asynchronous clocking for high-speed conversions

The ADC includes a hardware threshold compare function with zero-crossing detection. The threshold crossing interrupt is connected internally to the SCTimer/PWM inputs for tight timing control between the ADC and the SCTimer/PWM.

10.20.1.1 Features

- 12-bit successive approximation analog to digital converter.
- Input multiplexing among up to 12 pins.
- Two configurable conversion sequences with independent triggers.
- Optional automatic high/low threshold comparison and "zero crossing" detection.
- Measurement range VREFN to VREFP (typically 1.8 V; not to exceed VDDA_ADC1V8 voltage level).

- 12-bit conversion rate of 5.0 Msamples/s. Options for reduced resolution at higher conversion rates.

- Burst conversion mode for single or multiple inputs.

- Synchronous or asynchronous operation. Asynchronous operation maximizes flexibility in choosing the ADC clock frequency, Synchronous mode minimizes trigger latency and can eliminate uncertainty and jitter in response to a trigger.

10.20.2 Temperature sensor

The temperature sensor transducer uses an intrinsic pn-junction diode reference and outputs a CTAT voltage (Complement To Absolute Temperature). The temperature sensor is only approximately linear with a slight curvature. The output voltage is measured over different ranges of temperatures and fit with linear-least-square lines.

After power-up, the temperature sensor output must be allowed to settle to its stable value before it can be used as an accurate ADC input.

10.20.3 Analog Comparator

The comparator (CMP) module provides a circuit for comparing two analog input voltages. The comparator circuit is designed to operate across the full range of the supply voltage, known as rail-to-rail operation.

10.21 Security features

The security system on RT600 has a set of hardware blocks and ROM code to implement the security features of the device. The hardware consists of an AES engine, a SHA engine (Hash-AES block), a random number generator, and a key storage block that keys from an SRAM based PUF (Physically Unclonable Function). All components of the system can be accessed by the processor or the DMA engine to encrypt or decrypt data and for hashing. The ROM is responsible for secure boot in addition to providing support for various security functions.

10.21.1 Features

- Trust Zone M

- AES256 Decryption Engine.

- SHA-1, SHA-2 HASH Engine.

- Physical Unclonable Function (PUF) Key Generation.

- CASPER security Cortex-M33 co-processor.

- Random number generator (RNG).

- On-the-Fly Decryption on Octal/Quad0 SPI interface.

- Universally Unique Identifier (UUID)

- Device Identifier Composition Engine (DICE)

10.21.2 AES256

RT600 devices provide an on-chip hardware AES encryption and decryption engine to protect the image content and to accelerate processing for data encryption or decryption, data integrity, and proof of origin. Data can be encrypted or decrypted by the AES engine using a key from the PUF or a software supplied key.

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10.21.3 SHA-1 and SHA-2

The Hash peripheral is used to perform SHA-1 and SHA-2 (256) based hashing. A hash takes an arbitrarily large message or image and forms a relatively small fixed size "unique" number called a digest. The data is fed by words from the processor, DMA, or hosted access; the words are converted from little-endian (Arm standard) to big-endian (SHA standard) by the block.

10.21.3.1 Features

- Used with an HMAC to support a challenge/response or to validate a message.
- Can be used to verify external memory that has not been compromised.

10.21.4 PUF

The PUF controller provides a secure key storage without injecting or provisioning device unique PUF root key.

10.21.4.1 Features

- Key strength of 256 bits. The PUF constructs 256-bit strength device unique PUF root key using the digita fingerprint of a device derived from SRAM and error correction data called Activation Code (AC). The AC is generated during enrollment process and must be stored on external non-volatile memory device in the system.
- Generation, storage, and reconstruction of keys.
- Key sizes from 64 bits to 4096 bits.PUF controller allows storage of keys, generated externally or on chip, of sizes 64 bits to 4096 bits
- PUF controller allows to assign a 4-bit index value for each key while generating key codes. Keys that are assigned index value zero are output through HW bus, accessible to AES engine and OTFAD block only. Keys with non-zero index are available through APB register interface

10.21.5 CASPER co-processor

The Cryptographic Accelerator (CASPER) engine provides acceleration of asymmetric cryptographic algorithms. When the Cryptographic Accelerator (CASPER) is used in conjunction with hardware blocks for hashing and symmetric cryptography, significant performance can be achieved. Supported crypto functions are implemented in the SDK (Software Development Kit) and the mbed TLS examples utilize the CASPER peripheral for computations.

10.21.6 Random Number Generator (RNG)

Random Number Generators (RNG) are used for cryptographic, modeling, and simulation applications, which employ keys that must be generated in a random fashion.

10.21.7 On-the-Fly Decryption on Octal/Quad SPI interface (OTFAD)

The OTFAD function provides AES-128 Counter Mode On-the-Fly Decryption of external data located on the Quad/octal SPI flash interface (QuadSPI) interface.

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10.21.8 Universally Unique Identifier (UUID)

The RT600 stores a 128-bit IETF RFC4122 compliant non-sequential Universally Unique Identifier (UUID). It can be read from registers SYSCTL0_UUID0 through SYSCTL0_UUID3

10.21.9 Device Identifier Composition Engine (DICE)

The RT600 supports Device Identifier Composition Engine (DICE) to provide Composite Device Identifier (CDI). CDI value would be available in registers SYSCTL0DICEHWREG0 through SYSCTL0DICEHWREG7 for consumption after boot completion. It is recommended to overwrite these registers once ephemeral key-pairs are generated using this value.

10.22 Emulation and debugging

Debug and trace functions are integrated into the Arm Cortex-M33. Serial wire debug and trace functions are supported. The Arm Cortex-M33 is configured to support up to eight breakpoints and four watch points.

The Arm SYSREQ reset is supported and causes the processor to reset the peripherals, execute the boot code, restart from address 0x0000 0000, and break at the user entry point.

The SWD pins are multiplexed with other digital I/O pins. On reset, the pins assume the SWD functions by default.

11. Limiting values

Table 18. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). [1]

Symbol	Parameter	Conditions		Min	Max	Unit
VDD_AO1V8	Supply 1.8 V supply for "always on" features.		[2]	-0.3	1.98	V
VDD1V8	1.8 V supply voltage for on-chip analog functions other than the ADC and comparator.		[2]	-0.3	1.98	V
VDD1V8_1	1.8 V supply voltage for OTP.		[2]	-0.3	1.98	V
VDDCORE	Power supply for core logic	On-chip regulator not used. Power supplied by an off-chip power management IC (PMIC).	[2]	-0.3	1.32	V
VDDIO_0/1/2	Supply voltage for GPIO pins		[2]	-0.3	3.96	V
VDDA_ADC1V8	1.8 V analog supply voltage for ADC and comparator.		[2]	-0.3	1.98	V
VDDA_BIAS	Bias for ADC and comparator. VDD_BIAS must be equal to ADC input voltage or max comparator input voltage.		[2]	-0.3	3.96	V
VREFP	ADC positive reference voltage		[2]	-0.3	1.98	V
USB1_VBUS	USB1_VBUS detection			-0.3	5.6	V
USB1_VDD3V3	USB1 analog 3.3 V supply		[2]	-0.3	3.96	V
I_{DD}	supply current (VFBGA176)	per VDDIO pin, 1.71 V $\leq$ V$_{DDIO}$ $\leq$ 3.6 V	[3]	-	100	mA
	supply current (WLCSP114)	per VDDIO pin, 1.71 V $\leq$ V$_{DDIO}$ $\leq$ 3.6 V	[3]	-	100	mA
	supply current (FOWLP249)	per VDDIO pin, 1.71 V $\leq$ V$_{DDIO}$ $\leq$ 3.6 V	[3]	-	100	mA
I_{SS}	ground current (VFBGA176)	1.71 V $\leq$ V$_{DDIO}$ $\leq$ 3.6 V	[3]	-	100	mA
	ground current (WLCSP114)	1.71 V $\leq$ V$_{DDIO}$ $\leq$ 3.6 V	[3]	-	100	mA
	ground current (FOWLP249)	1.71 V $\leq$ V$_{DDIO}$ $\leq$ 3.6 V	[3]	-	100	mA
I_{latch}	I/O latch-up current	$-(0.5V_{DD}) < V_I < (1.5V_{DD})$; T$_j$ < 125 °C		-	100	mA
T_{stg}	storage temperature			-55	150	°C
$T_{j(max)}$	maximum junction temperature			-	105	°C
$P_{tot(pack)}$	total power dissipation (per package)	VFBGA176, based on package heat transfer, not device power consumption	[5]	-	1	W

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Table 18.   Limiting values …*continued*

In accordance with the Absolute Maximum Rating System (IEC 60134).[1]

Symbol	Parameter	Conditions		Min	Max	Unit
$P_{tot(pack)}$	total power dissipation (per package)	WLSCP114, based on package heat transfer, not device power consumption	[5]	-	1	W
$P_{tot(pack)}$	total power dissipation (per package)	FOWLP249, based on package heat transfer, not device power consumption	[5]	-	1.1	W
V_{ESD}	electrostatic discharge voltage	human body model; all pins	[4]	-	2000	V

[1]   The following applies to the limiting values:

    a) This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge. Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maximum.

    b) Parameters are valid over operating temperature range unless otherwise specified. All voltages are with respect to V_{SS} unless otherwise noted.

    c) The limiting values are stress ratings only and operating the part at these values is not recommended and proper operation is not guaranteed. The conditions for functional operation are specified in Table 20 "General operating conditions".

[2]   Maximum/minimum voltage above the maximum operating voltage (see Table 20 "General operating conditions") and below ground should be avoided as proper operation cannot be guaranteed and could lead to irrecoverable failure. Failure includes the loss of reliability and shorter lifetime of the device.

[3]   The peak current should not exceed the total supply current.

[4]   Human body model: equivalent to discharging a 100 pF capacitor through a 1.5 kΩ series resistor.

[5]   Determined in accordance to JEDEC JESD51-2A natural convection environment (still air).

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12. Thermal characteristics

The average chip junction temperature, T_j (°C), can be calculated using the following equation:

$$T_j = T_{amb} + (P_D \times R_{th(j-a)}) \tag{1}$$

- T_{amb} = ambient temperature (°C),
- $R_{th(j-a)}$ = the package junction-to-ambient thermal resistance (°C/W)
- P_D = sum of internal and I/O power dissipation

The internal power dissipation is the product of I_{DD} and V_{DD}. The I/O power dissipation of the I/O pins is often small and many times can be negligible. However it can be significant in some applications. Determined in accordance to JEDEC JESD51-2A natural convection environment (still air). Thermal resistance data in this report is solely for a thermal performance comparison of one package to another in a standardized specified environment. It is not meant to predict the performance of a package in an application-specific environment.

Table 19. Thermal resistance [1]

Symbol	Parameter	Conditions	Max/Min	Unit
VFBGA176 Package				
$R_{th(j-a)}$	thermal resistance from junction to ambient	JESD51-9, 2s2p, still air	32.8	°C/W
WLCSP114 Package				
$R_{th(j-a)}$	thermal resistance from junction to ambient	JESD51-9, 2s2p, still air	35.3	°C/W
FOWLP249 Package				
$R_{th(j-a)}$	thermal resistance from junction to ambient	JESD51-9, 2s2p, still air	29.6	°C/W

[1] Determined in accordance to JEDEC JESD51-2A natural convection environment (still air). Thermal resistance data in this report is solely for a thermal performance comparison of one package to another in a standardized specified environment. It is not meant to predict the performance of a package in an application-specific environment.

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13. Static characteristics

13.1 General operating conditions

Table 20. General operating conditions

T_{amb} = 0 °C to +85 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
f_{clk}	CPU (Cortex-M33) clock frequency.		-	-	300	MHz
	CPU (Cortex-M33) clock frequency.	For USB high-speed device and host operations.	90	-	300	MHz
	CPU (Cortex-M33) clock frequency.	For USB full-speed device and host operations.	12	-	300	MHz
f_{clk}	DSP clock frequency		-	-	600	MHz
VDD_AO1V8	Supply 1.8 V supply for "always on" features.		1.71	-	1.89	V
VDD1V8	1.8 V supply voltage for on-chip analog functions other than the ADC and comparator.		1.71	-	1.89	V
VDD1V8_1 [4]	1.8 V supply voltage for OTP.		1.71	-	1.89	V
VDDCORE [3][5][6][7]	Power supply for core logic. On-chip regulator not used. Power supplied by an off-chip power management IC (PMIC).	Retention Mode	0.7	-	-	V
	Low voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (M33 Max Freq = 70 MHz, FBB).	0.7	-	1.155	V
		Active Mode (M33 Max Freq = 150 MHz, FBB).	0.8	-	1.155	V
		Active Mode (M33 Max Freq = 220 MHz, FBB).	0.9	-	1.155	V
	Full voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (M33 Max Freq = 65 MHz, FBB).	0.7	-	1.155	V
		Active Mode (M33 Max Freq = 140 MHz, FBB).	0.8	-	1.155	V
		Active Mode (M33 Max Freq = 210 MHz, FBB).	0.9	-	1.155	V
		Active Mode (M33 Max Freq = 275 MHz, FBB).	1.0	-	1.155	V
		Active Mode (M33 Max Freq = 300 MHz, FBB).	1.13	-	1.155	V

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Table 20. **General operating conditions** *…continued*
T_{amb} = 0 °C to +85 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
VDDCORE [3]	Low voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (DSP Max Freq = 115 MHz, FBB).	0.7	-	1.155	V
		Active Mode (DSP Max Freq = 260 MHz, FBB).	0.8	-	1.155	V
		Active Mode (DSP Max Freq = 375 MHz, FBB).	0.9	-	1.155	V
	Full voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (DSP Max Freq = 70 MHz, FBB).	0.7	-	1.155	V
		Active Mode (DSP Max Freq = 195 MHz, FBB).	0.8	-	1.155	V
		Active Mode (DSP Max Freq = 300 MHz, FBB).	0.9	-	1.155	V
		Active Mode (DSP Max Freq = 480 MHz, FBB).	1.0	-	1.155	V
		Active Mode (DSP Max Freq = 600 MHz, FBB).	1.13	-	1.155	V
VDDIO_0/1/2	Supply voltage for GPIO rail.		1.71	-	3.6	V
VDDA_ADC1V8	1.8 V analog supply voltage for ADC and comparator.		1.71	-	1.89	V
VDDA_BIAS [2]	Bias for ADC and comparator.		1.71	-	3.6	V
VREFP	ADC positive reference voltage.		1.71	-	1.89	V
USB1_VDD3V3	USB1 analog 3.3 V supply.		3.0	-	3.6	V

[1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), nominal supply voltages.

[2] VDD_BIAS must be equal to ADC input voltage or max comparator input voltage.

[3] For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency.Please see Figure 6 "RT600 clock generation".

[4] 1.8 V supply voltage for OTP during active mode. In deep-sleep mode, this pin can be powered off to conserve additional current (~ 65 uA). VDD1V8_1 must be stable before performing any OTP related functions.

[5] When LDO_ENABLE is externally tied low, the user must boot at VDDCORE = 1.0 V or higher (Low power/Normal clock mode - OTP setting - BOOT_CLK_SPEED) or VDDCORE = 1.13 V (High Speed clock - OTP setting - BOOT_CLK_SPEED). Thereafter, the VDDCORE can be adjusted to the desired level.

[6] When LDO_ENABLE is externally tied high, the on-chip regulator to the VDDCORE Core voltage in PMC is set to the default value 1.05 V (Low power/Normal clock mode - OTP setting - BOOT_CLK_SPEED) or 1.13 V (High Speed clock - OTP setting - BOOT_CLK_SPEED). Thereafter, the POWER_SetLdoVoltageForFreq API function can be used to internally configure the on-chip regulator voltage to the VDDCORE.

[7] When performing any OTP read/write function, the VDDCORE voltage must be set to 1.0 V or higher when LDO_ENABLE is externally tied high or low.

[8] Low voltage operating range is for applications using the RT600 at VDDCORE voltages between 0.7 V to 0.9 V. So for example, if an application is using VDDCORE = 0.7 V and 0.9 V, max frequencies defined for the low voltage operating range must be used. Full voltage operating range is for applications using the RT600 at VDDCORE voltages between 0.7 V to 1.13 V. So for example, if an application is using VDDCORE = 0.7 V and 1.13 V, max frequencies defined for the full voltage operating range must be used. Low voltage range provides higher operating speeds when compared to full voltage operating range. After Boot-up, application must select either low voltage range or full voltage range. An application cannot switch between low voltage range and full voltage range mode.

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Table 21. General operating conditions

T_{amb} = -20 ℃ to +85 ℃, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
f_{clk}	CPU (Cortex-M33) clock frequency.		-	-	300	MHz
	CPU (Cortex-M33) clock frequency	For USB high-speed device and host operations	90	-	300	MHz
	CPU (Cortex-M33) clock frequency.	For USB full-speed device and host operations	12	-	300	MHz
f_{clk}	DSP clock frequency		-	-	580	MHz
VDD_AO1V8	Supply 1.8 V supply for "always on" features.		1.71	-	1.89	V
VDD1V8	1.8 V supply voltage for on-chip analog functions other than the ADC and comparator.		1.71	-	1.89	V
VDD1V8_1 [4]	1.8 V supply voltage for OTP.		1.71	-	1.89	V
VDDCORE [3][5][6][7]	Power supply for core logic. On-chip regulator not used. Power supplied by an off-chip power management IC (PMIC).	Retention Mode	0.7	-	-	V
	Low voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (M33 Max Freq = 60 MHz, FBB).	0.7	-	1.155	V
		Active Mode (M33 Max Freq = 140 MHz, FBB).	0.8	-	1.155	V
		Active Mode (M33 Max Freq = 215 MHz, FBB).	0.9	-	1.155	V
	Full voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (M33 Max Freq = 50 MHz, FBB).	0.7	-	1.155	V
		Active Mode (M33 Max Freq = 135 MHz, FBB).	0.8	-	1.155	V
		Active Mode (M33 Max Freq = 200 MHz, FBB).	0.9	-	1.155	V
		Active Mode (M33 Max Freq = 270 MHz, FBB).	1.0	-	1.155	V
		Active Mode (M33 Max Freq = 300 MHz, FBB).	1.13	-	1.155	V

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Table 21.   General operating conditions *…continued*
T_{amb} = -20 ˚C to +85 ˚C, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
VDDCORE [3]	Low voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (DSP Max Freq = 95 MHz, FBB).	0.7	-	1.155	V
		Active Mode (DSP Max Freq = 235 MHz, FBB).	0.8	-	1.155	V
		Active Mode (DSP Max Freq = 355 MHz, FBB).	0.9	-	1.155	V
	Full voltage operating range. SDK Power Library version = 0x020300, SDK version 2.8.3 and later. [8]	Active Mode (DSP Max Freq = 55 MHz, FBB).	0.7	-	1.155	V
		Active Mode (DSP Max Freq = 170 MHz, FBB).	0.8	-	1.155	V
		Active Mode (DSP Max Freq = 285 MHz, FBB).	0.9	-	1.155	V
		Active Mode (DSP Max Freq = 440 MHz, FBB).	1.0	-	1.155	V
		Active Mode (DSP Max Freq = 550 MHz, FBB).	1.13	-	1.155	V
VDDIO_0/1/2	Supply voltage for GPIO rail.		1.71	-	3.6	V
VDDA_ADC1V8	1.8 V analog supply voltage for ADC and comparator.		1.71	-	1.89	V
VDDA_BIAS [2]	Bias for ADC and comparator.		1.71	-	3.6	V
VREFP	ADC positive reference voltage.		1.71	-	1.89	V
USB1_VDD3V3	USB1 analog 3.3 V supply.		3.0	-	3.6	V

[1]   Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), nominal supply voltages.

[2]   VDD_BIAS must be equal to ADC input voltage or max comparator input voltage.

[3]   For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency. Please see Figure 6 "RT600 clock generation".

[4]   1.8 V supply voltage for OTP during active mode. In deep-sleep mode, this pin can be powered off to conserve additional current (~ 65 uA). VDD1V8_1 must be stable before performing any OTP related functions.

[5]   When LDO_ENABLE is externally tied low, the user must boot at VDDCORE = 1.0 V or higher (Low power/Normal clock mode - OTP setting - BOOT_CLK_SPEED) or VDDCORE = 1.13 V (High Speed clock - OTP setting - BOOT_CLK_SPEED). Thereafter, the VDDCORE can be adjusted to the desired level.

[6]   When LDO_ENABLE is externally tied high, the on-chip regulator to the VDDCORE Core voltage in PMC is set to the default value 1.05 V (Low power/Normal clock mode - OTP setting - BOOT_CLK_SPEED) or 1.13 V (High Speed clock - OTP setting - BOOT_CLK_SPEED). Thereafter, the POWER_SetLdoVoltageForFreq API function can be used to internally configure the on-chip regulator voltage to the VDDCORE.

[7]   When performing any OTP read/write function, the VDDCORE voltage must be set to 1.0 V or higher when LDO_ENABLE is externally tied high or low.

[8]   Low voltage operating range is for applications using the RT600 at VDDCORE voltages between 0.7 V to 0.9 V. So for example, if an application is using VDDCORE = 0.7 V and 0.9 V, max frequencies defined for the low voltage operating range must be used. Full voltage operating range is for applications using the RT600 at VDDCORE voltages between 0.7 V to 1.13 V. So for example, if an application is using VDDCORE = 0.7 V and 1.13 V, max frequencies defined for the full voltage operating range must be used. Low voltage range provides higher operating speeds when compared to full voltage operating range. After Boot-up, the application must select either low voltage range or full voltage range. An application cannot switch between low voltage range and full voltage range mode.

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13.2 Power Sequencing

Following power-on sequence should be followed when using the internal LDO in the RT600:

1. VDD_AO1V8, VDD1V8, and VDD1V8_1 pins should be powered first. There is no power sequence requirement between powering the VDD_AO1V8 and VDD1V8 pins.

2. VDDA_ADC1V8 and VREFP can be powered concurrently with VDD_AO1V8 and VDD1V8 or later.

3. VDDIO_x and VDDA_BIAS pins can be powered concurrently with VDD_AO1V8 and VDD1V8 if these pins are 1.8 V range or later if these pins are 3.3 V range. If the VDDIO_x is not powered concurrently with the VDD1V8, the delta voltage between VDDIO_x and VDD1V8 must be 1.89 V or less.

The VDDCORE pin will be supplied from the internal LDO and the LDO is powered from the VDD1V8. An external capacitor (4.7 uF) must be connected on the VDDCORE pin. There is no delay requirement on the external reset pin when using internal LDO and when the pin is tied high.

USB1_VDD3V3 can be powered at any time, independent of the other supplies.

Following power-on sequence should be followed when using an external PMIC or external IC to drive the VDDCORE pin (internal LDO is disabled, see timing diagram below):

1. VDD_AO1V8, VDD1V8, and VDD1V8_1 pins should be powered first. There is no power sequence requirement between powering the VDD_AO1V8 and VDD1V8 pins.

2. VDDA_ADC1V8 and VREFP can be powered concurrently with VDD_AO1V8 and VDD1V8 or later.

3. VDDIO_x and VDDA_BIAS pins can be powered concurrently with VDD_AO1V8 and VDD1V8 if these pins are 1.8 V range or later if these pins are 3.3 V range. If the VDDIO_x is not powered concurrently with the VDD1V8, the delta voltage between VDDIO_x and VDD1V8 must be 1.89 V or less.

4. Power up the VDDCORE. The external RESETN should be held low until VDDCORE is valid in the timing diagram.VDDCORE should not be ramped up until after all the other supplies have completed ramp up.

USB1_VDD3V3 can be powered at any time, independent of the other supplies.

Sequence of operations is handled internally so there is no specific timing requirement between the supplies. The time delays caused by any of the bypass capacitors will have no effect on the operation of the part. The internal POR detectors on VDD_AO1V8, VDD1V8 pins, and the Low Voltage Detector on VDDCORE pin, require a fall time of at least 10us (preliminary) to trigger. There is no restriction on the rise time, except for the sequencing defined above.

Table 22. Power-on characteristics

T_{amb} = -20 °C to +85 °C.

Symbol	Timing Parameter	Description	Min	Max	Unit
A	VDDIO_x valid to VDDCORE valid	The delay from when the IO pad voltages become valid to core voltage valid.	10	-	µs
B	VDDCORE valid to De-assertion of RESETN	The delay from when the VDD core is valid to when the RESETN can be released.	20	-	µs
AA	Mode pin valid	When the mode pins becomes valid. On power-on, the mode pins are reset to 00 and are controlled via a POR circuit in the always-on domain. The timing is from when the VDD_AO1V8 is valid to when the mode pins are reset to 00.	-	2	µs

Fig 9. Power-up ramp

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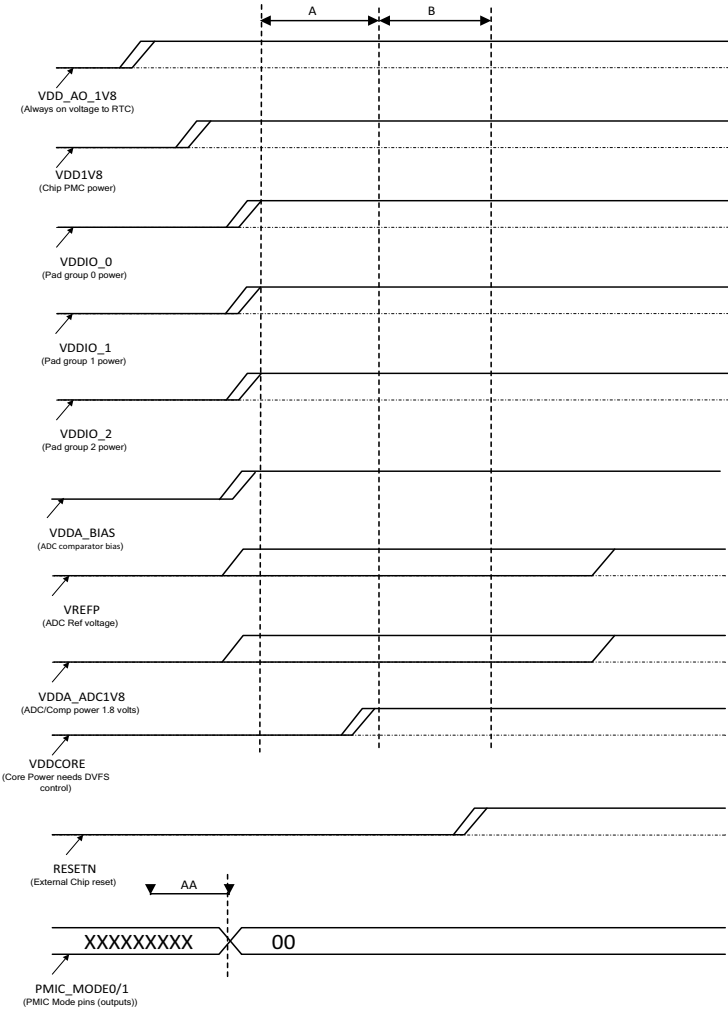
13.3 CoreMark data

Table 23. CoreMark score
$T_{amb} = 25°C$

Parameter	Conditions		Typ [3][4][5]	Unit
ARM Cortex-M33 in active mode, DSP no clock				
CoreMark score	CoreMark code executed from SRAM; CCLK = 12 MHz, VDDCORE = 0.7 V	[1][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 48 MHz, VDDCORE = 0.7 V	[1][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 60 MHz, VDDCORE = 0.7 V	[1][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 80 MHz, VDDCORE = 0.8 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 110 MHz, VDDCORE = 0.8 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 144 MHz, VDDCORE = 0.9 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 180 MHz, VDDCORE = 0.9 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 204 MHz, VDDCORE = 0.9 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 240 MHz, VDDCORE = 1.0 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 270 MHz, VDDCORE = 1.0 V	[2][6][7]	3.87	(Iterations/s) / MHz
	CCLK = 300 MHz, VDDCORE = 1.13 V	[2][6][7]	3.87	(Iterations/s) / MHz

[1] Clock source IRC. PLL disabled.

[2] Clock source external clock to XTALIN (bypass mode). PLL enabled.

[3] Characterized through bench measurements using typical samples.

[4] Compiler settings: IAR C/C++ Compiler for Arm ver 8.32.3, High, Speed, No Size Constraints.

[5] VDD_AO1V8 = VDD1V8 = VDDIO_0/1/2 = VDDA_ADC1V8 = 1.8 V. VDDA_BIAS = VREFP = 1.8 V. USB1_VDD3V3 = 3.3 V.

[6] For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency. Please see Figure 6 "RT600 clock generation".

[7] 4.5 MB SRAM enabled. All peripheral clocks disabled (set to NONE). All Array Power enabled (PDRUNCFG 1/2 registers). Only SRAM partition 12 access enabled (SYSCTL0_AHB_SRAM_ACCESS_DISABLE register). SYSCPUAHBCLKDIV = 0x0.

13.4 Power consumption

Table 24. Static characteristics: Power consumption in active mode
$T_{amb} = -20°C$ to $+85 °C$, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2][4][5]	Max	Unit
Cortex-M33 in Active mode, DSP no clock[1]							
$I_{DDVDDCORE}$	VDDCORE supply current	enhanced while (1) code executed from SRAM; Internal LDO disabled CCLK = 12 MHz, VDDCORE = 0.7 V	[3][6][7]	-	3.0	-	mA
		CCLK = 48 MHz VDDCORE = 0.7 V	[3][6][7]	-	6.0	-	mA
		CCLK = 60 MHz VDDCORE = 0.7 V	[3][6][7]	-	7.0	-	mA
		CCLK = 80 MHz VDDCORE = 0.8 V	[6][7][8]	-	10	-	mA

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Table 24. Static characteristics: Power consumption in active mode …*continued*
T_{amb} = -20°C to +85 $^\circ$C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2][4][5]	Max	Unit
		CCLK = 110 MHz VDDCORE = 0.8 V	[6][7][8]	-	13	-	mA
		CCLK = 144 MHz VDDCORE = 0.9 V	[6][7][8]	-	19	-	mA
		CCLK = 180 MHz VDDCORE = 0.9 V	[6][7][8]	-	23	-	mA
		CCLK = 204 MHz VDDCORE = 0.9 V	[6][7][8]	-	26	-	mA
		CCLK = 240 MHz VDDCORE = 1.0 V	[6][7][8]	-	34	-	mA
		CCLK = 270 MHz VDDCORE = 1.0 V	[6][7][8]	-	38	-	mA
		CCLK = 300 MHz VDDCORE = 1.13 V	[6][7][8]	-	50	-	mA

[1] Based on the power API library from the SDK software package available on nxp.com.

[2] Typical ratings are not guaranteed. Typical values listed are at room temperature (25 °C). VDD_AO1V8 = VDD1V8 = VDDIO_0/1/2 = VDDA_ADC1V8 = 1.8 V. VDDA_BIAS = VREFP = 1.8 V. USB1_VDD3V3 = 3.3 V

[3] Clock source IRC. PLL disabled.

[4] Characterized through bench measurements using typical samples.

[5] Compiler settings: Keil Compiler for Arm ver 5.28, optimization level 3

[6] For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency. Please see Figure 6 "RT600 clock generation".

[7] 4.5 MB SRAM enabled. All peripheral clocks disabled (set to NONE). All Array Power enabled (PDRUNCFG 1/2 registers). Only SRAM partition 12 access enabled (SYSCTL0_AHB_SRAM_ACCESS_DISABLE register). SYSCPUAHBCLKDIV = 0x0.

[8] Clock source external clock to XTALIN (bypass mode). PLL enabled.

Table 25. Static characteristics: Power consumption in active mode
T_{amb} = -20°C to +85°C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2][4][5]	Max	Unit
Cortex-M33 in Active mode, DSP no clock[1]							
I$_{DDVDDCORE}$	VDDCORE supply current	Coremark code executed from SRAM; Internal LDO disabled CCLK = 12 MHz, VDDCORE = 0.7 V	[3][6][7]	-	3	-	mA
		CCLK = 48 MHz VDDCORE = 0.7 V	[3][6][7]	-	6	-	mA
		CCLK = 60 MHz VDDCORE = 0.7 V	[3][6][7]	-	7	-	mA
		CCLK = 80 MHz VDDCORE = 0.8V	[6][7][8]	-	11	-	mA

Table 25. Static characteristics: Power consumption in active mode …*continued*
T_{amb} = -20˚C to +85˚C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2][4][5]	Max	Unit
		CCLK = 110 MHz VDDCORE = 0.8 V	[6][7][8]	-	14	-	mA
		CCLK = 144 MHz VDDCORE = 0.9 V	[6][7][8]	-	20	-	mA
		CCLK = 180 MHz VDDCORE = 0.9 V	[6][7][8]	-	25	-	mA
		CCLK = 204 MHz VDDCORE = 0.9 V	[6][7][8]	-	28	-	mA
		CCLK = 240 MHz VDDCORE = 1.0 V	[6][7][8]	-	36	-	mA
		CCLK = 270 MHz VDDCORE = 1.0 V	[6][7][8]	-	40	-	mA
		CCLK = 300 MHz VDDCORE = 1.13 V	[6][7][8]	-	51	-	mA

[1] Based on the power API library from the SDK software package available on nxp.com.

[2] Typical ratings are not guaranteed. Typical values listed are at room temperature (25 °C). VDD_AO1V8 = VDD1V8 = VDDIO_0/1/2 = VDDA_ADC1V8 = 1.8 V. VDDA_BIAS = VREFP = 1.8 V. USB1_VDD3V3 = 3.3 V

[3] Clock source IRC. PLL disabled.

[4] Characterized through bench measurements using typical samples.

[5] Compiler settings: IAR C/C++ Compiler for Arm ver 8.32.3, High, Speed, No Size Constraints

[6] For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency. Please see Figure 6 "RT600 clock generation".

[7] 4.5 MB SRAM enabled. All peripheral clocks disabled (set to NONE). All Array Power enabled (PDRUNCFG 1/2 registers). Only SRAM partition 12 access enabled (SYSCTL0_AHB_SRAM_ACCESS_DISABLE register). SYSCPUAHBCLKDIV = 0x0.

[8] Clock source external clock to XTALIN (bypass mode). PLL enabled.

Table 26. Static characteristics: Power consumption in active mode
T_{amb} = -20˚C to +85 ˚C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2][4][5]	Max	Unit
DSP in Active mode, M33 in WFI[1]							
I_{DDVDDCORE}	VDDCORE supply current	FFT code executed from SRAM partition 12; Internal LDO disabled CCLK = 12 MHz, VDDCORE = 0.7 V	[3][6][7]	-	4.6	-	mA
		CCLK = 48 MHz VDDCORE = 0.7 V	[3][6][7]	-	11	-	mA
		CCLK = 60 MHz VDDCORE = 0.7 V	[3][6][7]	-	14	-	mA
		CCLK = 80 MHz VDDCORE = 0.8 V	[6][7][8]	-	20	-	mA

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Table 26. Static characteristics: Power consumption in active mode *…continued*
T_{amb} = -20˚C to +85 ˚C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2][4][5]	Max	Unit
		CCLK = 110 MHz VDDCORE = 0.8 V	[6][7][8]	-	27	-	mA
		CCLK = 144 MHz VDDCORE = 0.8 V	[6][7][8]	-	34	-	mA
		CCLK = 180 MHz VDDCORE = 0.8 V	[6][7][8]	-	42	-	mA
		CCLK = 204 MHz VDDCORE = 0.8 V	[6][7][8]	-	47	-	mA
		CCLK = 240 MHz VDDCORE = 0.9 V	[6][7][8]	-	63	-	mA
		CCLK = 270 MHz VDDCORE = 0.9 V	[6][7][8]	-	71	-	mA
		CCLK = 300 MHz VDDCORE = 0.9 V	[6][7][8]	-	78	-	mA
		CCLK = 400 MHz VDDCORE = 1.0 V	[6][7][8]	-	117	-	mA
		CCLK = 600 MHz VDDCORE = 1.13 V	[6][7][8]	-	207	-	mA

[1] Based on the power API library from the SDK software package available on nxp.com.

[2] Typical ratings are not guaranteed. Typical values listed are at room temperature (25 °C). VDD_AO1V8 = VDD1V8 = VDDIO_0/1/2 = VDDA_ADC1V8 = 1.8 V. VDDA_BIAS = VREFP = 1.8 V. USB1_VDD3V3 = 3.3 V

[3] Clock source IRC. PLL disabled.

[4] Characterized through bench measurements using typical samples.

[5] Compiler settings: Keil Compiler for Arm ver 5.28, optimization level 3

[6] For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency. Please see Figure 6 "RT600 clock generation".

[7] 4.5 MB SRAM enabled. All peripheral clocks disabled (set to NONE). All Array Power enabled (PDRUNCFG 1/2 registers). Only SRAM partition 12 access enabled (SYSCTL0_AHB_SRAM_ACCESS_DISABLE register). SYSCPUAHBCLKDIV = 0x0.

[8] Clock source external clock to XTALIN (bypass mode). PLL enabled.

Table 27. Static characteristics: Power consumption in sleep mode
T_{amb} = -20 ˚C to +85 ˚C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[2]	Max	Unit
Cortex-M33 in Sleep mode, DSP no clock							
IDDVDDCORE	VDDCORE supply current	CCLK = 12 MHz VDDCORE = 0.7 V	[1][2][3][4][5][6]	-	3	-	mA
		CCLK = 48 MHz VDDCORE = 0.7 V	[1][2][3][4][5][6]	-	4	-	mA
		CCLK = 250 MHz VDDCORE = 1.0 V	[1][2][3][4][5][7]	-	20.3	-	mA

[1] Based on the power API library from the SDK software package available on nxp.com.

[2] Typical ratings are not guaranteed. Typical values listed are at room temperature (25 °C). VDD_AO1V8 = VDD1V8 = VDDIO_0/1/2 = VDDA_ADC1V8 = 1.8 V. VDDA_ADC3V3 = VREFP = USB1_VDD3V3 = 3.3 V

[3] Clock source IRC. PLL disabled.

[4] Characterized through bench measurements using typical samples.

[5] Compiler settings: IAR C/C++ Compiler for Arm ver 8.32.3, optimization level 0, optimized for time off.

[6] All peripheral clocks disabled.

[7] Clock source IRC. PLL enabled.

Table 28.   Static characteristics: Power consumption in deep-sleep mode[4]
T_{amb} = -20 °C to +85°C, unless otherwise specified,

Symbol	Parameter	Conditions		Min	Typ[1][2]	Max[3]	Unit
I_{VDD1V8}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	109	-	μA
I_{VDD1V8_1}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	65	-	μA
$I_{VDDCORE}$	supply current	Deep-sleep mode; SRAM (32 KB) powered, Internal LDO disabled. Array On, Periphery Off T_{amb} = 25 °C		-	75	-	μA
$I_{VDDCORE}$	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO disabled. Array On, Periphery Off T_{amb} = 25 °C		-	77	-	μA
$I_{VDDCORE}$	supply current	Deep-sleep mode; SRAM (4.5 MB) powered, Internal LDO disabled. Array On, Periphery Off T_{amb} = 25 °C		-	190	-	μA
I_{VDD_AO1V8}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	0.6	-	μA
I_{VDDIO_0}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	7.0	-	μA
I_{VDDIO_1}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	0.9	-	μA
I_{VDDIO_2}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	6.4	-	μA
I_{VDDA_ADC1V8}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	0.1	-	μA
I_{VDDA_BIAS}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	0.1	-	μA
I_{VREFP}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	0.1	-	μA
I_{USB1_VDD3V3}	supply current	Deep-sleep mode; SRAM (128 KB) powered, Internal LDO enabled. Array On, Periphery Off		-	0.1	-	μA

[1] Typical ratings are not guaranteed. Typical values listed are at room temperature (25 °C), All power supplies to = 1.8 V except USB1_VDD3V3 = 3.3 v

[2] Characterized through bench measurements using typical samples.

[3] Guaranteed by characterization, not tested in production.

[4] In deep-sleep mode, the VDDCORE voltage is set to 0.7V.

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Table 29. Static characteristics: Power consumption in deep power-down mode and full deep power-down modes
T_{amb} = -20 °C to +85 °C, unless otherwise specified,

Symbol	Parameter	Conditions		Min	Typ[1][2]	Max[3]	Unit
I_{VDD1V8}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	16	-	μA
I_{VDD_AO1V8}	supply current	Full Deep power-down mode; Internal LDO disabled. RTC Off T_{amb} = 25 °C		-	0.6	-	μA
I_{VDDIO_0}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	47	-	μA
I_{VDDIO_1}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	0.9	-	μA
I_{VDDIO_2}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	47	-	μA
I_{VDDA_ADC1V8}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	0.1	-	μA
I_{VDDA_BIAS}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	0.1	-	μA
I_{VREFP}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	0.1	-	μA
I_{USB1_VDD3V3}	supply current	Deep power-down mode; Internal LDO disabled. RTC Off		-	0.1	-	μA

[1] Typical ratings are not guaranteed. Typical values listed are at room temperature (25 °C), All power supplies to = 1.8 V except USB1_VDD3V3 = 3.3 v

[2] Characterized through bench measurements using typical samples.

[3] Guaranteed by characterization, not tested in production.

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13.5 Pin characteristics

Table 30. Static characteristics: pin characteristics

T_{amb} = -20 °C to +85 °C, unless otherwise specified. Values tested in production unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
RESET pin, LDO_ENABLE pin, PMIC_IRQ_N pin, PMIC_MODE pins[5]							
V_{IH}	HIGH-level input voltage			0.7 x VDD_AO1V8	-	VDD_AO1V8	V
V_{IL}	LOW-level input voltage			-0.3	-	0.3 x VDD_AO1V8	V
V_{OH}	HIGH-level output voltage	I_{OH} = −2.9 mA; 1.71 V ≤ VDD_AO1V8 < 1.89 V		0.8 x VDD_AO1V8	-	-	V
V_{OL}	HIGH-level output voltage	I_{OL} = 2.9 mA; 1.71 V ≤ VDD_AO1V8 < 1.89 V		-	-	0.2 x VDD_AO1V8	V
V_{hys}	hysteresis voltage		[4]	-	0.06 x VDD_AO1V8	-	V
Standard I/O pins and PMIC I2C pins							
Input characteristics							
I_{IL}	LOW-level input current	V_I = 0 V; on-chip pull-up resistor disabled. 1.71 V ≤ V_{DDIO} < 1.98 V		-1.0		1.0	µA
		V_I = 0 V; on-chip pull-up resistor disabled. 3.0 V ≤ V_{DDIO} < 3.6 V		-1.0		1.0	µA
I_{IH}	HIGH-level input current	V_I = VDDIO; on-chip pull-down resistor disabled. 1.71 V ≤ V_{DDIO} < 1.98 V		-1.0	0.5	1.0	µA
		V_I = VDDIO; on-chip pull-down resistor disabled. 3.0 V ≤ V_{DDIO} < 3.6 V		-1.0	0.5	1.0	µA
V_I	input voltage	pin configured to provide a digital function except following pins V_{DDIO} = 0 V	[3]				
				0	-	3.6	V
V_{IH}	HIGH-level input voltage	1.71 V ≤ V_{DDIO} < 1.98 V		0.7 × V_{DDIO}	-	V_{DDIO}	V
		3.0 V ≤ V_{DDIO} ≤ 3.6 V		0.7 × V_{DDIO}	-	V_{DDIO}	V
V_{IL}	LOW-level input voltage	1.71 V ≤ V_{DDIO} < 1.98 V		−0.3	-	0.3 × V_{DDIO}	V
		3.0 V ≤ V_{DDIO} ≤ 3.6 V		−0.3	-	+0.7	V
V_{hys}	hysteresis voltage	1.71 V ≤ VDDIO < 1.98 V	[4]	0.15	-	-	V
		3.0 V ≤ V_{DDIO} ≤ 3.6 V	[4]	0.15	-	-	V
Output characteristics							
V_{OH}	HIGH-level output voltage (Normal Drive)	I_{OH} = −2.9 mA; 1.71 V ≤ V_{DDIO} < 1.98 V		0.8 × V_{DDIO}	-	-	V
		I_{OH} = −4 mA; 3.0 V ≤ V_{DDIO} ≤ 3.6 V		0.8 × V_{DDIO}	-	-	V
V_{OH}	HIGH-level output voltage (Full Drive)	I_{OH} = −5.8 mA; 1.71 V ≤ V_{DDIO} < 1.98 V		0.8 × V_{DDIO}	-	-	V
		I_{OH} = −8 mA; 3.0 V ≤ V_{DDIO} ≤ 3.6 V		0.8 × V_{DDIO}	-	-	V

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Table 30.   Static characteristics: pin characteristics …*continued*

T_{amb} = -20 ˚C to +85 ˚C, unless otherwise specified. Values tested in production unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
V_{OL}	LOW-level output voltage (Normal Drive)	I_{OL} = 2.9 mA; 1.71 V $\leq$ V_{DDIO} < 1.98 V		-	-	0.2 × V_{DDIO}	V
		I_{OL} = 4 mA; 3.0 V $\leq$ V_{DDIO} $\leq$ 3.6 V		-	-	0.2 × V_{DDIO}	V
V_{OL}	LOW-level output voltage (Full Drive)	I_{OL} = 5.8 mA; 1.71 V $\leq$ V_{DDIO} < 1.98 V		-	-	0.2 × V_{DDIO}	V
		I_{OL} = 8 mA; 3.0 V $\leq$ V_{DDIO} $\leq$ 3.6 V		-	-	0.2 × V_{DDIO}	V
Weak input pull-up/pull-down characteristics							
I_{pd}	pull-down current	V_I = V_{DDIO}		34	-	180	μA
		V_I = 3.6 V	[2]	72	-	180	μA
I_{pu}	pull-up current	V_I = 0 V		-34	-	-180	μA
R_{pd}	pull-down resistance			20	-	50	kΩ
R_{pu}	pull-up resistance			20	-	50	kΩ
Fall Time							
t_f	fall time	15 pF load	[6]	-	-	6	ns

[1] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltage.

[2] Based on characterization. Not tested in production.

[3] All GPIO pins are fail safe up to 3.6 V when VDDIO supply = 0 V except following pins (PIO1_19 to PIO1_31, PIO2_0 to PIO2_8, PIO0_21, PIO0_22, PIO_23 pins).

[4] Guaranteed by design, not tested in production.

[5] PMIC mode pins are dedicated outputs. They are hard wired to normal drive, no input buffer, no pull ups or pull downs, and no slew rate control.

[6] Based on simulation, not tested in production.

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14. Dynamic characteristics

14.1 Wake-up process

Table 31.   Dynamic characteristic: Typical wake-up times from low power modes
T_{amb} = 25 $°$C; using IRC as the system clock.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
t_{wake}	wake-up time	from sleep mode, 250 MHz	[2][3]	-	1.5	-	µs
		from sleep mode, 12 MHz	[2][3]	-	6.2	-	µs
t_{wake}	wake-up time	from deep-sleep mode	[2][3]	-	637	-	µs
t_{wake}	wake-up time	from deep power-down mode using RESETN.	[4]	-	5.6	-	ms
		from deep power-down mode using PMIC_IRQ_N.	[4]	-	7	-	ms
t_{wake}	wake-up time	from full deep power-down mode using RESETN.	[4]	-	5.6	-	ms
		from full deep power-down mode using PMIC_IRQ_N.	[4]	-	7.6	-	ms

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply
       voltages.

[2]   The wake-up time measured is the time between when a GPIO input pin is triggered to wake the device up
       from the low power modes and from when a GPIO output pin is set in the interrupt service routine (ISR)
       wake-up handler.

[3]   IRC disabled, all peripherals off. PLL disabled.

[4]   Wake up from deep power-down causes the part to go through entire reset process. The wake-up time
       measured is the time between when the Wake-Up pin is triggered to wake the device up and when a GPIO
       output pin is set in the reset handler.

14.2 IRC (48 MHz/60 MHz and 16 MHz)

The 48 MHz/60 MHz IRC is trimmed to +/- 1% accuracy over the entire voltage and 0 C to
70 C temperature range.

The 48 MHz/60 MHz IRC is trimmed to +1.5% and - 1% accuracy over the entire voltage
and -20 C to 70 C temperature range.

The 48 MHz/60 MHz IRC is trimmed to +/- 1.5% over the entire voltage and -20 C to 85 C
temperature range.

The 16 MHz IRC is trimmed to ±3% accuracy over the entire voltage and temperature
range.

Table 32.   Dynamic characteristic: IRC
T_{amb} = 0 $°$C to +70 $°$C; 1.71 V to 3.6 V.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
$f_{osc(RC)}$	IRC clock frequency	-	15.52	16	16.48	MHz
$f_{osc(RC)}$	IRC clock frequency	-	47.52	48	48.48	MHz
$f_{osc(RC)}$	IRC clock frequency	-	59.4	60	60.6	MHz

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply
       voltages.

Table 33.   Dynamic characteristic: IRC

T_{amb} = -20 ℃ to +70 ℃; 1.71 V to 3.6 V.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
$f_{osc(RC)}$	IRC clock frequency	-	15.52	16	16.48	MHz
$f_{osc(RC)}$	IRC clock frequency	-	47.52	48	48.72	MHz
$f_{osc(RC)}$	IRC clock frequency	-	59.4	60	60.90	MHz

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply
       voltages.

Table 34.   Dynamic characteristic: IRC

T_{amb} = -20 C to +85 C; 1.71 V to 3.6 V.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
$f_{osc(RC)}$	IRC clock frequency	-	15.52	16	16.48	MHz
$f_{osc(RC)}$	IRC clock frequency	-	47.28	48	48.72	MHz
$f_{osc(RC)}$	IRC clock frequency	-	59.10	60	60.90	MHz

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply
       voltages.

14.3 Internal Low Power Oscillator (1 MHz)

The IRC is trimmed to ±10% accuracy over the entire voltage and temperature range.

Table 35.   Dynamic characteristic: LPCOSC

T_{amb} = -20 ℃ to +85 ℃; 1.71 V to 3.6 V.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
$f_{osc(RC)}$	LPOSC clock frequency	-	0.9	1	1.1	MHz

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply
       voltages.

14.4 Crystal oscillator

Table 36.   Dynamic characteristic: oscillator

T_{amb} = -20 ℃ to +85℃; 1.71 V to 3.6 V. [1][3]

Symbol	Parameter	Conditions		Min	Typ[2]	Max	Unit
f_{range}	oscillator frequency range			4	-	32	MHz
R_F	feedback resistor - high gain mode only			-	1	-	MΩ
ESR	Equivalent series resistance	-		-	-	80	Ω

[1]   Parameters are valid over operating temperature range unless otherwise specified.

[2]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply
       voltages.

[3]   See Section 16.5

[4]   Select Low power mode = 1 in the CLKCTL0_SYSOSCCTL0 register.

[5]   Select High Gain Mode = 0 in the CLKCTL0_SYSOSCCTL0 register.

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14.5 RTC oscillator

See Section 16.4 "RTC oscillator" for connecting the RTC oscillator to an external clock source.

Table 37.   Dynamic characteristic: RTC oscillator
T_{amb} = -20 ℃ to +85℃; 1.71 V to 3.6 V [1][2]

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
f_i	input frequency	-		-	32.768	-	kHz
ESR	Equivalent series resistance	-		-	50	100	kΩ

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

[2]   See Section 16.4

14.6 External Clock Input (CLKIN pin, MCLK pin)

Table 38.   Dynamic characteristic: CLKIN, MCLK pin
T_{amb} = -20℃ to +85℃; 1.71 V to 3.6 V. [1]

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
f_i	CLKIN frequency	-		-	-	50	MHz
f_i	MCLK frequency	-		-	-	25	MHz

[1]   Typical ratings are not guaranteed. The values listed are at room temperature (25°C), nominal supply voltages.

14.7 Main/System and Audio PLLs

Table 39.   Main/System and Audio PLLs electrical parameters

Parameter	Min	Typ	Max	Unit
Input reference frequency	5	-	26	MHz
PLL output frequency	80	-	572	MHz
Lock time	-	-	150	µs
Period jitter (p2p)	-	50	-	ps
PFD period jitter	-	100	-	ps
Duty cycle	45	-	55	%

14.8 I2C-bus

Table 40. Dynamic characteristic: I2C-bus pins[1]

T_{amb} = 0 °C to +85 °C; 1.71 V to 3.6 V.[2]

Symbol	Parameter		Conditions	Min	Max	Unit
f_{SCL}	SCL clock frequency		Standard-mode	0	100	kHz
			Fast-mode	0	400	kHz
			Fast-mode Plus	0	1	MHz
t_{LOW}	LOW period of the SCL clock	[8]	Standard-mode	4.7	-	μs
			Fast-mode	1.3	-	μs
			Fast-mode Plus	0.5	-	μs
t_{HIGH}	HIGH period of the SCL clock	[8]	Standard-mode	4.0	-	μs
			Fast-mode	0.6	-	μs
			Fast-mode Plus	0.26	-	μs
$t_{HD;DAT}$	data hold time	[3][4][5]	Standard-mode	0	-	μs
			Fast-mode	0	-	μs
			Fast-mode Plus	0	-	μs
$t_{SU;DAT}$	data set-up time	[6][7]	Standard-mode	250	-	ns
			Fast-mode	100	-	ns
			Fast-mode Plus	50	-	ns

[1] Guaranteed by design. Not tested in production.

[2] Parameters are valid over operating temperature range unless otherwise specified. See the I2C-bus specification *UM10204* for details.

[3] tHD;DAT is the data hold time that is measured from the falling edge of SCL; applies to data in transmission and the acknowledge.

[4] A device must internally provide a hold time of at least 300 ns for the SDA signal (with respect to the V_{IH}(min) of the SCL signal) to bridge the undefined region of the falling edge of SCL.

[5] The maximum $t_{HD;DAT}$ could be 3.45 μs and 0.9 μs for Standard-mode and Fast-mode but must be less than the maximum of $t_{VD;DAT}$ or $t_{VD;ACK}$ by a transition time. This maximum must only be met if the device does not stretch the LOW period (t_{LOW}) of the SCL signal. If the clock stretches the SCL, the data must be valid by the set-up time before it releases the clock.

[6] tSU;DAT is the data set-up time that is measured with respect to the rising edge of SCL; applies to data in transmission and the acknowledge.

[7] A Fast-mode I2C-bus device can be used in a Standard-mode I2C-bus system but the requirement $t_{SU;DAT}$ = 250 ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line $t_{r(max)}$ + $t_{SU;DAT}$ = 1000 + 250 = 1250 ns (according to the Standard-mode I2C-bus specification) before the SCL line is released. Also the acknowledge timing must meet this set-up time.

[8] The MSTTIME register allows programming of certain times for the clock (SCL) high and low times. Please see RT600 user manual UM11147 for further details.

[9] Fall-time spec can be found in Table 30 "Static characteristics: pin characteristics".
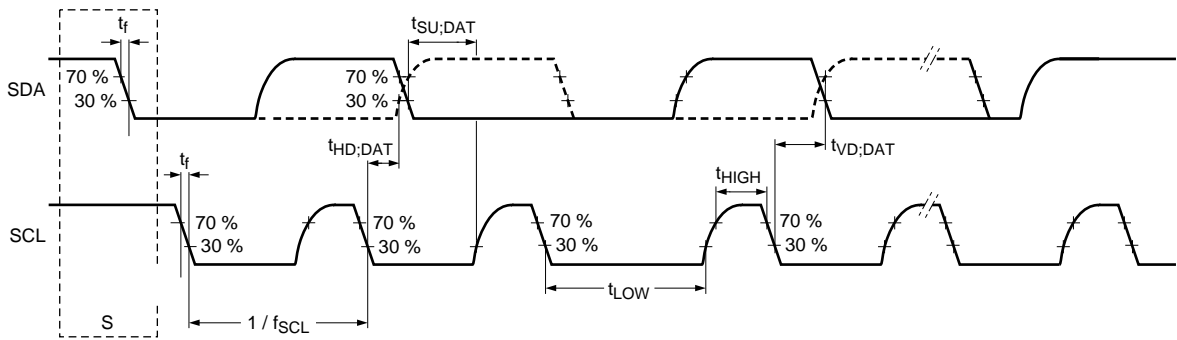
Fig 10. I2C-bus pins clock timing[9]

14.9 I^{2}S-bus interface

Excluding delays introduced by external device and PCB, the maximum supported bit rate for I^{2}S master mode (transmit/receive) is 20 Mbit/s and the maximum supported bit rate for I^{2}S slave mode (transmit/receive) is 20 Mbit/s.

Table 41.   Dynamic characteristics: I^{2}S-bus interface pins [1][3]

T_{amb} = 0 °C to 85 °C; VDDIO_x = 1.71 V to 3.6 V.; VDDCORE = 1.13 V; CL = 10 pF balanced loading on all pins; Input slew = 1.0 ns, Full Output Drive mode for all pins, SLEW setting = standard mode for all pins; Parameters sampled at the 50% level of the rising or falling edge.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
Common to master and slave							
t_{WH}	pulse width HIGH	on pins I2Sx_TX_SCK and I2Sx_RX_SCK					
				45%	-	55%	TCLK Period
t_{WL}	pulse width LOW	on pins I2Sx_TX_SCK and I2Sx_RX_SCK					
				45%	-	55%	TCLK Period
Master							
$t_{v(Q)}$	data output valid time	on pin I2Sx_TX_SDA	[2]				
				0	-	20	ns
		on pin I2Sx_WS					
				0	-	20	ns
$t_{su(D)}$	data input set-up time	on pin I2Sx_RX_SDA	[2]	8	-	-	ns
$t_{h(D)}$	data input hold time	on pin I2Sx_RX_SDA	[2]	0	-	-	ns
Slave							
$t_{v(Q)}$	data output valid time	on pin I2Sx_TX_SDA	[2]	0	-	20	ns
$t_{su(D)}$	data input set-up time	on pin I2Sx_RX_SDA	[2]				
				8	-	-	ns
		on pin I2Sx_WS					
				8	-	-	ns
$t_{h(D)}$	data input hold time	on pin I2Sx_RX_SDA	[2]				
				0	-	-	ns
		on pin I2Sx_WS					
				0	-	-	ns

[1]   Based on simulation; not tested in production.

[2]   Clock Divider register (DIV) = 0x0.

[3]   The Flexcomm Interface function clock frequency should not be above 140 MHz. See the data rates section in the I^{2}S chapter (UM11147) to calculate clock and sample rates.

Fig 11. I²S-bus timing (master)

Fig 12. I²S-bus timing (slave)

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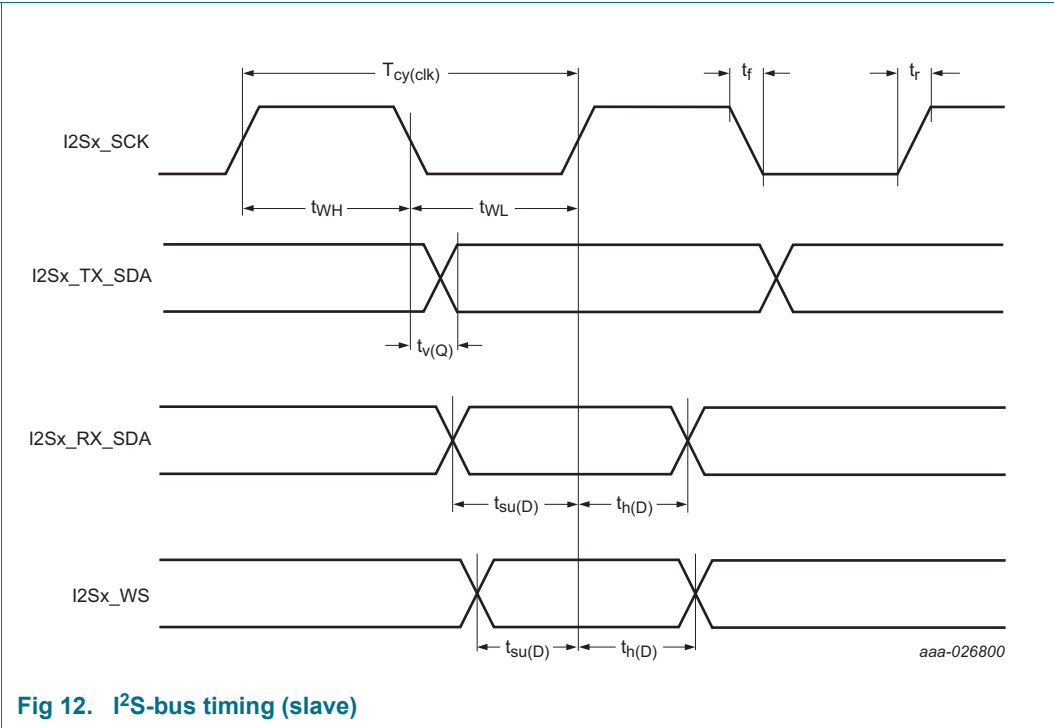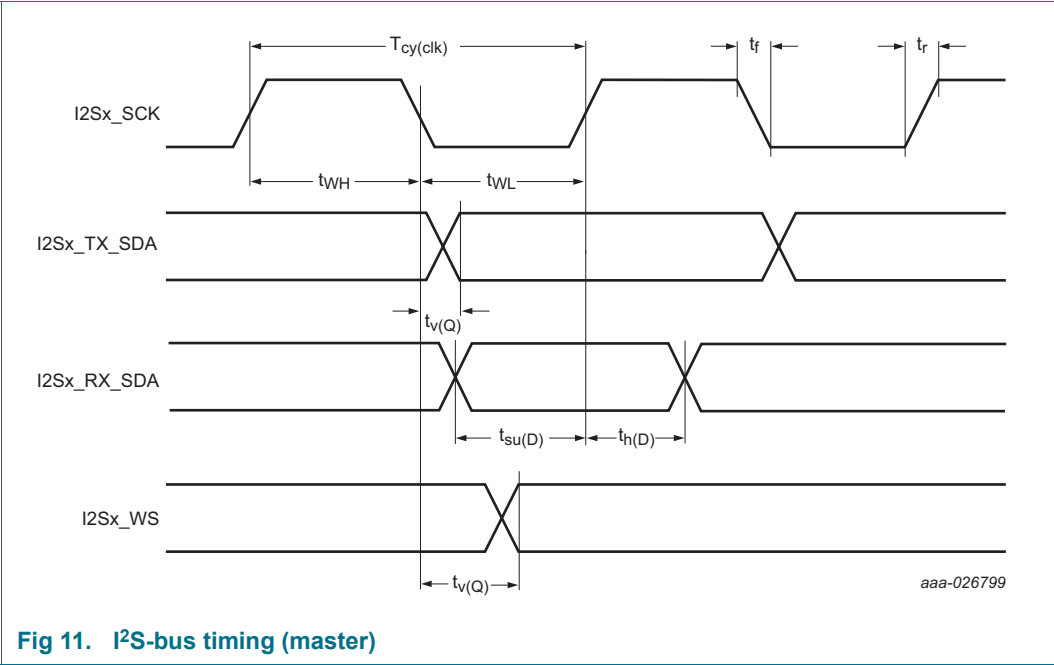
14.10 USART interface

Excluding delays introduced by external device and PCB, the maximum supported bit rate for USART master synchronous mode is 20 Mbit/s, and the maximum supported bit rate for USART slave synchronous mode is 20.0 Mbit/s.

Excluding delays introduced by external device and PCB, the maximum bit rates of 6.25 Mbit/s in asynchronous mode.

The actual USART bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading.

Table 42.   USART dynamic characteristics[1]
T_{amb} = 0 $^{\circ}$C to 85°C; VDDIO_x = 1.71 V to 3.6 V; C_L = 10, VDDCORE = 1.13 V pF balanced loading on all pins; Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins; Parameters sampled at the 50 % level of the rising or falling edge.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
USART master (in synchronous mode)						
$t_{su(D)}$	data input set-up time		12.0	-	-	ns
$t_{h(D)}$	data input hold time		12.0	-	-	ns
$t_{v(Q)}$	data output valid time		-5.0	-	10.0	ns
USART slave (in synchronous mode)						
$t_{su(D)}$	data input set-up time		8.0	-	-	ns
$t_{h(D)}$	data input hold time		0	-	-	ns
$t_{v(Q)}$	data output valid time		0	-	20.0	ns

[1]   Based on simulation; not tested in production.
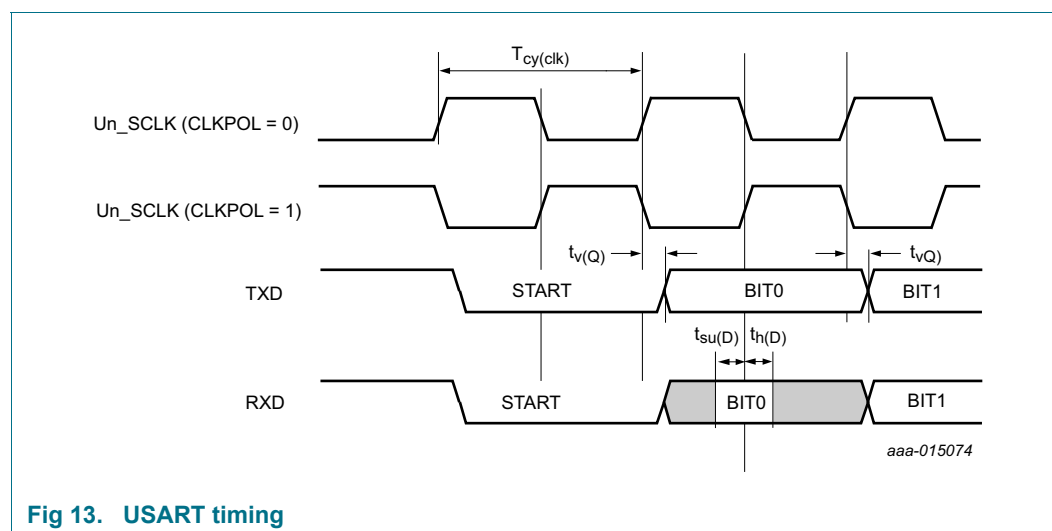
Fig 13.   USART timing

14.11 SPI interfaces (Flexcomm Interfaces 0-7)

The actual SPI bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading.

Excluding delays introduced by external device and PCB, the maximum supported bit rate for SPI master mode (transmit/receive) is 25 Mbit/s and the maximum supported bit rate for SPI slave mode (transmit/receive) is 25 Mbit/s.

Table 43.   SPI dynamic characteristics[1]
T_{amb} = 0 $°C$ to 85$°C$;VDDIO_x = 1.71 V to 3.6 V; C_L = 10 pF balanced loading on all pins; Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising or falling edge.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
SPI master						
t_{DS}	data set-up time		5	-	-	ns
t_{DH}	data hold time		0	-	-	ns
$t_{v(Q)}$	data output valid time		0	-	13	ns
SPI slave						
t_{DS}	data set-up time		5	-	-	ns
t_{DH}	data hold time		0	-	-	ns
$t_{v(Q)}$	data output valid time		0	-	13	ns

[1]   Based on simulation; not tested in production.

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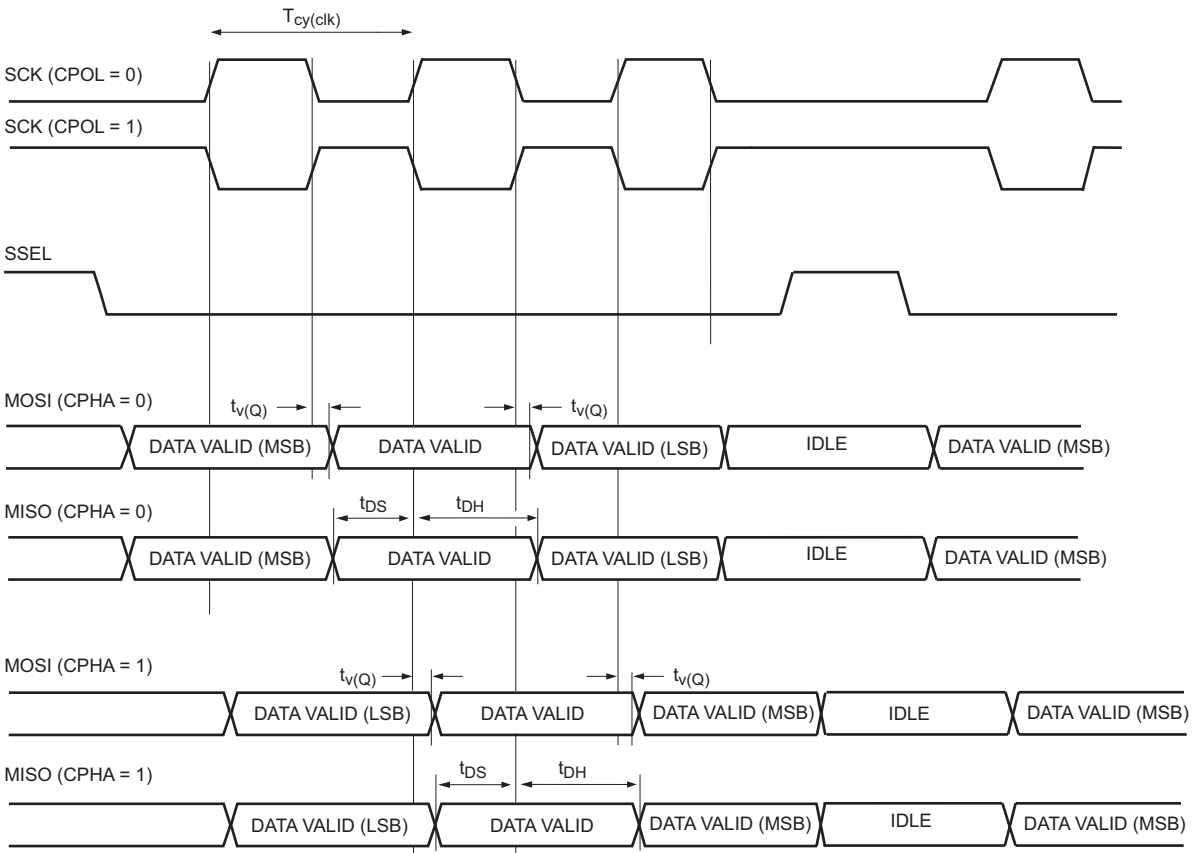
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Fig 14.   SPI master timing

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Fig 15. SPI slave timing

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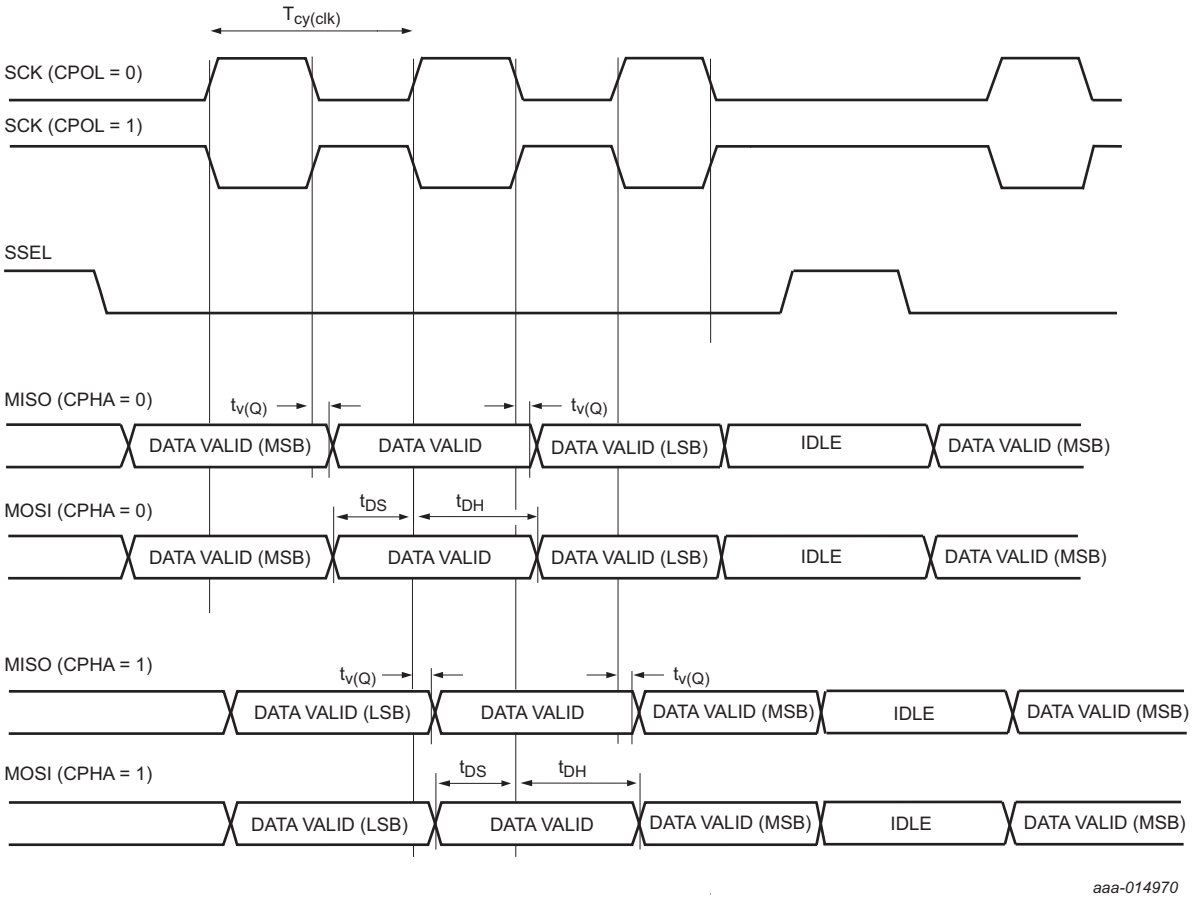
14.12 High Speed SPI Interface (Flexcomm Interface 14)

The actual SPI bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading. Excluding delays introduced by external device and PCB, the maximum supported bit rate for SPI master mode (transmit/receive) is 50 Mbit/s.

Excluding delays introduced by external device and PCB, the maximum supported bit rate for SPI slave mode (receive) is 50Mbit/s and for SPI slave mode (transmit) is 35 Mbit/s.

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Table 44. High -Speed SPI dynamic characteristics[1]

T_{amb} = -0 °C to 85°C;VDDIO_x = 1.71 V to 3.6 V; C_L = 10 pF balanced loading on all pins; Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising or falling edge.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
High-Speed SPI master						
t_{DS}	data set-up time		4.0	-	-	ns
t_{DH}	data hold time		0	-	-	ns
$t_{v(Q)}$	data output valid time		0	-	6	ns
High-Speed SPI slave						
t_{DS}	data set-up time		3.0	-	-	ns
t_{DH}	data hold time		0	-	-	ns
$t_{v(Q)}$	data output valid time		0	-	10	ns

[1] Based on simulation; not tested in production.

Fig 16. SPI master timing

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Fig 17. SPI slave timing

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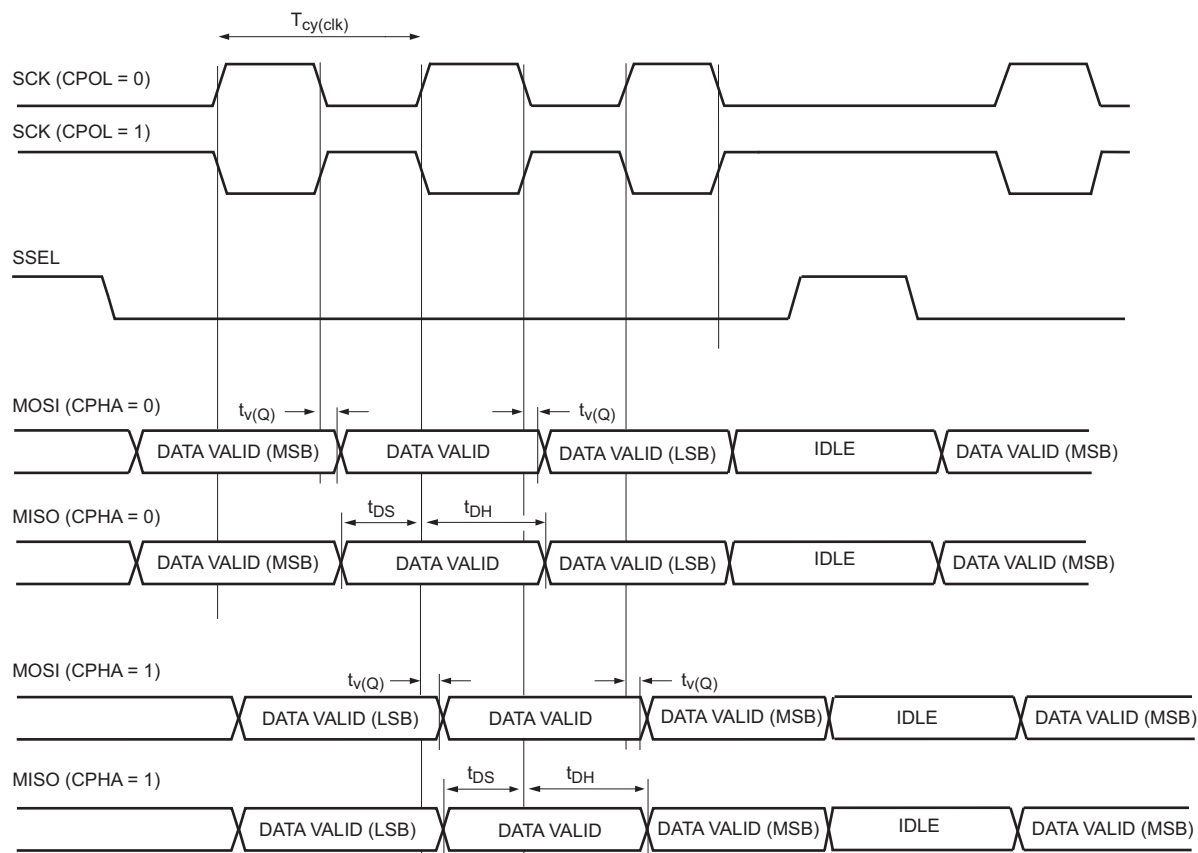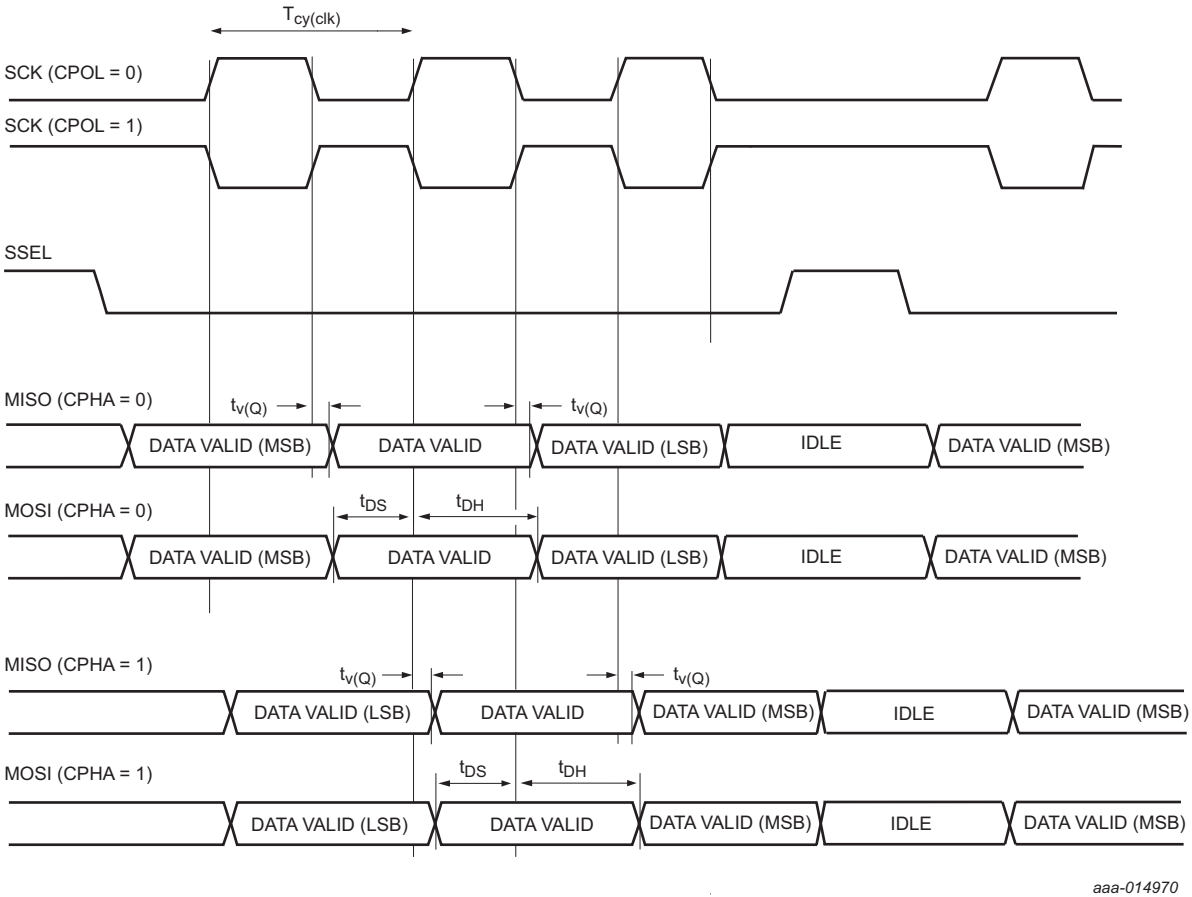
14.13 FlexSPI flash interface

Table 45. Dynamic characteristics: FlexSPI flash interface [1]

T_{amb} = 0 $^{\circ}$C to +85 $^{\circ}$C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF balanced loading on all pins; Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins; Parameters sampled at the 50 % level of the rising or falling edge.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
SDR Mode (FlexSPI A Interface)						
f_{clk}	clock frequency	Transmit	-	-	200	MHz
	clock frequency	RX clock source = 0	-	-	60	MHz
	clock frequency	RX clock source = 1	-	-	116	MHz
	clock frequency	RX clock source = 3	-	-	200	MHz
t_{DS}	data set-up time	RX clock source = 0 (internal dummy read strobe and loopbacked internally)	6	-	-	ns
		RX clock source = 1 (internal dummy read strobe and loopbacked from DQS pad)	1			
		source = 3 (external DQS, Flash provides read strobe)	1			
t_{DH}	data hold time	RX clock source = 0 (internal dummy read strobe and loopbacked internally)	1	-	-	ns
		RX clock source = 1 (internal dummy read strobe and loopbacked from DQS pad)	0			
		source = 3 (external DQS, Flash provides read strobe)	0			
$t_{v(Q)}$	data output valid time		0	-	3	ns
SDR Mode (FlexSPI B Interface)						
f_{clk}	clock frequency	Transmit	-	-	60	MHz
	clock frequency	RX clock source = 0	-	-	60	MHz
	clock frequency	RX clock source = 1	-	-	60	MHz
t_{DS}	data set-up time	RX clock source = 0 (internal dummy read strobe and loopbacked internally)	6	-	-	ns
		RX clock source = 1 (internal dummy read strobe and loopbacked from DQS pad)	1			
t_{DH}	data hold time	RX clock source = 0 (internal dummy read strobe and loopbacked internally)	1	-	-	ns
		RX clock source = 1 (internal dummy read strobe and loopbacked from DQS pad)	0			
$t_{v(Q)}$	data output valid time		0	-	3	ns
DDR Mode (with and without DQS) (FlexSPI A Interface) [2]						
f_{clk}	clock frequency	Transmit	-	-	200	MHz
	clock frequency	RX clock source = 0	-	-	30	MHz

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Table 45.   Dynamic characteristics: FlexSPI flash interface [1]

T$_{amb}$ = 0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C$_L$ = 10 pF balanced loading on all pins; Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins; Parameters sampled at the 50 % level of the rising or falling edge.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
	clock frequency	RX clock source = 1	-	-	58	MHz
	clock frequency	RX clock source = 3, with external DQS.	-	-	200	MHz
t$_{DS}$	data set-up time	RX clock source = 0 (internal dummy read strobe and loopbacked internally)	6	-	-	ns
		RX clock source = 1 (internal dummy read strobe and loopbacked from DQS pad)	1			
		source = 3 (external DQS, Flash provides read strobe)	1			
t$_{DH}$	data hold time	RX clock source = 0 (internal dummy read strobe and loopbacked internally)	1	-	-	ns
		RX clock source = 1 (internal dummy read strobe and loopbacked from DQS pad)	0			
		source = 3 (external DQS, Flash provides read strobe)	0			
t$_{v(Q)}$	data output valid time		0	-	0.6	ns

[1]   Based on simulation; not tested in production.

[2]   DLLACR register [6:3] = 8, MISCCR2 register [1:0] = 2.

Fig 18.   SDR mode (input timing, mode 0 and 1)

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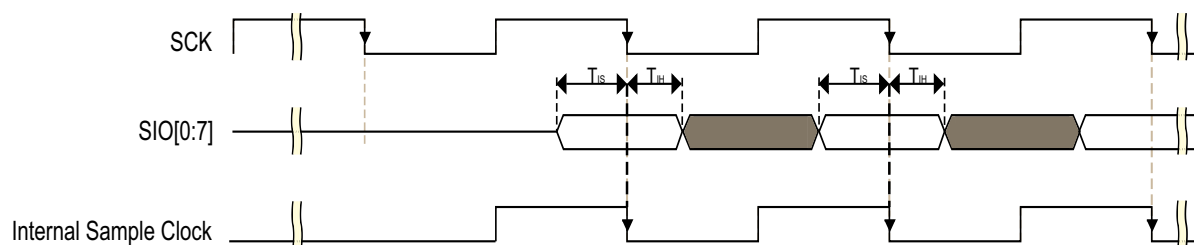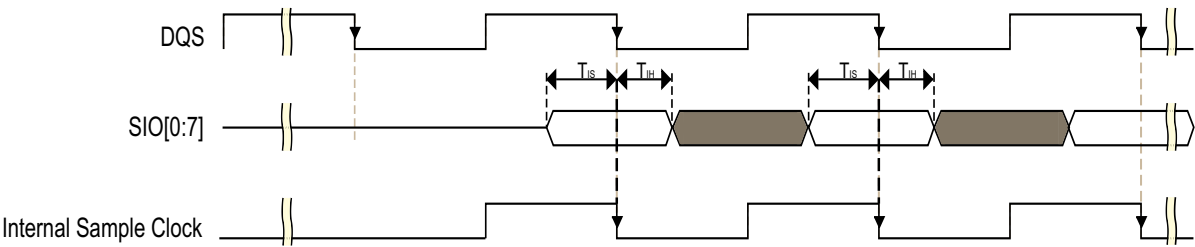
Fig 19.   SDR mode (input timing, mode 3)

Fig 20.   SDR mode (output timing, mode 0 and 1)

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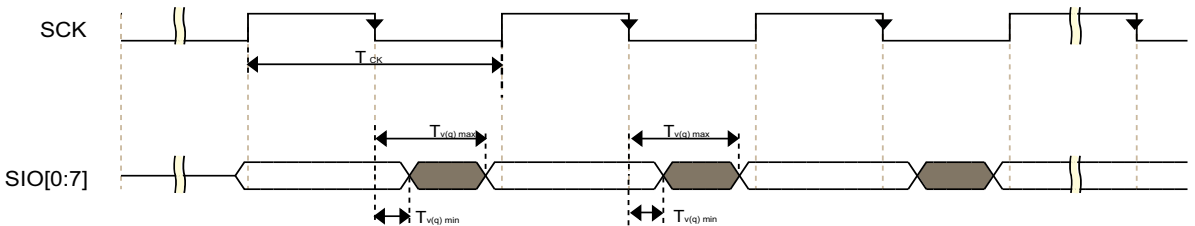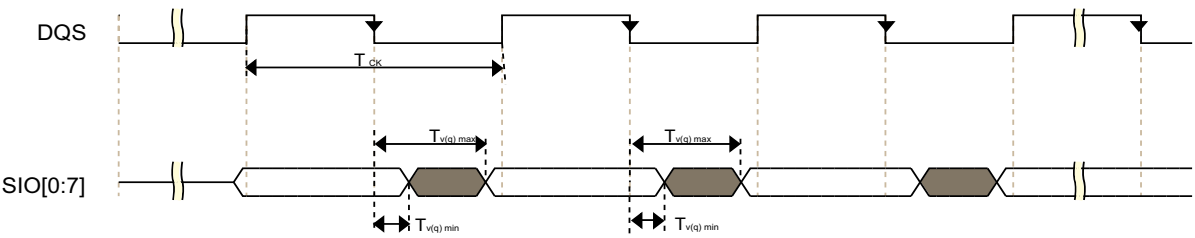
Fig 21. SDR mode (output timing, mode 3)

Fig 22. DDR mode (input timing, mode 0 and 1)

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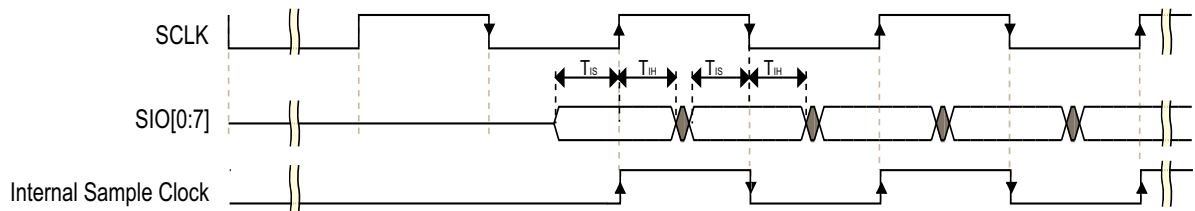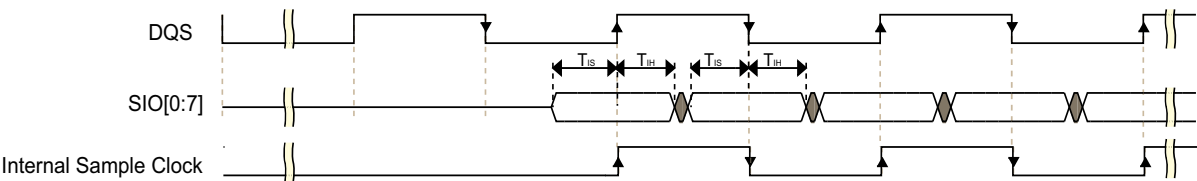
Fig 23. DDR mode (input timing, mode 3)

Fig 24. DDR mode (output timing, mode 0 and 1)

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Fig 25. DDR mode (output timing, mode 3)

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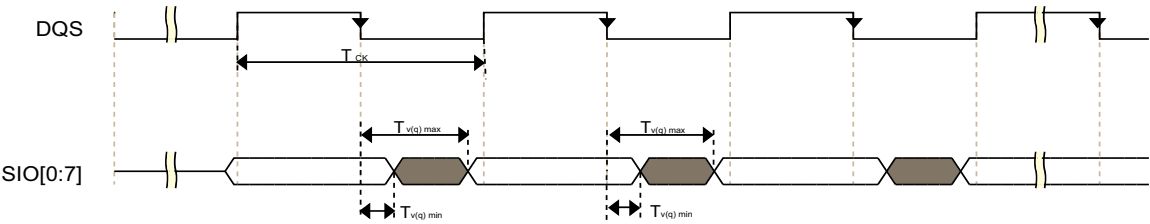
14.14 SD/MMC and SDIO

Table 46. Dynamic characteristics for following modes (SDR-12, SDR-25)

T_{amb} = 0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF. DLL_CTRL = 0x200, Full Drive Mode
on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising
or falling edge. Based on simulation, not tested in production.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, SDR-12 (12.5 MB/s)	-	-	25	MHz
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, SDR-25 (25 MB/s)	-	-	50	MHz
$t_{su(D)}$	data input set-up time	on pins SD_DATn as inputs	7.5	-	-	ns
		on pins SD_CMD as inputs	7.5	-	-	ns
$t_{h(D)}$	data input hold time	on pins SD_DATn as inputs	0	-	-	ns
		on pins SD_CMD as inputs	0	-	-	ns
$t_{v(Q)}$	data output valid time	on pins SD_DATn as outputs	0	-	7.5	ns
		on pins SD_CMD as outputs	0	-	7.5	ns

Table 47. Dynamic characteristics for following modes (SDR-50, SDR-104, SDR-200(HS-200))

T_{amb} = -0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF. DLL_CTRL = 0x200, Full Drive Mode
on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising
or falling edge. Based on simulation, not tested in production.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, SDR-50 (50 MB/s)	-	-	100	MHz
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, SDR-104 (104 MB/s)	-	-	208	MHz
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, SDR-200 (HS-200) (200 MB/s)	-	-	200	MHz
$t_{su(D)}$	data input set-up time	on pins SD_DATn as inputs	7.5	-	-	ns
		on pins SD_CMD as inputs	7.5	-	-	ns
$t_{h(D)}$	data input hold time	on pins SD_DATn as inputs	0	-	-	ns
		on pins SD_CMD as inputs	0	-	-	ns
$t_{v(Q)}$	data output valid time	on pins SD_DATn as outputs	0	-	7.5	ns
		on pins SD_CMD as outputs	0	-	7.5	ns

Table 48. Dynamic characteristics for following modes (DDR-50, DDR-100, HS DDR)

T_{amb} = -0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF. DLL_CTRL = 0x200, Full Drive Mode
on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising
or falling edge. Based on simulation, not tested in production. HS-400 supported on SD port 0 only.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, DDR-50 (50 MB/s)	-	-	50	MHz
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, DDR-100 (100 MB/s)	-	-	52	MHz
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, HS DDR (104 MB/s)	-	-	52	MHz

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Table 48. **Dynamic characteristics for following modes (DDR-50, DDR-100, HS DDR)**

T_{amb} = -0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF. DLL_CTRL = 0x200, Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising or falling edge. Based on simulation, not tested in production. HS-400 supported on SD port 0 only.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{su(D)}$	data input set-up time	on pins SD_DATn as inputs	4.8	-	-	ns
		on pins SD_CMD as inputs	4.8	-	-	ns
$t_{h(D)}$	data input hold time	on pins SD_DATn as inputs	0	-	-	ns
		on pins SD_CMD as inputs	0	-	-	ns
$t_{v(Q)}$	data output valid time	on pins SD_DATn as outputs	0	-	5.0	ns
		on pins SD_CMD as outputs	0	-	5.0	ns

Table 49. **Dynamic characteristics for following modes (DDR-200 (HS-400))**

T_{amb} = -0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF. DLL_CTRL = 0x200, Full Drive Mode on all pins, Input slew = 1 ns, SLEW setting = standard mode for all pins;. Parameters sampled at the 50 % level of the rising or falling edge. Based on simulation, not tested in production. HS-400 supported on SD port 0 only.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{clk}	clock frequency	on pin SD_CLK; data transfer mode, DDR-200 (HS-400) (400 MB/s)	-	-	200	MHz
$t_{su(D)}$	data input set-up time	on pins SD_DATn as inputs	0.5	-	-	ns
		on pins SD_CMD as inputs	0.5	-	-	ns
$t_{h(D)}$	data input hold time	on pins SD_DATn as inputs	0	-	-	ns
		on pins SD_CMD as inputs	0	-	-	ns
$t_{v(Q)}$	data output valid time	on pins SD_DATn as outputs	0	-	1.0	ns
		on pins SD_CMD as outputs	0	-	1.0	ns

14.15 DMIC subsystem

Table 50. Dynamic characteristics[1]

T_{amb} = 0°C to 85 °C; VDDIO_x = 1.71 V to 3.6 V; VDDCORE = 1.13 V; C_L = 10 pF balanced loading on all pins; Input slew = 1 ns, SLEW set to standard mode for all pins; Bypass bit = 0 (PDM data in bypass mode); Parameters sampled at the 50% level of the rising or falling edge

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_{DS}	data set-up time		13	-	-	ns
t_{DH}	data hold time		0	-	-	ns

[1] Based on simulated values.

Fig 26. DMIC timing diagram
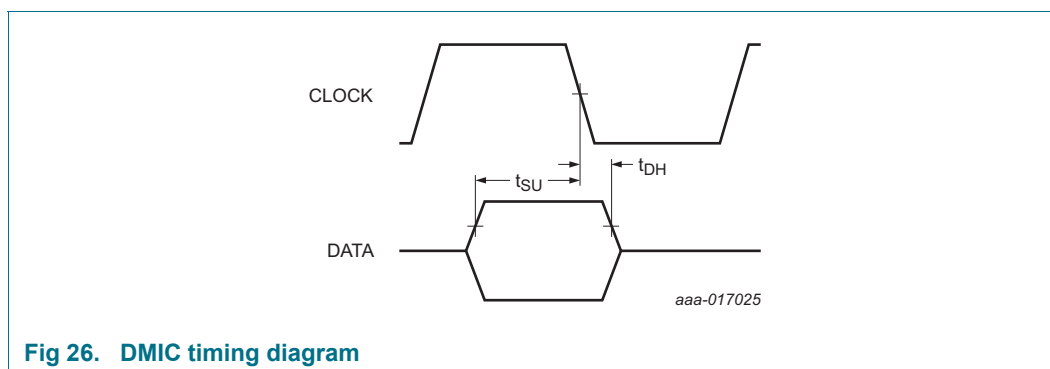
14.16 SCTimer/PWM output timing

Table 51. SCTimer/PWM output dynamic characteristics

T_{amb} = -0 °C to +85 °C, VDDIO_x = 1.71 V to 1.89 V; VDDCORE = 1.13 V; C_L = 10 pF. Simulated skew (over process, voltage, and temperature) of any two SCT fixed-pin output signals; sampled at the 50% level of the rising or falling edge; values guaranteed by design.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{sk(o)}$	output skew time	-	0	-	2.8	ns

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15. Analog characteristics

15.1 12-bit ADC characteristics

Table 52. 12-bit ADC static characteristics

T_{amb} = -20 ℃ to +85 ℃; VDD_AO1V8 = 1.8 V, VDD1V8 = 1.8 V, VDDIO_0/1/2 = 1.8 V, VDDA_ADC1V8 = VDDA_BIAS = VREFP = 1.8 V; V_{SSA} = VREFN = GND. $f_{clk(ADC)}$ = 22 MHz; Sample Time select (STS bit in CMDH register) = 0.

Symbol	Parameter	Conditions		Min	Typ[2]	Max	Unit
VADIN	analog input voltage		See Figure 28	VREFN	-	VREFP	V
$f_{clk(ADC)}$	ADC clock frequency			-	-	60	MHz
f_s	sampling frequency			-	-	1.0	Msamples/s
$C_{samples}$	Sample cycles			3.5	-	131.5	
$C_{compare}$	Fixed compare cycles			-	17.5	-	cycles
$C_{conversion}$	Conversion cycles			$C_{conversion} = C_{samples} + C_{compare}$			cycles
CADIN	Analog Input Capacitance		[3] See Figure 28.	-	4.5	-	pF
RADIN	Input Resistance		See Figure 28.	-	500	-	Ω
RAS	Analog source resistance		[8] See Figure 28	-	-	5	kΩ
E_D	differential linearity error		[1][4]	-	$< \pm1$	-	LSB
$E_{L(adj)}$	integral non-linearity		[1][5]	-	$< \pm1.1$	-	LSB
E_O	offset error		[1][6]	-	$< \pm1$	-	LSB
$V_{err(FS)}$	full-scale error voltage		[1][7]	-	±0.3	-	%

[1] Based on characterization; not tested in production.

[2] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

[3] CADIN represents the external capacitance on the analog input channel for sampling speeds of 1.0 Msamples/s. No parasitic capacitances included. See Figure 28

[4] The differential linearity error (E_D) is the difference between the actual step width and the ideal step width. See Figure 27.

[5] The integral non-linearity ($E_{L(adj)}$) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See Figure 27.

[6] The offset error (E_O) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See Figure 27.

[7] The full-scale error voltage or gain error (E_G) is the difference between the straight-line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See Figure 27.

[8] This resistance is external to the MCU. To achieve the best results, the analog source resistance must be kept as low possible. The results in this data sheet were derived from a system that had < 15 Ω analog source resistance. See Figure 28.
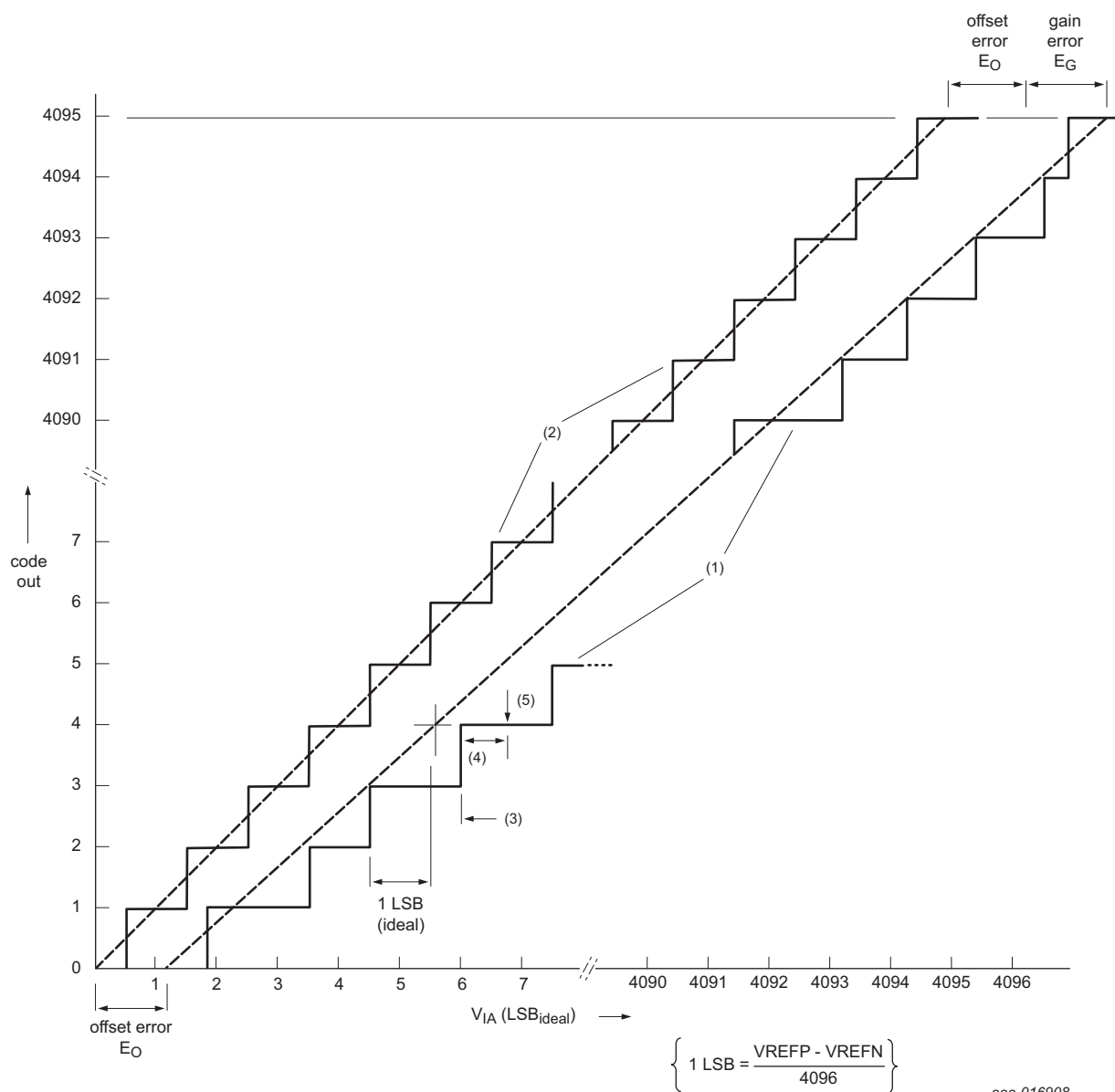
(1) Example of an actual transfer curve.

(2) The ideal transfer curve.

(3) Differential linearity error (E_D).

(4) Integral non-linearity ($E_{L(adj)}$).

(5) Center of a step of the actual transfer curve.

Fig 27. 12-bit ADC characteristics

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15.1.1 ADC input impedance

Fig 28. ADC input impedance diagram
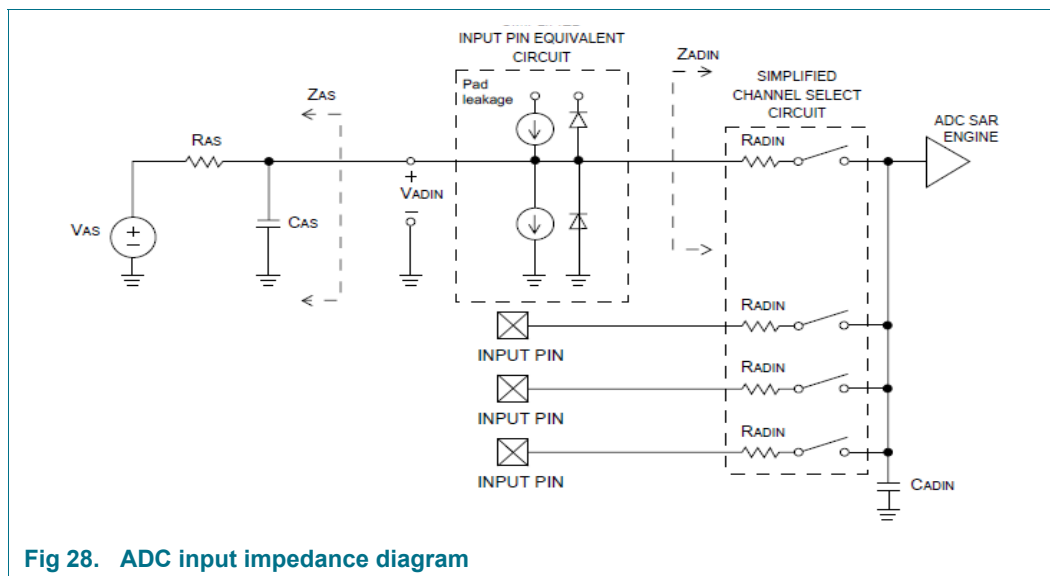
The total input impedance will depend on ADC sample rate and ADC input capacitance. AC impedance can be estimated by using 1/(f* CADIN) where f=1/Tconv.

15.2 Temperature sensor

Table 53.   Temperature sensor static and dynamic characteristics
VDDA_BIAS = 3.3 V, All other supplies = 1.8 V

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
DT_{sen}	sensor temperature accuracy	$T_{amb} = -20\ °C\ to\ +70\ °C$	[1]	-		2.77	°C
E_L	linearity error	$T_{amb} = -20\ °C\ to\ +70\ °C$	[1]	-	-	2.79	°C

[1]   Absolute temperature accuracy. Based on characterization. Not tested in production.

Table 54.   Temperature sensor Linear-Least-Square (LLS) fit parameters
VDDA_BIAS = 3.3 V, All other supplies = 1.8 V

Fit parameter	Range		Min	Typ	Max	Unit
LLS slope	T_{amb} = −20 °C to +70 °C	[1][2]	-	-1.536	-	mV/°C
LLS intercept at 0 °C	T_{amb} = −20 °C to +70 °C	[1][2]	-	807	-	mV
LLS intercept at 25 °C	T_{amb} = −20 °C to +70 °C	[1][2]	-	770.4	-	mV

[1]   Based on characterization, Not tested in production.

[2]   Equation:

Temp = 25 - ((Vtemp -Vtemp25)/m)

Where:

VTEMP is the voltage of the temperature sensor channel at the ambient temperature

VTEMP is the voltage of the temperature sensor channel at 25°C and VDD = 1.8 V

m is the voltage versus temperature slope in V/°C
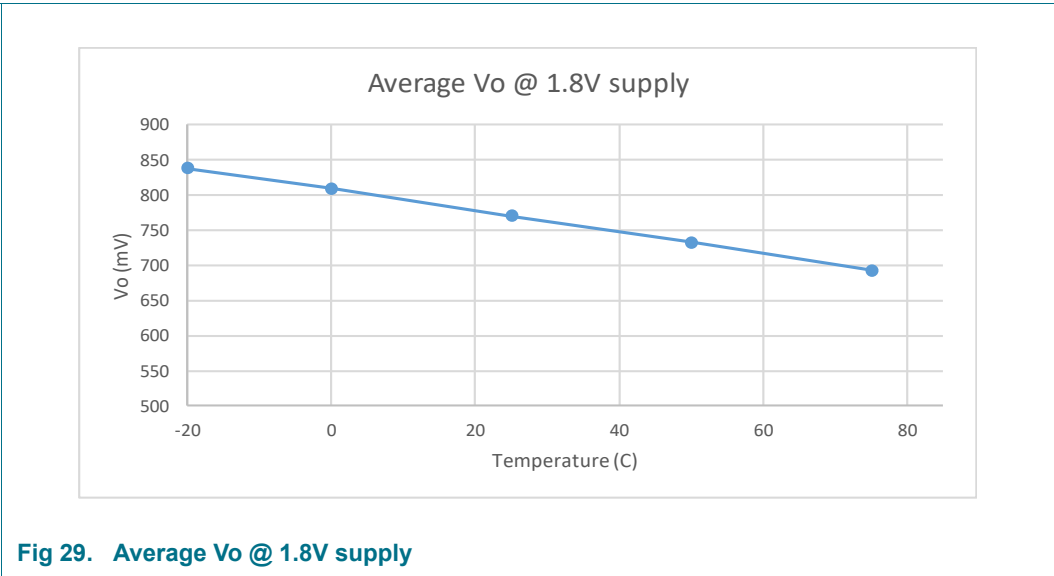
Fig 29.   Average Vo @ 1.8V supply

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15.2.1 Comparator

Table 55. Comparator characteristics

T_{amb} = −20 °C to +70 °C unless noted otherwise; All supplies = 1.8 V.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
Static characteristics							
V_{offset}	offset voltage	V_{IC} = 0.1 V		-	6	-	mV
		V_{IC} = 0.9 V		-	7	-	mV
		V_{IC} = 1.7 V		-	9	-	mV
Dynamic characteristics							
t_{PD}	propagation delay (Low speed mode)	HIGH to LOW; T_{amb} = 25 °C					
		V_{IC} = 0.1 V; 100 mV overdrive input		-	2	-	us
		V_{IC} = 0.1 V; rail-to-rail input		-	915	-	ns
		V_{IC} = 0.9 V; 100 mV overdrive input		-	525	-	ns
		V_{IC} = 0.9 V; rail-to-rail input		-	600	-	ns
		V_{IC} = 1.7 V; 100 mV overdrive input		-	500	-	ns
		V_{IC} = 1.7 V; rail-to-rail input		-	350	-	ns
t_{PD}	propagation delay (High speed mode)	HIGH to LOW; T_{amb} = 25 °C					
		V_{IC} = 0.1 V; 100 mV overdrive input	[3]	-	270	-	ns
		V_{IC} = 0.1 V; rail-to-rail input		-	310	-	ns
		V_{IC} = 0.9 V; 100 mV overdrive input	[3]	-	340	-	ns
		V_{IC} = 0.9 V; rail-to-rail input		-	210	-	ns
		V_{IC} = 1.7 V; 100 mV overdrive input	[3]	-	150	-	ns
		V_{IC} = 1.7 V; rail-to-rail input		-	125	-	ns
t_{PD}	propagation delay (Low speed mode)	LOW to HIGH; T_{amb} = 25 °C					
		V_{IC} = 0.1 V; 100 mV overdrive input	[3]	-	5.8	-	us
		V_{IC} = 0.1 V; rail-to-rail input		-	470	-	ns
		V_{IC} = 0.9 V; 100 mV overdrive input	[3]	-	750	-	ns
		V_{IC} = 0.9 V; rail-to-rail input		-	600	-	ns
		V_{IC} = 1.7 V; 100 mV overdrive input	[3]	-	5.5	-	us
		V_{IC} = 1.7 V; rail-to-rail input		-	1.25	-	us
t_{PD}	propagation delay (High speed mode)	LOW to HIGH; T_{amb} = 25 °C					
		V_{IC} = 0.1 V; 100 mV overdrive input	[3]	-	105	-	ns
		V_{IC} = 0.1 V; rail-to-rail input		-	115	-	ns
		V_{IC} = 0.9 V; 100 mV overdrive input	[3]	-	110	-	ns
		V_{IC} = 0.9 V; rail-to-rail input		-	120	-	ns
		V_{IC} = 1.7 V; 100 mV overdrive input	[3]	-	110	-	ns
		V_{IC} = 1.7 V; rail-to-rail input		-	120	-	ns
V_{hys}	hysteresis voltage[2]	HYSTCRT[1:0] = 01		-	13	-	mV
		HYSTCRT[1:0] = 10		-	27	-	mV
		HYSTCRT[1:0] = 11		-	35	-	mV

[1] Characterized on typical samples, not tested in production.

[2] Input hysteresis is relative to the reference input channel and is software programmable.

[3] 100 mV overdrive corresponds to a square wave from 50 mV below the reference (V_{IC}) to 50 mV above the reference.

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16. Application information

16.1 Current consumption vs Memory Partitions

Figure 30 shows the current consumption vs memory partitions:

Current Measurements for Memory Partitions

- Test conditions: M33 active, Running advanced-while1 code in different partitions (2 to 29)
- Typical silicon, VDDCORE = 1.1 V, Temp = 25°C, Frequency = 198 MHz, internal LDO is disabled
- All memories array/periphery ON (PDRUNCFG2/3) and only one partition clocked (AHB_SRAM_ACCESS_DISABLE REGISTER)

Fig 30. Current measurements for memory partition

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16.2 Standard I/O pin configuration

The RT600 contains 2 types of GPIO pins: Fail-Safe and High-Speed. Figure 31 shows the simplified pin diagram for the Fail-Safe GPIO pins and Figure 32 shows the simplified pin diagram for the High-Speed GPIO pins.

Fig 31. Simplified fail-safe GPIO pins

Fig 32. Simplified high-speed GPIO pins
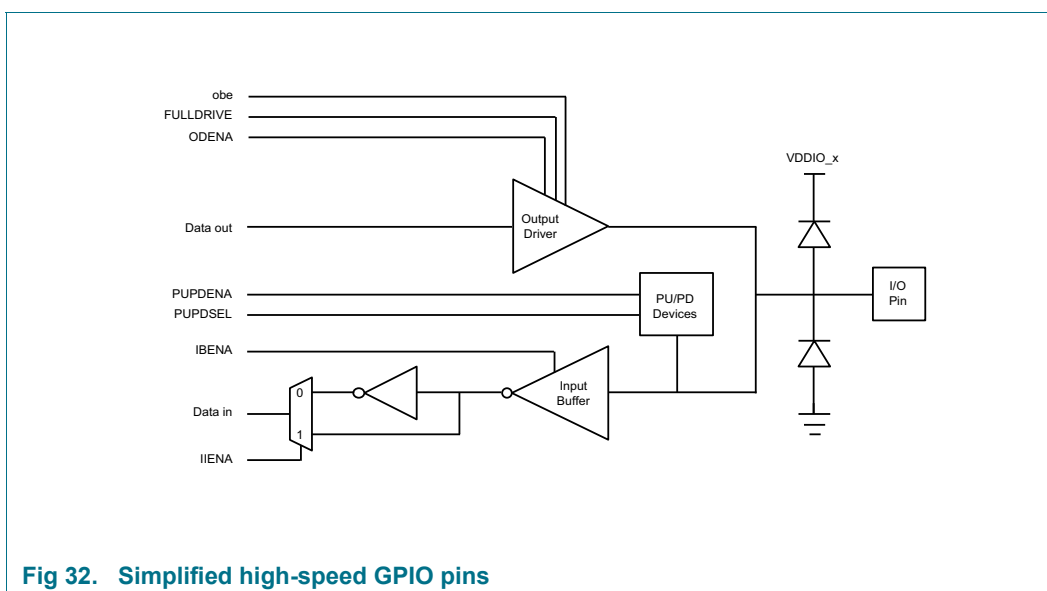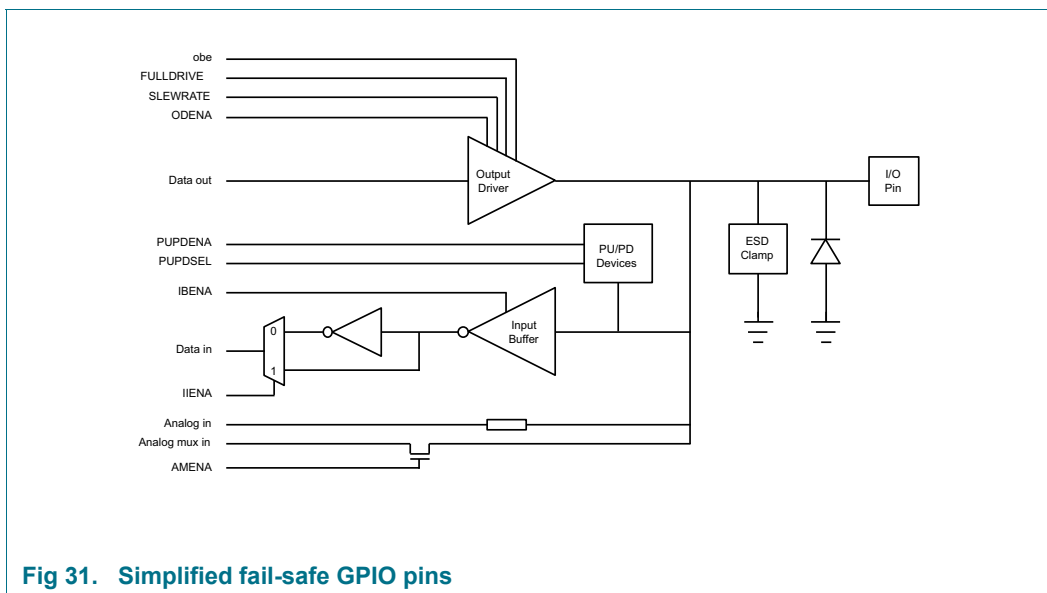
16.3 I/O power consumption

I/O pins are contributing to the overall dynamic and static power consumption of the part. If pins are configured as digital inputs, a static current can flow depending on the voltage level at the pin and the setting of the internal pull-up and pull-down resistors. This current can be calculated using the parameters R_{pu} and R_{pd} given in Table 30 for a given input voltage V_I. For pins set to output, the current drive strength is given by parameters I_{OH} and I_{OL} in Table 30, but for calculating the total static current, you also need to consider any external loads connected to the pin.

I/O pins also contribute to the dynamic power consumption when the pins are switching because the V_{DD} supply provides the current to charge and discharge all internal and external capacitive loads connected to the pin in addition to powering the I/O circuitry.

The contribution from the I/O switching current I_{sw} can be calculated as follows for any given switching frequency f_{sw} if the external capacitive load (C_{ext}) is known (see Table 30 for the internal I/O capacitance):

$I_{sw} = V_{DD} \times f_{sw} \times (C_{io} + C_{ext})$

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16.4 RTC oscillator

In the RTC oscillator circuit, only the crystal (XTAL) and the capacitances Cx and Cy need to be connected externally on RTCXIN and RTCXOUT. See Figure 33 "RTC oscillator components".
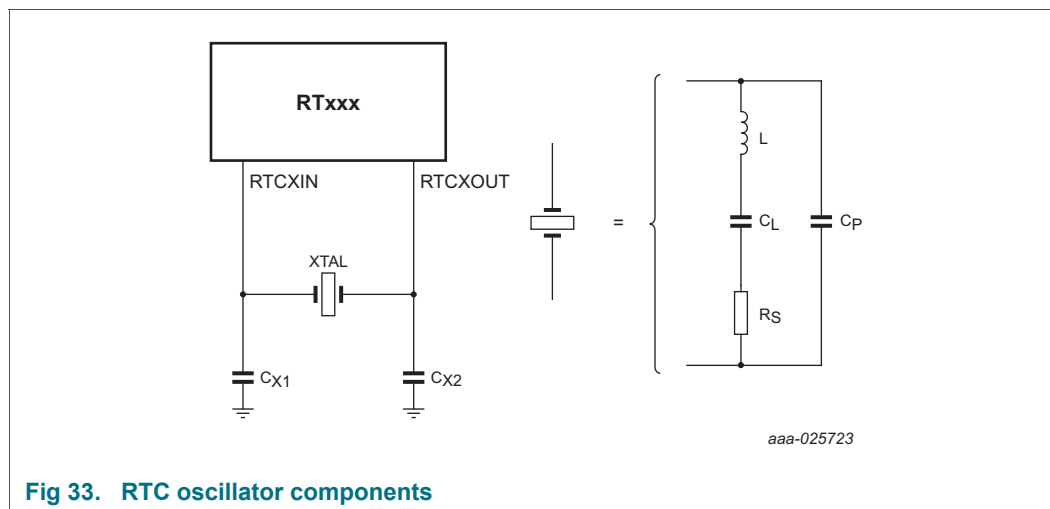
Fig 33. RTC oscillator components

For best results, it is very critical to select a matching crystal for the on-chip oscillator. Load capacitance (CL), series resistance (RS), and drive level (DL) are important parameters to consider while choosing the crystal. After selecting the proper crystal, the approximate external load capacitor Cx and Cy values can also be generally determined by the following expression:

$Cx = Cy = 2C_L - C_{Pad} - 2C_{STRAY}$

Where:

C_L - Crystal load capacitance

C_{Pin} - Pin capacitance of the RTCXIN and RTCXOUT pins (~3 pf per pin).

C_{STRAY} – stray capacitance between RTCXIN and RTCXOUT pins.

For example:

C_L = 9 pF

$Cx = Cy = 2C_L - C_{Pad} - 2C_{STRAY}$

$Cx = Cy = 2*9 - 3 - 0 = 15$ pF.

Although C_{STRAY} can be ignored in general, the actual board layout and placement of external components influences the optimal values of external load capacitors. Therefore, it is recommended to fine tune the values of external load capacitors on actual hardware board to get the accurate clock frequency. For fine tuning, output the RTC Clock to the CLKOUT pin and optimize the values of external load capacitors for minimum frequency deviation.

The RTC oscillator can be bypassed and driven by an external signal. To accomplish this, set bit 8 to 1 in RTC control register (RTC_OSC_PD), the RTCXOUT pin is left disconnected (floating), and the RTCXIN pin is driven by an external source with a level

appropriate for 1.8V Vdd logic. One millisecond should be allowed before the input takes effect in the RTC logic.

Also, as another option, selectable on-chip crystal load capacitors are available for RTC oscillator. Please refer to RT6xx UM for further details.

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16.4.1 RTC Printed Circuit Board (PCB) design guidelines

- Connect the crystal and external load capacitors on the PCB as close as possible to the oscillator input and output pins of the chip.

- The length of traces in the oscillation circuit should be as short as possible and must not cross other signal lines.

- Ensure that the load capacitors Cx and Cy have a common ground plane.

- Loops must be made as small as possible to minimize the noise coupled in through the PCB and to keep the parasitics as small as possible.

- Lay out the ground (GND) pattern under crystal unit.

- Do not lay out other signal lines under crystal unit for multi-layered PCB.

16.5 XTAL oscillator

In the XTAL oscillator circuit, only the crystal (XTAL) and the capacitances C_X and C_y need to be connected externally on XTALIN and XTALOUT. See Figure 34 "XTAL oscillator connection - Low-Power Mode".
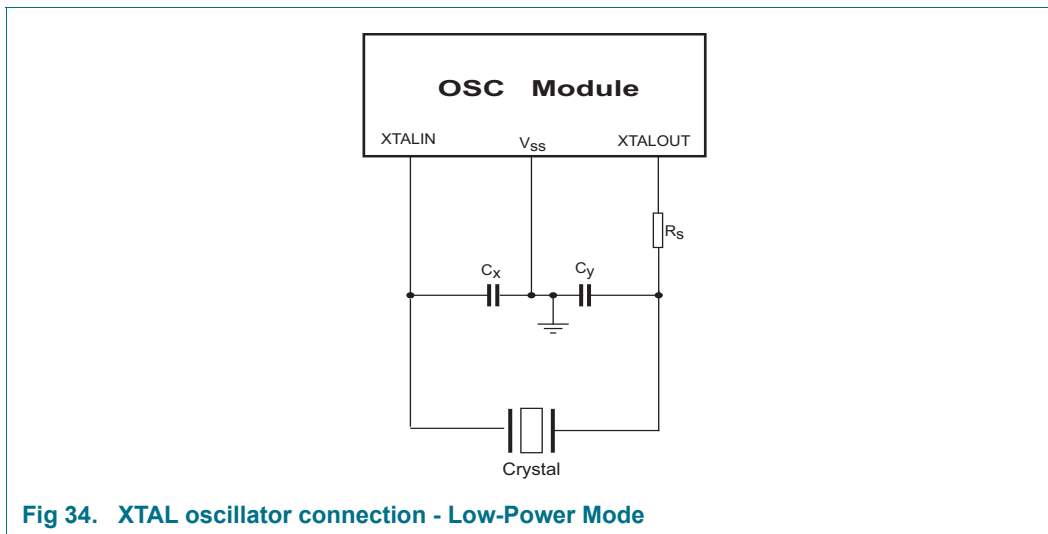
Fig 34. XTAL oscillator connection - Low-Power Mode
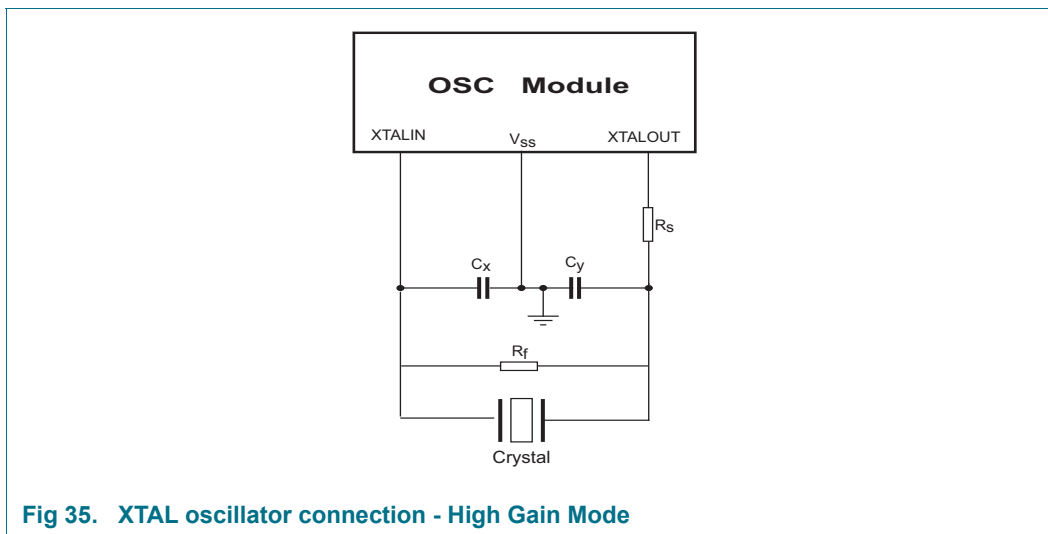
Fig 35. XTAL oscillator connection - High Gain Mode

For best results, it is very critical to select a matching crystal for the on-chip oscillator. Load capacitance (CL), series resistance (RS), and drive level (DL) are important parameters to consider while choosing the crystal. After selecting the proper crystal, the approximate external load capacitor C_x and C_y values can also be generally determined by the following expression:

$Cx = Cy = 2C_L - C_{Pad} - 2C_{STRAY}$

Where:

C_L - Crystal load capacitance

C_{Pin} - Pad capacitance of the XTALIN and XTALOUT pins (~3 pf per pin).

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C_{STRAY} – stray capacitance between XTALIN and XTALOUT pins.

For example:

CL = 9pF

$Cx = Cy = 2C_L - C_{Pad} - 2C_{STRAY}$

Cx = Cy = 2*9 - 3 - 0 = 15 pF

Although C_{STRAY} can be ignored in general, the actual board layout and placement of external components influences the optimal values of external load capacitors. Therefore, it is recommended to fine tune the values of external load capacitors on actual hardware board to get the accurate clock frequency. For fine tuning, measure the clock on the CLKOUT pin and optimize the values of external load capacitors for minimum frequency deviation.

To use bypass mode on system oscillator, set bit 1 to '1' in the system oscillator control 0 (CLKCTL0_SYSOSCCTL0), float the XTALOUT pin, and drive XTALIN with a 0.8 V to 1.8V square wave.

For oscillator high gain mode, a larger voltage swing is used at the crystal pin. This gives a higher noise immunity within the oscillator and less edge to edge jitter of the internal clock. If high gain mode is not required, power used by the crystal oscillator can be reduced by using low power mode.

Remark: High gain mode requires a 1 megohm resistor (R_F) to be inserted.

16.5.1 XTAL Printed Circuit Board (PCB) design guidelines

- Connect the crystal and external load capacitors on the PCB as close as possible to the oscillator input and output pins of the chip.
- The length of traces in the oscillation circuit should be as short as possible and must not cross other signal lines.
- Ensure that the load capacitors Cx and Cy have a common ground plane.
- Loops must be made as small as possible to minimize the noise coupled in through the PCB and to keep the parasitics as small as possible.
- Lay out the ground (GND) pattern under crystal unit.
- Do not lay out other signal lines under crystal unit for multi-layered PCB.

16.6 Suggested USB interface solutions

The USB device can be connected to the USB as self-powered device (see Figure 36) or bus-powered device (see Figure 37).

On the RT600, the USB_VBUS pin is 5 V tolerant pin regardless of whether USB1_VDD3V3 or VDD pins are present or not.

aaa-023996
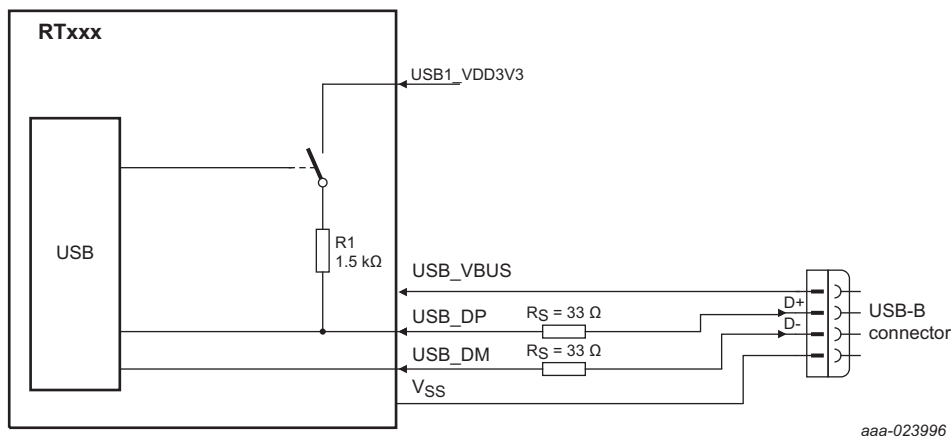
Fig 36.   USB interface on a self-powered device where USB_VBUS = 5 V

The internal pull-up (1.5 kΩ) can be enabled by setting the DCON bit in the DEVCMDSTAT register to prevent the USB from timing out when there is a significant delay between power-up and handling USB traffic. External circuitry is not required.

aaa-023997
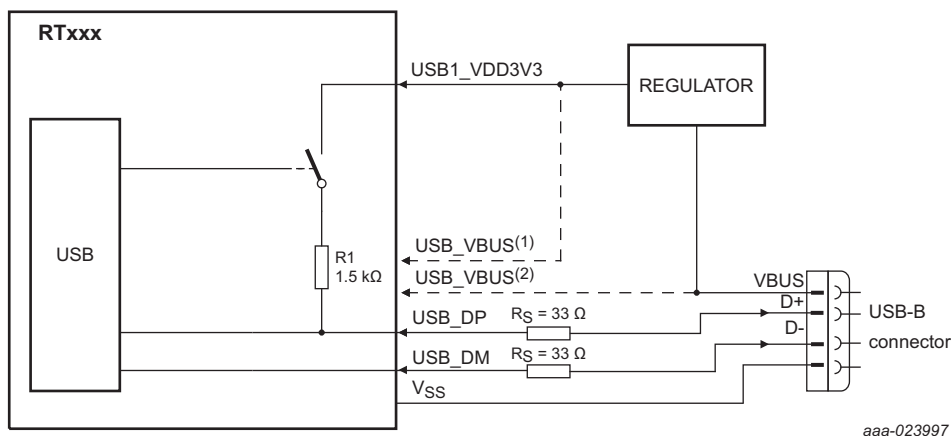
Two options exist for connecting VBUS to the USB_VBUS pin:

(1) Connect the regulator output to USB_VBUS. In this case, the USB_VBUS signal is HIGH whenever the part is powered.

(2) Connect the VBUS signal directly from the connector to the USB_VBUS pin. In this case, 5 V are applied to the USB_VBUS pin while the regulator is ramping up to supply USB1_VDD3V3.

Fig 37.   USB interface on a bus-powered device

16.7 Boundary Scan Mode

The RESET pin selects between the JTAG boundary scan (RESET = LOW) and the Arm SWD debug (RESET = HIGH). The Arm SWD debug port is disabled while the RT6xx is in reset. The JTAG boundary scan pins are selected by hardware when the part is in boundary scan mode.

To perform boundary scan testing, follow these steps:

1. Power up the part with the RESET pin pulled LOW externally.

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2. Wait for at least 100 us.

3. Perform boundary scan operations.

4. Once the boundary scan operations are completed, assert the TRST pin to enable the SWD debug mode, and release the RESET pin (pull HIGH).

Remark: The JTAG interface cannot be used for debug purposes.

16.8 VDDA_BIAS Power Supply Connection

For Configuration 1 see Figure 38 and for Configuration 2 see Figure 39.
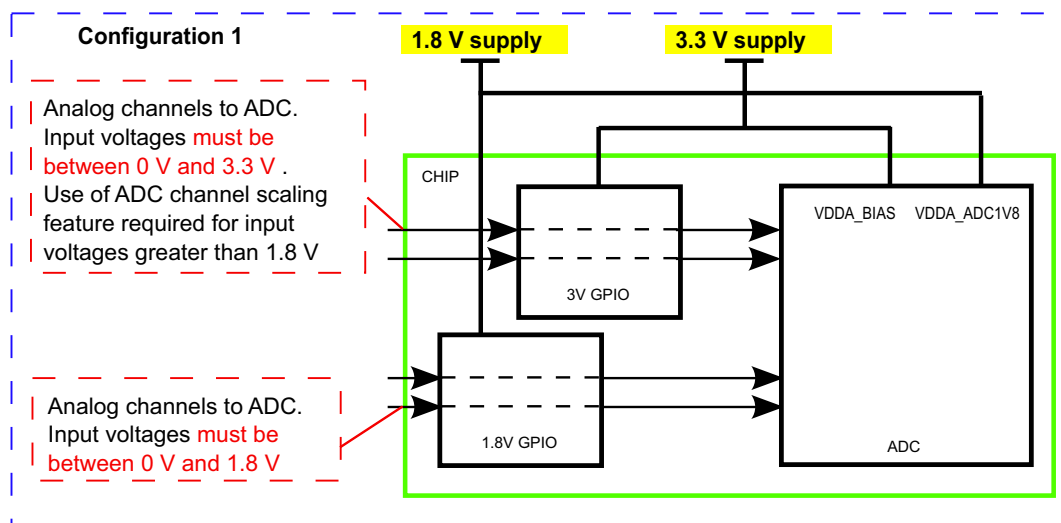
Fig 38. Configuration 1
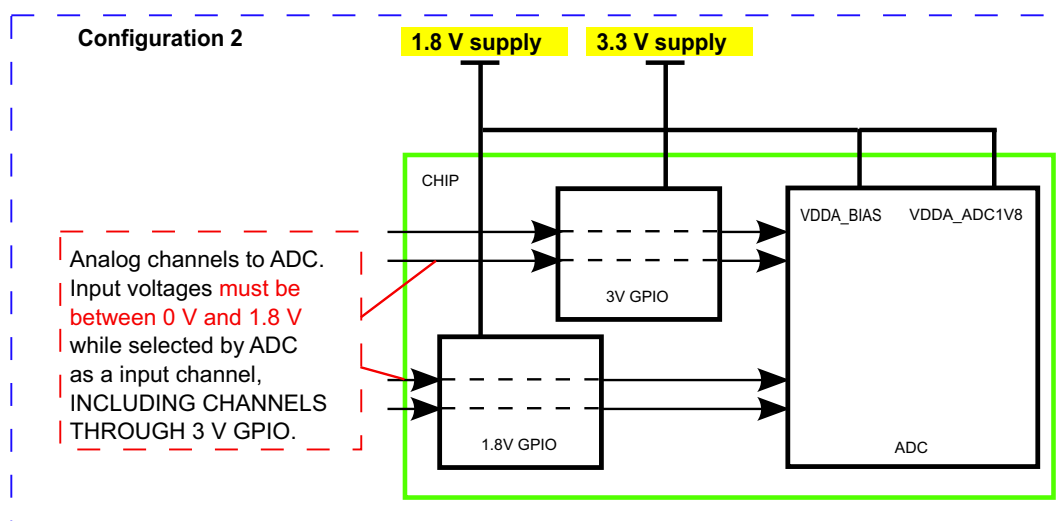
Fig 39. Configuration 2
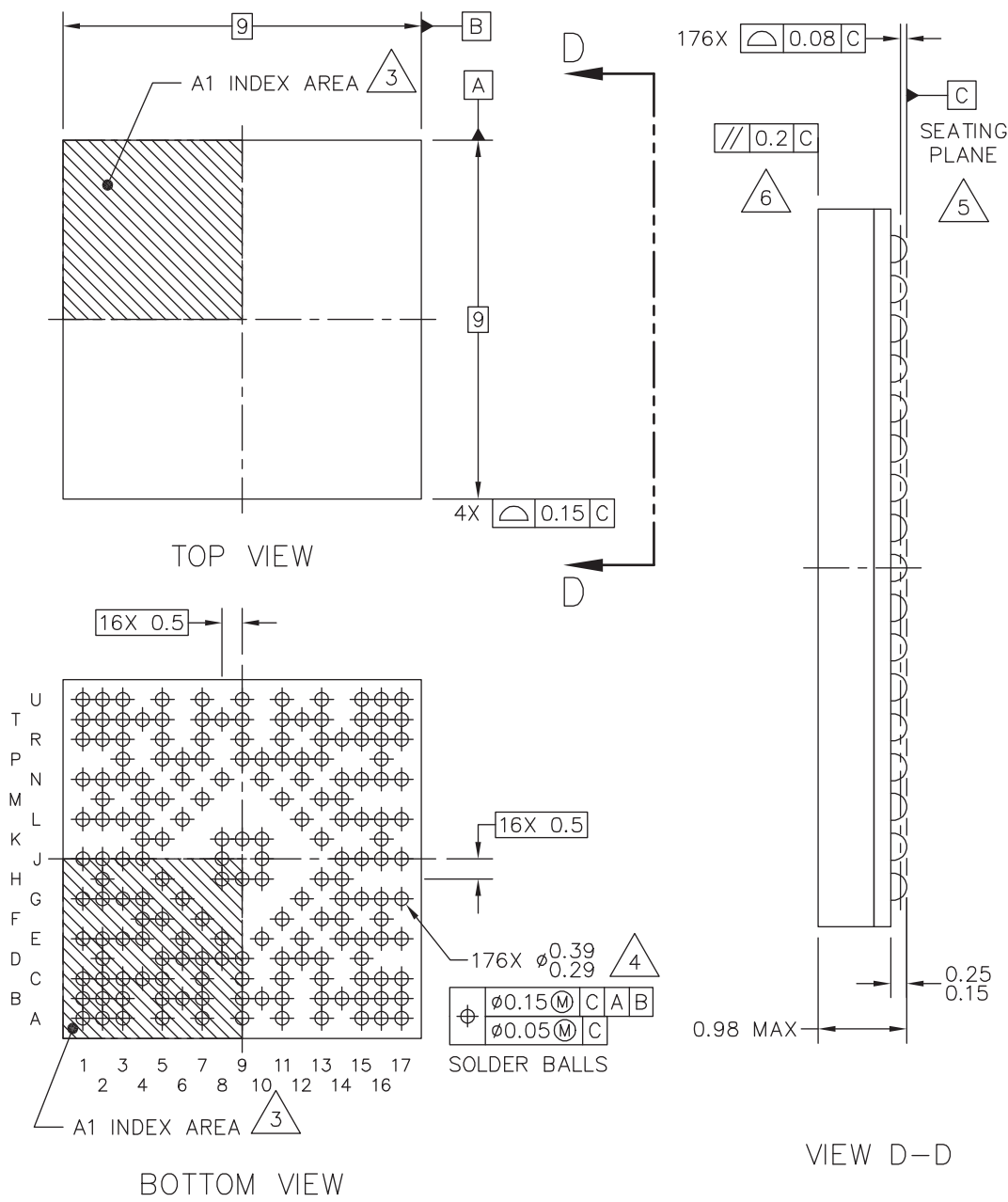
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17. Package outline

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98ASA00942D | REVISION:
A | PAGE: | DATE: 13 JUL 2018 |

Fig 40. VFBGA176 package

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WLCSP-114 I/O
4.235 X 4.235 X 0.49 PKG, 0.35 PITCH (BACKSIDE COATING INCLUDED)

SOT2019-1

TOP VIEW

BOTTOM VIEW

VIEW D-D

RELEASED FOR EXTERNAL ASSEMBLY ONLY. THIS DESIGN ONLY MEETS EXTERNAL DESIGN AND
ASSEMBLY RULES. MUST BE REVIEWED AND UPDATED BEFORE BEING ASSEMBLED INTERNALLY.

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Fig 41. WLCSP114 package

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Fig 42. FOWLP249 package

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			REVISION: O	PAGE: 1 OF 6	

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18. Soldering

16X 0.5

(176X ⌀0.38)

16X 0.5

PACKAGE
OUTLINE

PCB DESIGN GUIDELINES — SOLDER MASK OPENING PATTERN

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Fig 43.   Reflow soldering of the VFBGA176 package (part 1 of 3)

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16X 0.5

(176X ⌀0.28)

16X 0.5

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PCB DESIGN GUIDELINES — I/O PADS AND SOLDERABLE AREA

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Fig 44.   Reflow soldering of the VFBGA176 package (part 2 of 3)

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16X 0.5

(176X ⌀0.34)

16X 0.5

PACKAGE
OUTLINE
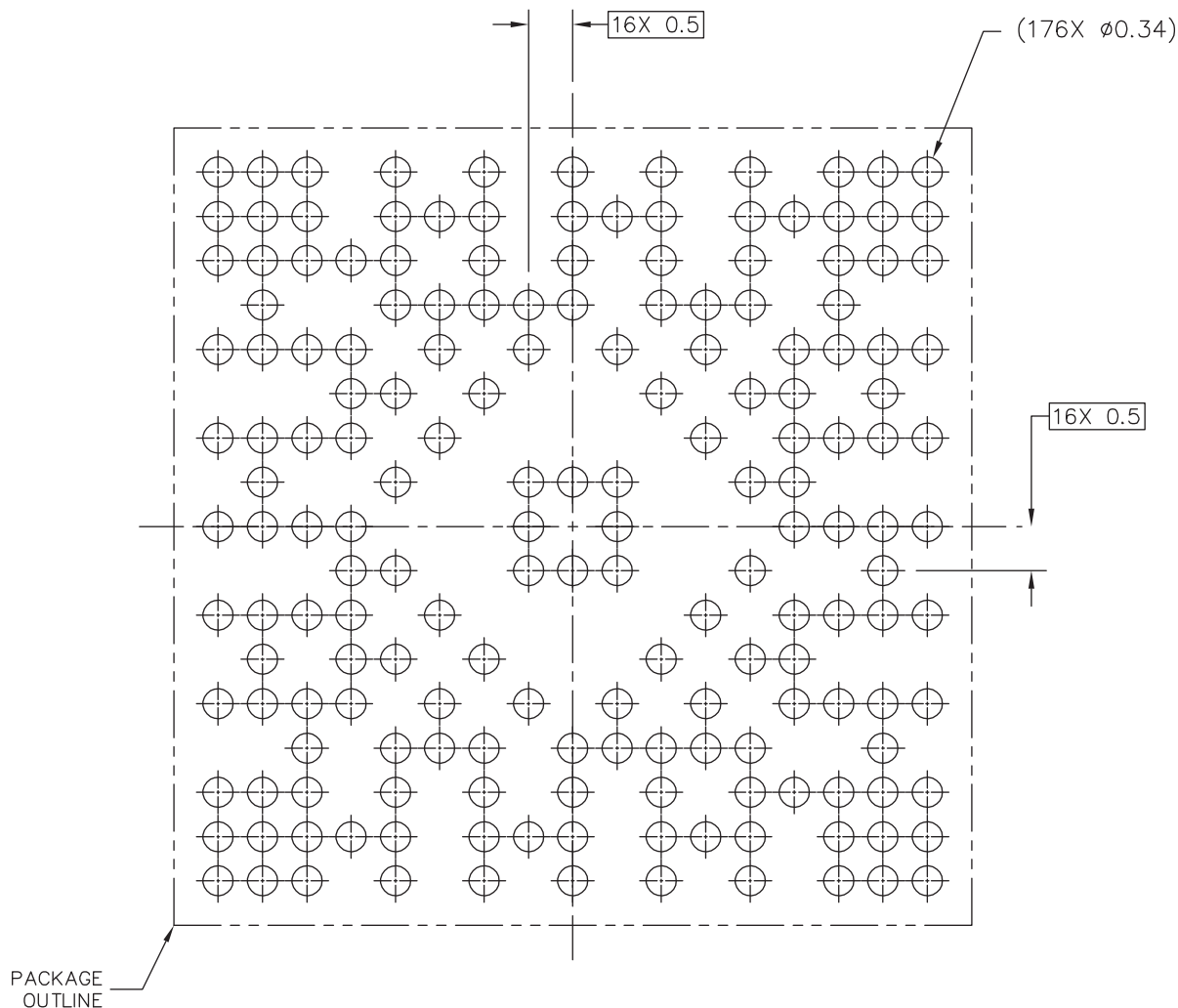
RECOMMENDED STENCIL THICKNESS 0.125

PCB DESIGN GUIDELINES — SOLDER PASTE STENCIL

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| MECHANICAL OUTLINE | STANDARD: | DRAWING NUMBER: | REVISION: | PAGE: |

Fig 45. Reflow soldering of the VFBGA176 package (part 3 of 3)

FOWLP-249 I/O
7 X 7 X 0.725 PKG, 0.4 MM PITCH

SOT2003-1

16X 0.4

(249X ⌀0.32)

16X 0.4

PACKAGE
OUTLINE

PCB DESIGN GUIDELINES — SOLDER MASK OPENING PATTERN

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NON JEDEC | DRAWING NUMBER:
98ASA01357D | REVISION:
O | PAGE:
2 OF 6 |

Fig 46.   Reflow soldering of the FOWLP249 package (part 1 of 4)

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FOWLP-249 I/O
7 X 7 X 0.725 PKG, 0.4 MM PITCH

SOT2003-1

16X 0.4

(249X ⌀0.24)

16X 0.4

PACKAGE
OUTLINE

PCB DESIGN GUIDELINES — I/O PADS AND SOLDERABLE AREA

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	STANDARD: NON JEDEC	DRAWING NUMBER: 98ASA01357D	REVISION: O	PAGE: 3 OF 6

Fig 47.   Reflow soldering of the FOWLP249 package (part 2 of 4)

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FOWLP-249 I/O
7 X 7 X 0.725 PKG, 0.4 MM PITCH

SOT2003-1

16X 0.4

(249X ⌀0.275)

16X 0.4

PACKAGE
OUTLINE
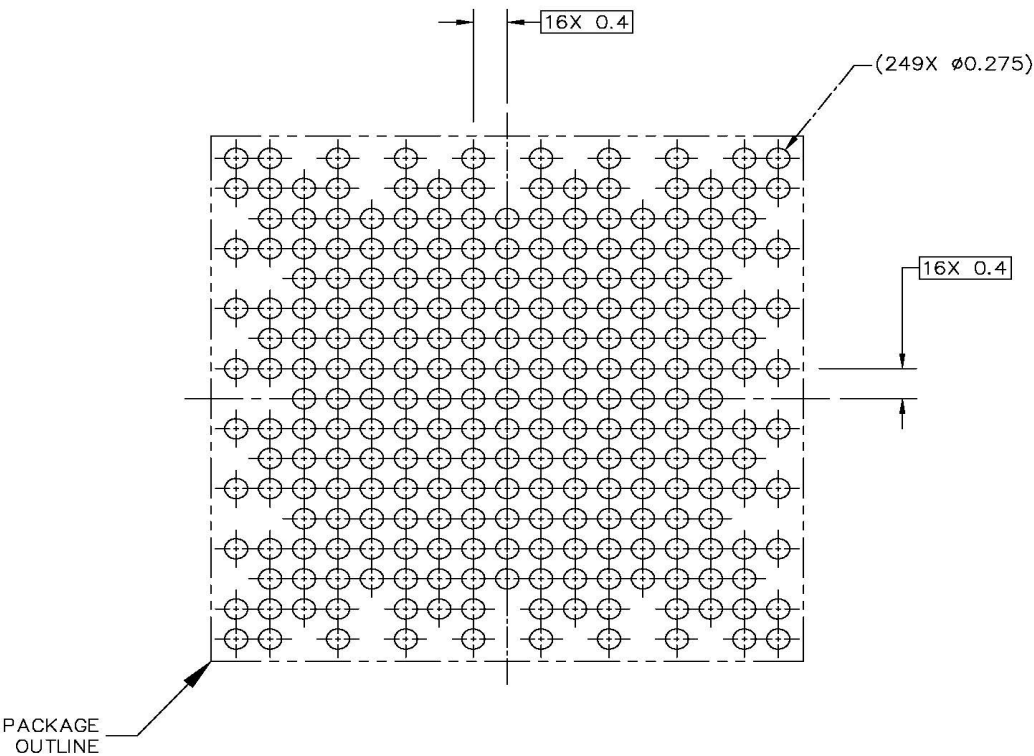
RECOMMENDED STENCIL THICKNESS 0.1

PCB DESIGN GUIDELINES — SOLDER PASTE STENCIL

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Fig 48.   Reflow soldering of the FOWLP249 package (part 3 of 4)

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```
FOWLP-249 I/O                                                      SOT2003-1
7 X 7 X 0.725 PKG, 0.4 MM PITCH


    NOTES:

    1.   ALL DIMENSIONS IN MILLIMETERS.

    2.   DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

   /3.\  PIN A1 FEATURE SHAPE, SIZE AND LOCATION MAY VARY.

   /4.\  MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM C.

   /5.\  DATUM C, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE
         SOLDER BALLS.

   /6.\  PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE
         OF PACKAGE.
```

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MECHANICAL OUTLINE PRINT VERSION NOT TO SCALE	STANDARD: NON JEDEC	DRAWING NUMBER: 98ASA01357D	REVISION: O	PAGE: 5 OF 6	

Fig 49.   Reflow soldering of the FOWLP249 package (part 4 of 4)

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Fig 50. Reflow soldering of the WLCSP114 package (part 1 of 4)

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10X 0.35

(114X ⌀0.2)

10X 0.35

PACKAGE
OUTLINE

PCB DESIGN GUIDELINES — I/O PADS AND SOLDERABLE AREA

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Fig 51. Reflow soldering of the WLCSP114 package (part 2 of 4)

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4.205 X 4.205 X 0.49 PKG, 0.35 PITCH (BACKSIDE COATING INCLUDED)

10X 0.35

(114X ⌀0.23)

10X 0.35

PACKAGE
OUTLINE

RECOMMENDED STENCIL THICKNESS 0.08

PCB DESIGN GUIDELINES – SOLDER PASTE STENCIL

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PRINT VERSION NOT TO SCALE | STANDARD:
NON JEDEC | DRAWING NUMBER:
98ASA01389D | REVISION:
X0 | |

Fig 52. Reflow soldering of the WLCSP114 package (part 3 of 4)

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N200 X N200 X 0.40 PAD, 0.35 PITCH (BACKSIDE COATING INCLUDED)

NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.

2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M−1994.

3. PIN A1 FEATURE SHAPE, SIZE AND LOCATION MAY VARY.

4. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM C.

5. DATUM C, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.

6. THIS PACKAGE HAS A BACK SIDE COATING THICKNESS OF 0.025.

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Fig 53. Reflow soldering of the WLCSP114 package (part 4 of 4)

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19. Abbreviations

Table 56.   Abbreviations

Acronym	Description
AHB	Advanced High-performance Bus
APB	Advanced Peripheral Bus
API	Application Programming Interface
DMA	Direct Memory Access
FRO oscillator	Internal Free-Running Oscillator, tuned to the factory specified frequency
GPIO	General Purpose Input/Output
FRO	Free Running Oscillator
LSB	Least Significant Bit
MCU	MicroController Unit
PDM	Pulse Density Modulation
PLL	Phase-Locked Loop
SPI	Serial Peripheral Interface
TCP/IP	Transmission Control Protocol/Internet Protocol
TTL	Transistor-Transistor Logic
USART	Universal Asynchronous Receiver/Transmitter

20. References

[1]   RT600. User manual UM11147

[2]   RT600. Errata sheet.

[3]   Technical note ADC design guidelines:
http://www.nxp.com/documents/technical_note/TN00009.pdf

[4]   Cortex-M33 DGUG - ARM Cortex-M33 Devices Generic User Guide

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21. Revision history

Table 57.   Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
RT600 v.2.0	20220401	Product data sheet	-	1.9
		• In Section 7 "Pinning information" updated details of GPIO pins.		
		• In Table 6 "Termination of unused pins" updated default state of all PIOn pins.		
		• Updated Section 10.15.1 "Features" to read all GPIO default to high impedance after reset.		
		• In Table 18 "Limiting values", Table 20 "General operating conditions", and in Table 21 "General operating conditions" updated VDDCORE maximum value.		
		• In Section 13.2 "Power Sequencing" added no delay requirement on the external reset pin when using internal LDO and when the pin is tied high.		
		• In Table 30 "Static characteristics: pin characteristics" added Table note 5 "PMIC mode pins are dedicated outputs. They are hard wired to normal drive, no input buffer, no pull ups or pull downs, and no slew rate control." and Table note 6 "Based on simulation, not tested in production.".		
		• Updated fail-safe and high-speed GPIO pins detail and their diagram in Section 16.2 "Standard I/O pin configuration".		
		• In Section 16.4 "RTC oscillator" updated XTALIN, XTALOUT, and CLOCKOUT pins to RTCXIN, RTCXOUT, and CLKOUT respectively.		
		• In Section 16.5 "XTAL oscillator" updated drive XTALIN with a 0.8 V to 1.8V square wave instead of <0.7V to 1.8V.		
		• Added Table note 9 "Fall-time spec can be found in Table 30 "Static characteristics: pin characteristics" in Figure 10 "I2C-bus pins clock timing[9]".		
		• Removed below footnote from Table 4 "Pin description":		
		a. Pad with programmable glitch filter; provides digital I/O functions with TTL levels and hysteresis; normal drive strength.		
		b. Pin providing standard digital I/O functions with configurable modes, configurable hysteresis, and analog input.		
		• Updated recommended termination of unused pins in Table 6 "Termination of unused pins".		
		• Updated Section 10.14.2 "Deep-sleep mode".		
		• In Table 18 "Limiting values" added USB1_VBUS and updated footnote[2] to "Maximum/minimum voltage above the maximum operating voltage and below ground should be avoided as proper operation cannot be guaranteed and could lead to irrecoverable failure. Failure includes the loss of reliability and shorter lifetime of the device."		
		• In Section 14.9 "I2S-bus interface" added maximum and minimum supported bit.		
		• In Table 41 "Dynamic characteristics: I2S-bus interface pins [1][3]":		
		a. updated VDDCORE = 1.13 V; CL = 10 pF		
		b. Removed footnote "Typical ratings are not guaranteed".		
		c. Updated t_{WH} and t_{WL} minimum and maximum unit.		
		• Added Section 14.7 "Main/System and Audio PLLs".		
		• Added MCLK pin values in Section 14.6 "External Clock Input (CLKIN pin, MCLK pin)".		
		• Updated footnote [3] clock frequency from 48 MHz to 140 MHz in Table 41 "Dynamic characteristics: I2S-bus interface pins [1][3]".		
RT600 v.1.9	20211230	Product Data Sheet	-	1.8
		• Removed RT633 device from Table 2 "Ordering options 4".		

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Table 57.   Revision history *…continued*

Document ID	Release date	Data sheet status	Change notice	Supersedes
RT600 v.1.8	20211209	Product data sheet	-	1.7

- Updated SWCLK resistor for PIO2_25 and description for PIO0_29 (Function 1) in Table 4 "Pin description".
- Updated Section 14.12 "High Speed SPI Interface (Flexcomm Interface 14)".
- Updated footnote [3] in Section 13.1 "General operating conditions".
- Added Fail Safe Pad and High Speed Pad details in Table 5 "Power Supply for pins"
- Removed below footnotes from Section 14.8 "I2C-bus":
  a. The maximum fall time for the SDA output stage tf is specified at 250 ns. This allows series protection resistors to be connected in between the SDA and the SCL pins and the SDA/SCL bus lines without exceeding the maximum specified tf.
  b. C_b = total capacitance of one bus line in pF. If mixed with Hs-mode devices, faster fall times are allowed.
  c. In Fast-mode Plus, fall time is specified the same for both output stage and bus timing. If series resistors are used, designers should allow for this when considering bus timing.
- Removed field MIMXRT633SFVKB and MIMXRT633SFAWBR from Section 4 "Ordering information".
- Updated Section 9 "Termination of unused pins" and Section 16.4 "RTC oscillator".
- Section 10.20.1 "12-bit Analog-to-Digital Converter (ADC)" updated to read ADC runs up to 1Msamples/s.
- ADC functional description updated in Section 10.20.1.1 "Features".
- Added minimum reset pulse width 4ns inTable 4 "Pin description".
- Updated I2C Bus fall time details in Section 13.5 "Pin characteristics".
- VDDCORE voltage is set to 0.7 note added in Table 28 "Static characteristics: Power consumption in deep-sleep mode[4]".
- Added PLL lock time is approximately 150 us in Section 10.13.2 "System PLL (PLL0)".
- Added only FBB must be used for active mode and only RBB must be used for deep sleep mode in Section 10.14 "Power control".
- In Figure 30 "Current measurements for memory partition", Y-axis changed from VDD1V8 Current (mA) to VDDCORE Current (mA) and also, added that internal LDO is disabled in the second bullet.
- Added Section 16.7 "Boundary Scan Mode" and Section 16.8 "VDDA_BIAS Power Supply Connection".
- Replaced "VDD_BIAS must be connected to the highest VDDIO rail voltage used for the ADC input channel or comparator inputs" to "VDD_BIAS must be equal to max ADC input voltage or max comparator input voltage" in Table 4 "Pin description", Table 18 "Limiting values". Table 20 "General operating conditions", and Table 21 "General operating conditions".
- In Section 7 "Pinning information" updated all GPIO pins are fail safe up to 3.6V when VDDIO supply is 0V except pins PIO1_18 (instead of PIO1_19) to PIO1_31.
- Added practical range of crystal frequencies for PLL usage is 5 MHz to 26 MHz in Section 10.13.1.4 "Crystal oscillator".

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Table 57.   Revision history *…continued*

Document ID	Release date	Data sheet status	Change notice	Supersedes
		• Voltage level changed from VDDA_ADC1V8 to VDDA_ADC1V8 in Section 10.20.1.1 "Features". • VDDA_1V8 symbol replaced with VDDA_ADC1V8 in Table 20 "General operating conditions", Table 21 "General operating conditions", and Table 52 "12-bit ADC static characteristics". • Updated footnote to read "For SDK version 2.8 and before (SDK Power Library version = 0x020200): The maximum frequency for the specified VDDCORE voltage is the frequency of the main clock. This is before the CPU CLOCK Divider. The VDDCORE voltage has to be set according to the chosen main clock frequency. For SDK version 2.8.3 and after (SDK Power Library version = 0x02030): The maximum frequency for the specified VDDCORE voltage is the frequency of the clock after CPU CLOCK and DSP clock Divider. The VDDCORE voltage has to be set according to the chosen M33 CPU and DSP CPU clock frequency." in Table 20 "General operating conditions", Table 21 "General operating conditions", Table 23 "CoreMark score", Table 24 "Static characteristics: Power consumption in active mode", Table 25 "Static characteristics: Power consumption in active mode", and Table 26 "Static characteristics: Power consumption in active mode". • Symbol IVDDA_1V8 replaced with IVDDA_ADC1V8 in Table 28 "Static characteristics: Power consumption in deep-sleep mode[4]" and Table 29 "Static characteristics: Power consumption in deep power-down mode and full deep power-down modes". • I2C Fall time in Table 30 "Static characteristics: pin characteristics" updated to read Fall Time, and also removed Standard mode/ Fast mode from fall time parameter column. • Value of VDDIO_x changed from 1.89 V to 3.6 V in Table 41 "Dynamic characteristics: I^{2}S-bus interface pins [1][3]", Table 42 "USART dynamic characteristics[1]", Table 43 "SPI dynamic characteristics[1]", Table 44 "High -Speed SPI dynamic characteristics[1]", and Table 50 "Dynamic characteristics[1]".		
RT600 v.1.7	20210120	Product data sheet	02101004I	1.6
Modifications:	• Updated Table 20 "General operating conditions".			
RT600 v.1.6	20201217	Product data sheet	-	1.5
Modifications:	• Section 13.2 "Power Sequencing" was updated.			
RT600 v.1.5	20201015	Product data sheet	-	1.4
Modifications:	• Updated Table 20 "General operating conditions" and Table 21 "General operating conditions" to align with SDK version 2.8.3 and after (SDK Power Library version = 0x020300).			
RT600 v.1.4	20200821	Product data sheet	-	1.3
Modifications:	• Updated Section 14.13 "FlexSPI flash interface".			
RT600 v.1.3	20200710	Product data sheet	-	1.2
Modifications:	Various improvements including updated clock generation diagrams, updated Section 16.4 "RTC oscillator" and Section 16.5 "XTAL oscillator". • Extended temperature to +85 • Updated IRC (48 MHz/60 MHz and 16 MHz) spec • Updated General operating conditions section • Updated FlexSPI flash interface specification table			
RT600 v.1.2	20200511	Product data sheet	-	1.1

Table 57. Revision history *…continued*

Document ID	Release date	Data sheet status	Change notice	Supersedes
Modifications:	Various improvements including updated Table 4 "Pin description", added plot and equation information for Section 15.2 "Temperature sensor", and added Section 16.1 "Current consumption vs Memory Partitions".			
RT600 v.1.1	20200511	Product data sheet	-	1.0
Modifications:	Updated minor fixes.			
RT600 v.1.0	20200224	Product data sheet	-	-
Modifications:	Total update for product release			

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